







DRV8316-Q1 JAJSN64 - JANUARY 2022

# DRV8316-Q13相 FET 内蔵モーター・ドライバ

# 1 特長

- 車載アプリケーション向けの AEC-Q100 認証取得済 み
  - 温度グレード 1:-40°C ≤ TA ≤ 125°C
- 3相 BLDC モーター・ドライバ
- 動作電圧:4.5V~35V (絶対最大定格 40V)
- 高い出力電流能力:ピーク8A
- ・ 低い MOSFET ON 抵抗
  - $T_A = 25$ °C  $\stackrel{\circ}{\sim}$  95mΩ  $\bigcirc$   $R_{DS(ON)}$  (HS + LS)
- 低消費電力スリープ・モード
  - V<sub>VM</sub> = 24V ∖ T<sub>A</sub> = 25°C ో 1.5µA
- 複数の制御インターフェイス・オプション
  - 6x PWM 制御インターフェイス
  - 3x PWM 制御インターフェイス
- 低インダクタンスのモーターをサポートするため、最大 **200kHz**の PWM 周波数に対応
- サイクル単位の電流制限
- 統合型の電流センス機能を内蔵 – 外付け電流センス抵抗不要
- ハードウェアまたは 5MHz の 16 ビット SPI インターフ エイス
- 1.8V、3.3V、5V のロジック入力電圧に対応
- 3.3V (5%)、30mAのLDOレギュレータを内蔵
- 3.3V/5V、200mAの降圧レギュレータを内蔵
- 遅延補償によりデューティ・サイクルの歪みを低減
- 一連の内蔵保護機能
  - 電源低電圧誤動作防止 (UVLO)
  - チャージ・ポンプ低電圧 (CPUV)
  - 過電流保護 (OCP)
  - 熱警告およびシャットダウン (OTW/OTSD)
  - フォルト状況表示ピン (nFAULT)
  - SPI インターフェイスによるフォルト診断 (任意)

# 2 アプリケーション

- ブラシレス DC (BLDC) モーター・モジュール
- 車載用 LIDAR
- 小型の車載用ファンおよびポンプ
- 車載用アクチュエータ

# 3 概要

DRV8316-Q1 は、12V ブラシレス DC モーターを最大 40W で駆動するシングル・チップ出力段ソリューションで す。DRV8316-Q1 は、40V の絶対最大定格能力および 95mΩ (下限側と上限側)の非常に小さい RDS (ON) を 備えた3 つの1/2-H ブリッジを内蔵し、大電力の駆動能 力を実現しています。電流は、外付けセンス抵抗を使わな い内蔵電流検出機能を使って測定します。可変降圧レギ ュレータおよび LDO の電源管理機能は、デバイスに必要 な電圧レールを生成します。また、外部回路に電力を供 給するためにも使用できます。

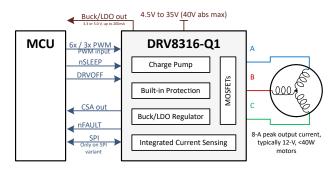
DRV8316-Q1 には 6x または 3x の PWM 制御方式が実 装されており、センサ付きまたはセンサレスのフィールド・ オリエンテッド制御 (FOC)、正弦波制御、または外付けマ イコンを使用した台形制御を実現できます。DRV8316-Q1 は最大 200kHz の PWM 周波数を駆動できます。制 御方式は、モーター電流制限動作からフォルト応答まで、 ハードウェア・ピンまたはレジスタ設定を使って詳細に設定 できます。

DRV8316-Q1 は、本デバイス自身、モーター、システムを フォルト・イベントから保護するための多くの保護機能を内 蔵しています。

#### デバイス情報<sup>(1)</sup>

| 部品番号                       | パッケージ     | 本体サイズ (公称)      |
|----------------------------|-----------|-----------------|
| DRV8316R-Q1                | VQFN (40) | 7.00mm × 5.00mm |
| DRV8316T-Q1 <sup>(2)</sup> | VQFN (40) | 7.00mm × 5.00mm |

- 利用可能なパッケージについては、このデータシートの末尾にあ (1) る注文情報を参照してください。
- (2)このデバイスはプレビュー版としてのみ供給されます。



# 概略回路図



英語版のTI製品についての情報を翻訳したこの資料は、製品の概要を確認する目的で便宜的に提供しているものです。該当する正式な英語版の最新情報は、 🐼 www.ti.com で閲覧でき、その内容が常に優先されます。 TI では翻訳の正確性および妥当性につきましては一切保証いたしません。 実際の設計などの前には、必ず 最新版の英語版をご参照くださいますようお願いいたします。



# **Table of Contents**

| 1 | 特長1                                   |    |
|---|---------------------------------------|----|
|   | アプリケーション1                             |    |
| 3 | 概要1                                   |    |
|   | Revision History                      |    |
|   | Device Comparison Table               |    |
|   | Pin Configuration and Functions4      |    |
| 7 | Specifications6                       | ;  |
|   | 7.1 Absolute Maximum Ratings6         | ;  |
|   | 7.2 ESD Ratings AUTO                  | ;  |
|   | 7.3 Recommended Operating Conditions6 | ;  |
|   | 7.4 Thermal Information7              |    |
|   | 7.5 Electrical Characteristics7       |    |
|   | 7.6 SPI Timing Requirements14         | ł. |
|   | 7.7 SPI Slave Mode Timings15          | 5  |
|   | 7.8 Typical Characteristics           | ;  |
| 8 | Detailed Description16                | ;  |
|   | 8.1 Overview                          | ;  |
|   | 8.2 Functional Block Diagram17        | ·  |
|   | 8.3 Feature Description               | )  |

| 8.4 Device Functional Modes             | 53 |
|-----------------------------------------|----|
| 8.5 SPI Communication                   | 54 |
| 8.6 Register Map                        | 56 |
| 9 Application and Implementation        |    |
| 9.1 Application Information             |    |
| 9.2 Typical Applications                |    |
| 10 Power Supply Recommendations         |    |
| 10.1 Bulk Capacitance                   |    |
| 11 Layout                               |    |
| 11.1 Layout Guidelines                  |    |
| 11.2 Layout Example                     |    |
| 11.3 Thermal Considerations             |    |
| 12 Device and Documentation Support     |    |
| 12.1 サポート・リソース                          |    |
| 12.2 Trademarks                         |    |
| 12.3 Electrostatic Discharge Caution    |    |
| 12.4 Glossary                           |    |
| 13 Mechanical, Packaging, and Orderable |    |
| Information                             | 85 |
|                                         |    |

# **4 Revision History**

資料番号末尾の英字は改訂を表しています。その改訂履 歴は英語版に準じています。

| DATE         | REVISION | NOTES           |
|--------------|----------|-----------------|
| January 2022 | *        | Initial Release |



# **5 Device Comparison Table**

| DEVICE                         | PACKAGES    | INTERFACE | BUCK<br>REGULATOR |
|--------------------------------|-------------|-----------|-------------------|
| DRV8316R-Q1                    | 40-pin VQFN | SPI       | Yes               |
| DRV8316T-<br>Q1 <sup>(1)</sup> | (7x5 mm)    | Hardware  |                   |

(1) Device available for preview only.



# **6** Pin Configuration and Functions

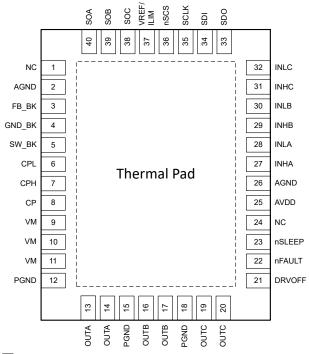


図 6-1. DRV8316R-Q1 40-Pin VQFN With Exposed Thermal Pad Top View

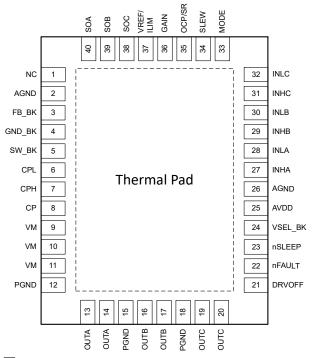


図 6-2. DRV8316T-Q1 40-Pin VQFN With Exposed Thermal Pad Top View

| PIN    | 40-pin F    | Package     | TYPE <sup>(1)</sup> | DESCRIPTION                                                                                                                                                                   |  |
|--------|-------------|-------------|---------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--|
| NAME   | DRV8316R-Q1 | DRV8316T-Q1 |                     | DESCRIPTION                                                                                                                                                                   |  |
| AGND   | 2, 26       | 2, 26       | GND                 | Device analog ground. Refer Layout Guidelines for connections recommendation.                                                                                                 |  |
| AVDD   | 25          | 25          | PWR O               | 3.3-V internal regulator output. Connect an X5R or X7R, 1- $\mu$ F, 6.3-V ceramic capacitor between the AVDD and AGND pins. This regulator can source up to 30 mA externally. |  |
| СР     | 8           | 8           | PWR O               | Charge pump output. Connect a X5R or X7R, 1- $\mu$ F, 16-V ceramic capacitor between the CP and VM pins.                                                                      |  |
| CPH    | 7           | 7           | PWR                 | Charge pump switching node. Connect a X5R or X7R, 47-nF, ceramic                                                                                                              |  |
| CPL    | 6           | 6           | PWR                 | capacitor between the CPH and CPL pins. TI recommends a capacitor voltage rating at least twice the normal operating voltage of the device.                                   |  |
| DRVOFF | 21          | 21          | I                   | When this pin is pulled high the six MOSFETs in the power stage are turned OFF making all outputs Hi-Z.                                                                       |  |
| FB_BK  | 3           | 3           | PWR I               | Feedback for buck regulator. Connect to buck regulator output after the inductor/resistor.                                                                                    |  |
| GAIN   |             | 36          | I                   | Amplifier gain setting. The pin is a 4 level input pin set by an external resistor.                                                                                           |  |
| GND_BK | 4           | 4           | GND                 | Buck regulator ground. Refer Layout Guidelines for connections recommendation.                                                                                                |  |
| INHA   | 27          | 27          | I                   | High-side driver control input for OUTA. This pin controls the output of the high-side MOSFET.                                                                                |  |
| INHB   | 29          | 29          | I                   | High-side driver control input for OUTB. This pin controls the output of the high-side MOSFET.                                                                                |  |
| INHC   | 31          | 31          | I                   | High-side driver control input for OUTC. This pin controls the output of the high-side MOSFET.                                                                                |  |
| INLA   | 28          | 28          | I                   | Low-side driver control input for OUTA. This pin controls the output of the low-side MOSFET.                                                                                  |  |

表 6-1. Pin Functions



# 表 6-1. Pin Functions (continued)

| PIN            | 40-pin F    | Package     |                     |                                                                                                                                                                                                                                                                                                  |  |
|----------------|-------------|-------------|---------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--|
| NAME           | DRV8316R-Q1 | DRV8316T-Q1 | TYPE <sup>(1)</sup> | DESCRIPTION                                                                                                                                                                                                                                                                                      |  |
| INLB           | 30          | 30          | 1                   | Low-side driver control input for OUTB. This pin controls the output of the low-<br>side MOSFET.                                                                                                                                                                                                 |  |
| INLC           | 32          | 32          | I                   | Low-side driver control input for OUTC. This pin controls the output of the low-side MOSFET.                                                                                                                                                                                                     |  |
| MODE           | _           | 33          | I                   | PWM input mode setting. This pin is a 2-level input pin set by an external resistor.                                                                                                                                                                                                             |  |
| NC             | 1, 24       | 1           | _                   | No connection, open                                                                                                                                                                                                                                                                              |  |
| nFAULT         | 22          | 22          | 0                   | Fault indicator. Pulled logic-low with fault condition; Open-drain output requires an external pull-up resistor to 1.8V to 5.0 V. If external supply is used to pull up nFAULT, ensure that it is pulled to >2.2 V on power up or the device will enter test mode                                |  |
| nSCS           | 36          | _           | I                   | Serial chip select. A logic low on this pin enables serial interface communication.                                                                                                                                                                                                              |  |
| nSLEEP         | 23          | 23          | I                   | Driver nSLEEP. When this pin is logic low, the device goes into a low-power sleep mode. An 20 to 40-µs low pulse can be used to reset fault conditions without entering sleep mode.                                                                                                              |  |
| OCP            | _           | 35          | I                   | OCP level setting. This pin is a 2 level input pin set by an external resistor (Hardware devices).                                                                                                                                                                                               |  |
| OUTA           | 13, 14      | 13, 14      | PWR O               | Half bridge output A                                                                                                                                                                                                                                                                             |  |
| OUTB           | 16, 17      | 16, 17      | PWR O               | Half bridge output B                                                                                                                                                                                                                                                                             |  |
| OUTC           | 19, 20      | 19, 20      | PWR O               | Half bridge output C                                                                                                                                                                                                                                                                             |  |
| PGND           | 12, 15, 18  | 12, 15, 18  | GND                 | Device power ground. Refer Layout Guidelines for connections recommendation.                                                                                                                                                                                                                     |  |
| SCLK           | 35          | _           | I                   | Serial clock input. Serial data is shifted out and captured on the corresponding rising and falling edge on this pin (SPI devices).                                                                                                                                                              |  |
| SDI            | 34          | _           | I                   | Serial data input. Data is captured on the falling edge of the SCLK pin (SPI devices).                                                                                                                                                                                                           |  |
| SDO            | 33          | _           | 0                   | Serial data output. Data is shifted out on the rising edge of the SCLK pin. This pin requires an external pullup resistor (SPI devices).                                                                                                                                                         |  |
| SLEW           | _           | 34          | I                   | Slew rate control setting. This pin is a 4-level input pin set by an external resistor.                                                                                                                                                                                                          |  |
| SOA            | 40          | 40          | 0                   | Current sense amplifier output.                                                                                                                                                                                                                                                                  |  |
| SOB            | 39          | 39          | 0                   | Current sense amplifier output.                                                                                                                                                                                                                                                                  |  |
| SOC            | 38          | 38          | 0                   | Current sense amplifier output.                                                                                                                                                                                                                                                                  |  |
| SW_BK          | 5           | 5           | PWR O               | Buck switch node. Connect this pin to an inductor or resistor.                                                                                                                                                                                                                                   |  |
| VM             | 9, 10, 11   | 9, 10, 11   | PWR I               | Power supply. Connect to motor supply voltage; bypass to PGND with two 0.1- $\mu$ F capacitors (for each pin) plus one bulk capacitor rated for VM. TI recommends a capacitor voltage rating at least twice the normal operating voltage of the device.                                          |  |
| VSEL_BK        | _           | 24          | I                   | Buck output voltage setting. This pin is a 4-level input pin set by an external resistor.                                                                                                                                                                                                        |  |
| VREF/ILIM      | 37          | 37          | PWR/I               | VREF in PWM Mode 1 and Mode 3: Current sense amplifier power supply input and reference. Connect a X5R or X7R, 0.1- $\mu$ F, 6.3-V ceramic capacitor between the VREF and AGND pins.<br>ILIM in PWM Mode 2 and Mode4: Sets the threshold for phase current used in cycle by cycle current limit. |  |
| Thermal<br>pad |             |             | GND                 | Must be connected to analog ground.                                                                                                                                                                                                                                                              |  |

(1) I = input, O = output, GND = ground pin, PWR = power, NC = no connect

# 7 Specifications

# 7.1 Absolute Maximum Ratings

over operating ambient temperature range (unless otherwise noted)<sup>(1)</sup>

|                                                                       | MIN  | MAX                  | UNIT |
|-----------------------------------------------------------------------|------|----------------------|------|
| Power supply pin voltage (VM)                                         | -0.3 | 40                   | V    |
| Power supply voltage ramp (VM)                                        |      | 4                    | V/µs |
| Voltage difference between ground pins (GND_BK, PGND, AGND)           | -0.3 | 0.3                  | V    |
| Charge pump voltage (CPH, CP)                                         | -0.3 | V <sub>M</sub> + 6   | V    |
| Charge pump negative switching pin voltage (CPL)                      | -0.3 | V <sub>M</sub> + 0.3 | V    |
| Switching regulator pin voltage (FB_BK)                               | -0.3 | 5.75                 | V    |
| Switching node pin voltage (SW_BK)                                    | -0.3 | V <sub>M</sub> + 0.3 | V    |
| Analog regulators pin voltage (AVDD)                                  | -0.3 | 4                    | V    |
| Logic pin input voltage (DRVOFF, INHx, INLx, nSCS, nSLEEP, SCLK, SDI) | -0.3 | 5.75                 | V    |
| Logic pin output voltage (nFAULT, SDO)                                | -0.3 | 5.75                 | V    |
| Output pin voltage (OUTA, OUTB, OUTC)                                 | -1   | V <sub>M</sub> + 1   | V    |
| Ambient temperature, T <sub>A</sub>                                   | -40  | 125                  | °C   |
| Junction temperature, T <sub>J</sub>                                  | -40  | 150                  | °C   |
| Storage tempertaure, T <sub>stg</sub>                                 | -65  | 150                  | °C   |

(1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

# 7.2 ESD Ratings AUTO

|                    |               |                                                                                           |             | VALUE | UNIT |
|--------------------|---------------|-------------------------------------------------------------------------------------------|-------------|-------|------|
|                    | Electrostatic | Human body model (HBM), per AEC Q100-002 <sup>(1)</sup><br>HBM ESD Classification Level 2 |             | ±2000 |      |
| V <sub>(ESD)</sub> | discharge     | Charged device model (CDM), per AEC Q100-011                                              | Corner pins | ±750  | V    |
|                    |               | CDM ESD Classification Level C4B                                                          | Other pins  | ±750  |      |

(1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

# 7.3 Recommended Operating Conditions

over operating ambient temperature range (unless otherwise noted)

|                                 |                                |                                                | MIN  | NOM | MAX  | UNIT |
|---------------------------------|--------------------------------|------------------------------------------------|------|-----|------|------|
| V <sub>VM</sub>                 | Power supply voltage           | V <sub>VM</sub>                                | 4.5  | 24  | 35   | V    |
| f <sub>PWM</sub>                | Output PWM frequency           | OUTA, OUTB, OUTC                               |      |     | 200  | kHz  |
| I <sub>OUT</sub> <sup>(1)</sup> | Peak output winding current    | OUTA, OUTB, OUTC                               |      |     | 8    | А    |
| V <sub>IN</sub>                 | Logic input voltage            | DRVOFF, INHx, INLx, nSCS, nSLEEP,<br>SCLK, SDI | -0.1 |     | 5.5  | V    |
| V <sub>OD</sub>                 | Open drain pullup voltage      | nFAULT, SDO                                    | -0.1 |     | 5.5  | V    |
| V <sub>SDO</sub>                | Push-pull voltage              | SDO                                            | 2.2  |     | 5.5  | V    |
| I <sub>OD</sub>                 | Open drain output current      | nFAULT, SDO                                    |      |     | 5    | mA   |
| V <sub>VREF</sub>               | Voltage reference pin voltage  | VREF                                           | 2.8  |     | AVDD | V    |
| T <sub>A</sub>                  | Operating ambient temperature  |                                                | -40  |     | 125  | °C   |
| TJ                              | Operating Junction temperature |                                                | -40  |     | 150  | °C   |

(1) Power dissipation and thermal limits must be observed



# 7.4 Thermal Information

|                       |                                              | DRV8316T-Q1,<br>DRV8316R-Q1 |      |
|-----------------------|----------------------------------------------|-----------------------------|------|
|                       | THERMAL METRIC <sup>(1)</sup>                | VQFN (RGF)                  | UNIT |
|                       |                                              | 40 Pins                     |      |
| R <sub>0JA</sub>      | Junction-to-ambient thermal resistance       | 25.7                        | °C/W |
| R <sub>0JC(top)</sub> | Junction-to-case (top) thermal resistance    | 15.2                        | °C/W |
| R <sub>θJB</sub>      | Junction-to-board thermal resistance         | 7.3                         | °C/W |
| $\Psi_{JT}$           | Junction-to-top characterization parameter   | 0.2                         | °C/W |
| $\Psi_{JB}$           | Junction-to-board characterization parameter | 7.2                         | °C/W |
| R <sub>0JC(bot)</sub> | Junction-to-case (bottom) thermal resistance | 2.0                         | °C/W |

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

# 7.5 Electrical Characteristics

 $T_J = -40^{\circ}C$  to +150°C,  $V_{VM} = 4.5$  to 35 V (unless otherwise noted). Typical limits apply for  $T_A = 25^{\circ}C$ ,  $V_{VM} = 24$  V

|                   | PARAMETER                                              | TEST CONDITIONS                                                                                                            | MIN | TYP | MAX   | UNIT |
|-------------------|--------------------------------------------------------|----------------------------------------------------------------------------------------------------------------------------|-----|-----|-------|------|
| POWER             | SUPPLIES                                               |                                                                                                                            |     |     |       |      |
|                   | VM sleep mode current                                  | V <sub>VM</sub> > 6 V, nSLEEP = 0, T <sub>A</sub> = 25 °C                                                                  |     | 1.5 | 2.5   | μA   |
| I <sub>VMQ</sub>  | VM sleep mode current                                  | nSLEEP = 0                                                                                                                 |     | 2.5 | 5     | μA   |
|                   | VM standby made surrant                                | nSLEEP = 1, INHx = INLx = 0, SPI =<br>'OFF', BUCK_DIS = 1;                                                                 |     | 4   | 10    | mA   |
| I <sub>VMS</sub>  | VM standby mode current<br>(Buck regulator disabled)   | V <sub>VM</sub> > 6 V, nSLEEP = 1, INHx = INLx =<br>0, SPI = 'OFF', T <sub>A</sub> = 25 °C, BUCK_DIS =<br>1;               |     | 4   | 5     | mA   |
| I <sub>VMS</sub>  | VM standby mode current                                | $V_{VM}$ > 6 V, nSLEEP = 1, INHx = INLx =<br>0, SPI = 'OFF', I <sub>BK</sub> = 0, T <sub>A</sub> = 25<br>°C, BUCK_DIS = 0; |     | 5   | 6     | mA   |
| VIIIC             | (Buck regulator enabled)                               | nSLEEP = 1, INHx = INLx = 0, SPI =<br>'OFF', I <sub>BK</sub> = 0, BUCK_DIS = 0;                                            |     | 6   | 10    | mA   |
|                   | VM operating mode current<br>(Buck regulator disabled) | $V_{VM}$ > 6 V, nSLEEP = 1, f <sub>PWM</sub> = 25 kHz,<br>T <sub>A</sub> = 25 °C, BUCK_DIS = 1                             |     | 10  | 13    | mA   |
|                   |                                                        | $V_{VM}$ > 6 V, nSLEEP = 1, f <sub>PWM</sub> = 200 kHz,<br>T <sub>A</sub> = 25 °C, BUCK_DIS = 1                            |     | 18  | 21    | mA   |
| I <sub>VM</sub>   |                                                        | nSLEEP =1, f <sub>PWM</sub> = 25 kHz, BUCK_DIS<br>= 1                                                                      |     | 11  | 16    | mA   |
|                   |                                                        | nSLEEP =1, f <sub>PWM</sub> = 200 kHz,<br>BUCK_DIS = 1                                                                     |     | 17  | 25    | mA   |
|                   |                                                        | V <sub>VM</sub> > 6 V, nSLEEP = 1, f <sub>PWM</sub> = 25 kHz,<br>T <sub>A</sub> = 25 °C, BUCK_DIS =<br>0; BUCK_PS_DIS = 0  |     | 11  | 13    | mA   |
| I <sub>VM</sub>   | VM operating mode current<br>(Buck regulator enabled)  | V <sub>VM</sub> > 6 V, nSLEEP = 1, f <sub>PWM</sub> = 200 kHz,<br>T <sub>A</sub> = 25 °C, BUCK_DIS =<br>0; BUCK_PS_DIS = 0 |     | 19  | 22    | mA   |
|                   |                                                        | nSLEEP =1, f <sub>PWM</sub> = 25 kHz, BUCK_DIS<br>= 0; BUCK_PS_DIS = 0                                                     |     | 12  | 17    | mA   |
|                   |                                                        | nSLEEP =1, f <sub>PWM</sub> = 200 kHz,<br>BUCK_DIS = 0; BUCK_PS_DIS = 0                                                    |     | 18  | 27    | mA   |
| V <sub>AVDD</sub> | Analog regulator voltage                               | $0 \text{ mA} \le I_{\text{AVDD}} \le 30 \text{ mA}; \text{BUCK}_{PS} \text{DIS} = 0$                                      | 3.1 | 3.3 | 3.465 | V    |
| I <sub>AVDD</sub> | External analog regulator load                         |                                                                                                                            |     |     | 30    | mA   |
| V <sub>VCP</sub>  | Charge pump regulator voltage                          | VCP with respect to VM                                                                                                     | 3.6 | 4.7 | 5.25  | V    |
| f <sub>CP</sub>   | Charge pump switching frequency                        |                                                                                                                            |     | 400 |       | kHz  |

Copyright © 2022 Texas Instruments Incorporated

DRV8316-Q1 JAJSN64 – JANUARY 2022



|                   | PARAMETER                                                                                   | TEST CONDITIONS                                                                                                                                                                   | MIN             | TYP                                                                         | MAX | UNI |
|-------------------|---------------------------------------------------------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------------|-----------------------------------------------------------------------------|-----|-----|
| t <sub>WAKE</sub> | Wakeup time                                                                                 | $V_{VM} > V_{UVLO}$ , nSLEEP = 1 to outputs ready and nFAULT released                                                                                                             |                 |                                                                             | 1   | ms  |
| SLEEP             | Sleep Pulse time                                                                            | nSLEEP = 0 period to enter sleep mode                                                                                                                                             | 120             |                                                                             |     | μs  |
| RST               | Reset Pulse time                                                                            | nSLEEP = 0 period to reset faults                                                                                                                                                 | 20              |                                                                             | 40  | μs  |
| BUCK RE           | EGULATOR                                                                                    |                                                                                                                                                                                   |                 |                                                                             |     |     |
|                   |                                                                                             | $V_{VM} > 6 V$ , 0 mA $\le I_{BK} \le 200$ mA,<br>BUCK_SEL = 00b                                                                                                                  | 3.1             | 3.3                                                                         | 3.5 | V   |
|                   |                                                                                             | $V_{VM} > 6 V, 0 mA \le I_{BK} \le 200 mA,$<br>BUCK_SEL = 01b                                                                                                                     | 4.6             | 5.0                                                                         | 5.4 | V   |
| V <sub>BK</sub>   | Buck regulator average voltage ( $L_{BK}$ = 47 µH, $C_{BK}$ = 22 µF)                        | $V_{VM} > 6 V, 0 mA \le I_{BK} \le 200 mA,$<br>BUCK_SEL = 10b                                                                                                                     | 3.7             | 4.0                                                                         | 4.3 | V   |
|                   | (SPI Device)                                                                                | $V_{VM}$ > 6.7 V, 0 mA ≤ $I_{BK}$ ≤ 200 mA,<br>BUCK_SEL = 11b                                                                                                                     | 5.2             | 5.7                                                                         | 6.2 | V   |
|                   |                                                                                             | $V_{VM}$ < 6.0 V (BUCK_SEL = 00b, 01b,<br>10b) or $V_{VM}$ < 6.0 V (BUCK_SEL = 11b),<br>0 mA ≤ I <sub>BK</sub> ≤ 200 mA                                                           | ۱ <sub>В</sub>  | V <sub>VM</sub> –<br><sub>K</sub> *(R <sub>LBK</sub> +<br>2) <sup>(1)</sup> |     | V   |
|                   | Buck regulator average voltage (L <sub>BK</sub> = 22 $\mu$ H, C <sub>BK</sub> = 22 $\mu$ F) | $V_{VM} > 6 V, 0 mA \le I_{BK} \le 50 mA,$<br>BUCK_SEL = 00b                                                                                                                      | 3.1             | 3.3                                                                         | 3.5 | V   |
|                   |                                                                                             | $V_{VM} > 6 V, 0 \text{ mA} \le I_{BK} \le 50 \text{ mA},$<br>BUCK_SEL = 01b                                                                                                      | 4.6             | 5.0                                                                         | 5.4 | V   |
| V <sub>BK</sub>   |                                                                                             | $V_{VM}$ > 6 V, 0 mA ≤ $I_{BK}$ ≤ 50 mA,<br>BUCK_SEL = 10b                                                                                                                        | 3.7             | 4.0                                                                         | 4.3 | V   |
|                   | (SPI Device)                                                                                | $V_{VM}$ > 6.7 V, 0 mA $\leq$ I <sub>BK</sub> $\leq$ 50 mA, BUCK_SEL = 11b                                                                                                        | 5.2             | 5.7                                                                         | 6.2 | V   |
|                   |                                                                                             | $\label{eq:VVM} \begin{array}{l} V_{VM} < 6.0 \ V \ (BUCK\_SEL = 00b, \ 01b, \\ 10b) \ or \ V_{VM} < 6.0 \ V \ (BUCK\_SEL = 11b), \\ 0 \ mA \leq I_{BK} \leq 50 \ mA \end{array}$ | ۱ <sub>В</sub>  | V <sub>VM</sub> –<br><sub>K</sub> *(R <sub>LBK</sub> +<br>2) <sup>(1)</sup> |     | V   |
|                   | Buck regulator average voltage<br>( $R_{BK} = 22 \Omega, C_{BK} = 22 \mu F$ )               | $V_{VM} > 6 V, 0 mA \le I_{BK} \le 40 mA,$<br>BUCK_SEL = 00b                                                                                                                      | 3.1             | 3.3                                                                         | 3.5 | V   |
|                   |                                                                                             | $V_{VM} > 6 V, 0 \text{ mA} \le I_{BK} \le 40 \text{ mA},$<br>BUCK_SEL = 01b                                                                                                      | 4.6             | 5.0                                                                         | 5.4 | V   |
| V <sub>BK</sub>   |                                                                                             | $V_{VM}$ > 6 V, 0 mA ≤ $I_{BK}$ ≤ 40 mA,<br>BUCK_SEL = 10b                                                                                                                        | 3.7             | 4.0                                                                         | 4.3 | V   |
|                   | (SPI Device)                                                                                | $V_{VM}$ > 6.7 V, 0 mA $\leq$ I <sub>BK</sub> $\leq$ 40 mA, BUCK_SEL = 11b                                                                                                        | 5.2             | 5.7                                                                         | 6.2 | V   |
|                   |                                                                                             | $\label{eq:VVM} \begin{array}{l} V_{VM} < 6.0 \ V \ (BUCK\_SEL = 00b, \ 01b, \\ 10b) \ or \ V_{VM} < 6.0 \ V \ (BUCK\_SEL = 11b), \\ 0 \ mA \le I_{BK} \le 40 \ mA \end{array}$   | I <sub>Bł</sub> | V <sub>VM</sub> –<br>(*(R <sub>BK</sub> +2<br>)                             |     | V   |
|                   |                                                                                             | $V_{VM} > 6 V, 0 mA \le I_{BK} \le 200 mA, VSEL_BK pin tied to AGND$                                                                                                              | 3.1             | 3.3                                                                         | 3.5 | V   |
|                   |                                                                                             | $V_{VM} > 6 V, 0 \text{ mA} \le I_{BK} \le 200 \text{ mA}, VSEL_BK pin to Hi-Z$                                                                                                   | 4.6             | 5.0                                                                         | 5.4 |     |
| V <sub>BK</sub>   | Buck regulator average voltage<br>( $L_{BK}$ = 47 µH, $C_{BK}$ = 22 µF)<br>(HW Device)      | $V_{VM}$ > 6 V, 0 mA ≤ $I_{BK}$ ≤ 200 mA, VSEL_BK pin to 47 kΩ +/- 5% tied to AVDD                                                                                                | 3.7             | 4.0                                                                         | 4.3 |     |
|                   | (                                                                                           | $V_{VM}$ > 6.7 V, 0 mA ≤ $I_{BK}$ ≤ 200 mA,<br>VSEL_BK pin tied to AVDD                                                                                                           | 5.2             | 5.7                                                                         | 6.2 |     |
|                   |                                                                                             | V <sub>VM</sub> < 6.0 V, 0 mA ≤ I <sub>BK</sub> ≤ 200 mA                                                                                                                          | I <sub>B</sub>  | V <sub>VM</sub> –<br><sub>K</sub> *(R <sub>LBK</sub> +<br>2) <sup>(1)</sup> |     | V   |



|                                                                                                     | $V_{VM} > 6 V, 0 mA \le I_{BK} \le 50 mA,$                                                                                                                              |      |                                                                                |                            |                                                        |
|-----------------------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|--------------------------------------------------------------------------------|----------------------------|--------------------------------------------------------|
|                                                                                                     | VSEL_BK pin tied to AGND                                                                                                                                                | 3.1  | 3.3                                                                            | 3.5                        | V                                                      |
|                                                                                                     | $V_{VM} > 6 V, 0 mA \le I_{BK} \le 50$<br>mA, VSEL_BK pin to Hi-Z                                                                                                       | 4.6  | 5.0                                                                            | 5.4                        | V                                                      |
| Buck regulator average voltage<br>(L <sub>BK</sub> = 22 μH, C <sub>BK</sub> = 22 μF)<br>(HW Device) | $V_{VM} > 6 V, 0 \text{ mA} \le I_{BK} \le 50$<br>mA, VSEL_BK pin to 47 k $\Omega$ +/- 5% tied to AVDD                                                                  | 3.7  | 4.0                                                                            | 4.3                        | V                                                      |
| (                                                                                                   | $V_{VM}$ > 6.7 V, 0 mA ≤ $I_{BK}$ ≤ 50 mA, VSEL_BK pin tied to AVDD                                                                                                     | 5.2  | 5.7                                                                            | 6.2                        | V                                                      |
|                                                                                                     | V <sub>VM</sub> < 6.0 V, 0 mA ≤ I <sub>BK</sub> ≤ 50 mA                                                                                                                 |      | V <sub>VM</sub> -<br>I <sub>BK</sub> *(R <sub>LBK</sub> +<br>2) <sup>(1)</sup> |                            | V                                                      |
|                                                                                                     | $V_{VM}$ > 6 V, 0 mA ≤ $I_{BK}$ ≤ 40 mA,<br>VSEL_BK pin tied to AGND                                                                                                    | 3.1  | 3.3                                                                            | 3.5                        | V                                                      |
|                                                                                                     | V <sub>VM</sub> > 6 V, 0 mA ≤ I <sub>BK</sub> ≤ 40<br>mA, VSEL_BK pin to Hi-Z                                                                                           | 4.6  | 5.0                                                                            | 5.4                        | V                                                      |
| Buck regulator average voltage<br>(R <sub>BK</sub> = 22 Ω, C <sub>BK</sub> = 22 μF)<br>(HW Device)  | $V_{VM}$ > 6 V, 0 mA ≤ $I_{BK}$ ≤ 40 mA, VSEL_BK pin to 47 k $\Omega$ +/- 5% tied to AVDD                                                                               | 3.7  | 4.0                                                                            | 4.3                        | V                                                      |
|                                                                                                     | $V_{VM}$ > 6.7 V, 0 mA ≤ $I_{BK}$ ≤ 40 mA, VSEL_BK pin tied to AVDD                                                                                                     | 5.2  | 5.7                                                                            | 6.2                        | V                                                      |
|                                                                                                     | V <sub>VM</sub> < 6.0 V, 0 mA ≤ I <sub>BK</sub> ≤ 40 mA                                                                                                                 |      | V <sub>VM</sub> –<br>I <sub>BK</sub> *(R <sub>BK</sub> +2<br>)                 |                            | V                                                      |
| Buck regulator ripple voltage                                                                       | $V_{VM}$ > 6 V, 0 mA ≤ $I_{BK}$ ≤ 200 mA, Buck<br>regulator with inductor, $L_{BK}$ = 47 uH, $C_{BK}$<br>= 22 µF                                                        | -100 |                                                                                | 100                        | mV                                                     |
|                                                                                                     | $V_{VM}$ > 6 V, 0 mA ≤ $I_{BK}$ ≤ 50 mA, Buck<br>regulator with inductor, $L_{BK}$ = 22 uH, $C_{BK}$<br>= 22 µF                                                         | -100 |                                                                                | 100                        | mV                                                     |
|                                                                                                     | $V_{VM}$ > 6 V, 0 mA ≤ $I_{BK}$ ≤ 50 mA, Buck<br>regulator with resistor; $R_{BK}$ = 22 $\Omega$ , $C_{BK}$<br>= 22 µF                                                  | -100 |                                                                                | 100                        | mV                                                     |
|                                                                                                     | L <sub>BK</sub> = 47 uH, C <sub>BK</sub> = 22 μF,<br>BUCK_PS_DIS = 1b                                                                                                   |      |                                                                                | 200                        | mA                                                     |
|                                                                                                     | L <sub>BK</sub> = 47 uH, C <sub>BK</sub> = 22 μF,<br>BUCK_PS_DIS = 0b                                                                                                   |      |                                                                                | 200 –<br>I <sub>AVDD</sub> | mA                                                     |
| External buck regulator load                                                                        | L <sub>BK</sub> = 22 uH, C <sub>BK</sub> =<br>22 μF, BUCK_PS_DIS = 1b                                                                                                   |      |                                                                                | 50                         | mA                                                     |
| External buck regulator load                                                                        | L <sub>BK</sub> = 22 uH, C <sub>BK</sub> = 22 μF,<br>BUCK_PS_DIS = 0b                                                                                                   |      |                                                                                | 50 –<br>I <sub>AVDD</sub>  | mA                                                     |
|                                                                                                     | R <sub>BK</sub> = 22 Ω, C <sub>BK</sub> =<br>22 μF, BUCK_PS_DIS = 1b                                                                                                    |      |                                                                                | 40                         | mA                                                     |
|                                                                                                     | R <sub>BK</sub> = 22 Ω, C <sub>BK</sub> = 22 μF,<br>BUCK_PS_DIS = 0b                                                                                                    |      |                                                                                | 40 –<br>I <sub>AVDD</sub>  | mA                                                     |
| Buck regulator switching frequency                                                                  | Regulation Mode                                                                                                                                                         | 20   |                                                                                | 535                        | kHz                                                    |
|                                                                                                     | (L <sub>BK</sub> = 22 μH, C <sub>BK</sub> = 22 μF)<br>(HW Device)<br>Buck regulator average voltage<br>(R <sub>BK</sub> = 22 Ω, C <sub>BK</sub> = 22 μF)<br>(HW Device) |      |                                                                                |                            | $ \begin{array}{  c                                  $ |



| T <sub>J</sub> = -40°C | to +150°C, $V_{VM}$ = 4.5 to 35 V (unless          | otherwise noted). Typical limits apply for                            | r T <sub>A</sub> = 25°C | , V <sub>VM</sub> = 24 | V    |      |
|------------------------|----------------------------------------------------|-----------------------------------------------------------------------|-------------------------|------------------------|------|------|
|                        | PARAMETER                                          | TEST CONDITIONS                                                       | MIN                     | TYP                    | MAX  | UNIT |
|                        |                                                    | V <sub>BK</sub> rising, BUCK_SEL = 00b                                | 2.7                     | 2.8                    | 2.9  | V    |
|                        |                                                    | V <sub>BK</sub> falling, BUCK_SEL = 00b                               | 2.5                     | 2.6                    | 2.7  | V    |
|                        |                                                    | V <sub>BK</sub> rising, BUCK_SEL = 01b                                | 4.2                     | 4.4                    | 4.55 | V    |
|                        | Buck regulator undervoltage lockout                | V <sub>BK</sub> falling, BUCK_SEL = 01b                               | 4.0                     | 4.2                    | 4.35 | V    |
| V <sub>BK_UV</sub>     | (SPI Device)                                       | V <sub>BK</sub> rising, BUCK_SEL = 10b                                | 2.7                     | 2.8                    | 2.9  | V    |
|                        |                                                    | V <sub>BK</sub> falling, BUCK SEL = 10b                               | 2.5                     | 2.6                    | 2.7  | V    |
|                        |                                                    | $V_{BK}$ rising, BUCK_SEL = 11b                                       | 4.2                     | 4.4                    | 4.55 | V    |
|                        |                                                    | $V_{BK}$ falling, BUCK_SEL = 11b                                      | 4                       | 4.2                    | 4.35 | V    |
|                        |                                                    | V <sub>BK</sub> rising, VSEL_BK pin tied to AGND                      | 2.7                     | 2.8                    | 2.9  | V    |
|                        |                                                    | $V_{BK}$ falling, VSEL_BK pin tied to AGND                            | 2.5                     | 2.6                    | 2.7  | v    |
|                        |                                                    | $V_{BK}$ rising, VSEL_BK pin to 47 k $\Omega$ +/- 5% tied to AVDD     | 4.3                     | 4.4                    | 4.5  | V    |
| V <sub>BK_UV</sub>     | Buck regulator undervoltage lockout<br>(HW Device) | $V_{BK}$ falling, VSEL_BK pin to 47 k $\Omega$ +/-<br>5% tied to AVDD | 4.1                     | 4.2                    | 4.3  | V    |
|                        |                                                    | V <sub>BK</sub> rising, VSEL_BK pin to Hi-Z                           | 2.7                     | 2.8                    | 2.9  | V    |
|                        |                                                    | $V_{BK}$ falling, VSEL_BK pin to Hi-Z                                 | 2.5                     | 2.6                    | 2.7  | v    |
|                        |                                                    | V <sub>BK</sub> rising, VSEL BK pin tied to AVDD                      | 4.2                     | 4.4                    | 4.55 | v    |
|                        |                                                    | V <sub>BK</sub> falling, VSEL_BK pin tied to AVDD                     | 4.0                     | 4.4                    | 4.35 | V    |
|                        | Puel regulator under altere leskout                | VBK failing, VSEL_BK pill fied to AVDD                                | 4.0                     | 4.2                    | 4.35 | v    |
| V <sub>BK_UV_HYS</sub> | Buck regulator undervoltage lockout hysteresis     | Rising to falling threshold                                           | 90                      | 200                    | 320  | mV   |
| I <sub>BK_CL</sub>     | Buck regulator Current limit threshold             | BUCK_CL = 0b                                                          | 360                     | 600                    | 900  | mA   |
| BI(_OL                 | (SPI Device)                                       | BUCK_CL = 1b                                                          | 80                      | 150                    | 250  | mA   |
| I <sub>BK_CL</sub>     | Buck regulator Current limit threshold (HW Device) |                                                                       | 360                     | 600                    | 900  | mA   |
| I <sub>BK_OCP</sub>    | Buck regulator Overcurrent protection trip point   |                                                                       | 2                       | 3                      | 4    | А    |
| t <sub>BK_RETRY</sub>  | Overcurrent protection retry time                  |                                                                       | 0.7                     | 1                      | 1.3  | ms   |
| LOGIC-LEV              | EL INPUTS (DRVOFF, INHx, INLx, nSLE                | EP, SCLK, SDI)                                                        |                         |                        |      |      |
| V <sub>IL</sub>        | Input logic low voltage                            |                                                                       | 0                       |                        | 0.6  | V    |
|                        | In section of a bit share the sec                  | Other Pins                                                            | 1.5                     |                        | 5.5  | V    |
| V <sub>IH</sub>        | Input logic high voltage                           | nSLEEP                                                                | 1.6                     |                        | 5.5  | V    |
|                        |                                                    | Other PIns                                                            | 180                     | 300                    | 420  | mV   |
| V <sub>HYS</sub>       | Input logic hysteresis                             | nSLEEP                                                                | 95                      | 250                    | 420  | mV   |
| IIL                    | Input logic low current                            | V <sub>PIN</sub> (Pin Voltage) = 0 V                                  | -1                      |                        | 1    | μA   |
|                        |                                                    | nSLEEP, V <sub>PIN</sub> (Pin Voltage) = 5 V                          | 10                      |                        | 30   | μΑ   |
| I <sub>IH</sub>        | Input logic high current                           | Other pins, V <sub>PIN</sub> (Pin Voltage) = 5 V                      | 30                      |                        | 75   | μA   |
|                        |                                                    | nSLEEP                                                                | 150                     | 200                    | 300  | kΩ   |
| R <sub>PD</sub>        | Input pulldown resistance                          | Other pins                                                            | 70                      | 100                    | 130  | kΩ   |
| C <sub>ID</sub>        | Input capacitance                                  |                                                                       |                         | 30                     |      | pF   |
| LOGIC-LEV              | 'EL INPUTS (nSCS)                                  |                                                                       |                         |                        |      |      |
| V <sub>IL</sub>        | Input logic low voltage                            |                                                                       | 0                       |                        | 0.6  | V    |
| V <sub>IH</sub>        | Input logic high voltage                           |                                                                       | 1.5                     |                        | 5.5  | V    |
| V <sub>HYS</sub>       | Input logic hysteresis                             |                                                                       | 180                     | 300                    | 420  | mV   |
| IIL                    | Input logic low current                            | V <sub>PIN</sub> (Pin Voltage) = 0 V                                  |                         |                        | 75   | μA   |
| IIH                    | Input logic high current                           | V <sub>PIN</sub> (Pin Voltage) = 5 V                                  | -1                      |                        | 25   | μΑ   |
|                        |                                                    |                                                                       |                         | 100                    |      | •    |
| R <sub>PU</sub>        | Input pullup resistance                            |                                                                       | 80                      | 100                    | 130  | kΩ   |



| 0                   | C to +150°C, V <sub>VM</sub> = 4.5 to 35 V (unless of<br>PARAMETER | TEST CONDITIONS                                                         |                | TYP            | MAX            | UNIT |
|---------------------|--------------------------------------------------------------------|-------------------------------------------------------------------------|----------------|----------------|----------------|------|
|                     | EL INPUTS (GAIN, MODE, SLEW, VSEL_E                                |                                                                         |                | 11F            | IVIAA          | UNIT |
|                     |                                                                    |                                                                         |                |                | 0.2*AVD        |      |
| V <sub>L1</sub>     | Input mode 1 voltage                                               | Tied to AGND                                                            | 0              |                | D.2 AVD        | V    |
| V <sub>L2</sub>     | Input mode 2 voltage                                               | Hi-Z                                                                    | 0.27*AV<br>DD  | 0.5*AVDD       | 0.545*AV<br>DD | V    |
| V <sub>L3</sub>     | Input mode 3 voltage                                               | 47 kΩ +/- 5% tied to AVDD                                               | 0.606*AV<br>DD | 0.757*AVD<br>D | 0.909*AV<br>DD | V    |
| V <sub>L4</sub>     | Input mode 4 voltage                                               | Tied to AVDD                                                            | 0.945*AV<br>DD |                | AVDD           | V    |
| R <sub>PU</sub>     | Input pullup resistance                                            | To AVDD                                                                 | 70             | 100            | 130            | kΩ   |
| R <sub>PD</sub>     | Input pulldown resistance                                          | To AGND                                                                 | 70             | 100            | 130            | kΩ   |
| FOUR-LEV            | EL INPUTS (OCP/SR)                                                 | 1                                                                       | 1              |                |                |      |
| V <sub>L1</sub>     | Input mode 1 voltage                                               | Tied to AGND                                                            | 0              |                | 0.09*AV<br>DD  | V    |
| V <sub>L2</sub>     | Input mode 2 voltage                                               | 22 k $\Omega$ ± 5% to AGND                                              | 0.12*AV<br>DD  | 0.15*AVDD      | 0.2*AVD<br>D   | V    |
| V <sub>L3</sub>     | Input mode 3 voltage                                               | Hi-Z                                                                    | 0.45*AV<br>DD  | 0.5*AVDD       | 0.55*AV<br>DD  | V    |
| V <sub>L4</sub>     | Input mode 4 voltage                                               | Tied to AVDD                                                            | 0.94*AV<br>DD  |                | AVDD           | V    |
| R <sub>PU</sub>     | Input pullup resistance                                            | To AVDD                                                                 | 80             | 100            | 120            | kΩ   |
| R <sub>PD</sub>     | Input pulldown resistance                                          | To AGND                                                                 | 80             | 100            | 120            | kΩ   |
| OPEN-DR             | AIN OUTPUTS (nFAULT)                                               |                                                                         |                |                | I              |      |
| V <sub>OL</sub>     | Output logic low voltage                                           | I <sub>OD</sub> = 5 mA                                                  |                |                | 0.4            | V    |
| I <sub>OH</sub>     | Output logic high current                                          | V <sub>OD</sub> = 5 V                                                   | -1             |                | 1              | μA   |
| C <sub>OD</sub>     | Output capacitance                                                 |                                                                         |                |                | 30             | pF   |
| PUSH-PUL            | L OUTPUTS (SDO)                                                    |                                                                         |                |                |                |      |
| V <sub>OL</sub>     | Output logic low voltage                                           | I <sub>OP</sub> = 5 mA                                                  | 0              |                | 0.4            | V    |
| V <sub>OH</sub>     | Output logic high voltage                                          | I <sub>OP</sub> = 5 mA                                                  | 2.2            |                | 5.5            | V    |
| I <sub>OL</sub>     | Output logic low leakage current                                   | V <sub>OP</sub> = 0 V                                                   | -1             |                | 1              | μA   |
| I <sub>OH</sub>     | Output logic high leakage current                                  | V <sub>OP</sub> = 5 V                                                   | -1             |                | 1              | μA   |
| C <sub>OD</sub>     | Output capacitance                                                 |                                                                         |                |                | 30             | pF   |
| DRIVER O            | UTPUTS                                                             |                                                                         |                |                |                |      |
|                     |                                                                    | V <sub>VM</sub> > 6 V, I <sub>OUT</sub> = 1 A, T <sub>A</sub> = 25°C    |                | 95             | 120            | mΩ   |
| <b>D</b>            | Total MOSFET on resistance (High-side                              | V <sub>VM</sub> < 6 V, I <sub>OUT</sub> = 1 A, T <sub>A</sub> = 25°C    |                | 105            | 130            | mΩ   |
| R <sub>DS(ON)</sub> | + Low-side)                                                        | V <sub>VM</sub> > 6 V, I <sub>OUT</sub> = 1 A, T <sub>J</sub> = 150 °C  |                | 140            | 185            | mΩ   |
|                     |                                                                    | V <sub>VM</sub> < 6 V, I <sub>OUT</sub> = 1 A, T <sub>J</sub> = 150 °C  |                | 145            | 190            | mΩ   |
|                     |                                                                    | $V_{VM}$ = 24 V, SLEW = 00b or SLEW pin tied to AGND                    | 14             | 25             | 45             | V/us |
| <b>9</b> D          | Phase pin slew rate switching low to high                          | $V_{VM}$ = 24 V, SLEW = 01b or SLEW pin to Hi-Z                         | 30             | 50             | 80             | V/us |
| SR                  | (Rising from 20 % to 80 %)                                         | $V_{VM}$ = 24 V, SLEW = 10b or SLEW pin to 47 k $\Omega$ +/- 5% to AVDD | 80             | 125            | 185            | V/us |
|                     |                                                                    | V <sub>VM</sub> = 24 V, SLEW = 11b or SLEW pin<br>tied to AVDD          | 130            | 200            | 280            | V/us |





|                        | to +150°C, V <sub>VM</sub> = 4.5 to 35 V (unless of<br>PARAMETER | TEST CONDITIONS                                                         | MIN   | TYP  | MAX                         | UNIT |
|------------------------|------------------------------------------------------------------|-------------------------------------------------------------------------|-------|------|-----------------------------|------|
|                        |                                                                  |                                                                         | WIIN  | 118  | MAX                         |      |
|                        |                                                                  | $V_{VM}$ = 24 V, SLEW = 00b or SLEW pin tied to AGND                    | 14    | 25   | 45                          | V/us |
|                        | Phase pin slew rate switching high to low                        | $V_{VM}$ = 24 V, SLEW = 01b or SLEW pin to Hi-Z                         | 30    | 50   | 80                          | V/us |
| SR                     | (Falling from 80 % to 20 %                                       | $V_{VM}$ = 24 V, SLEW = 10b or SLEW pin to 47 k $\Omega$ +/- 5% to AVDD | 80    | 125  | 185                         | V/us |
|                        |                                                                  | V <sub>VM</sub> = 24 V, SLEW = 11b or SLEW pin<br>tied to AVDD          | 110   | 200  | 280                         | V/us |
|                        | Leakage current on OUTx                                          | V <sub>OUTx</sub> = V <sub>VM</sub> , nSLEEP = 1                        |       |      | 5                           | mA   |
| LEAK                   | Leakage current on OUTx                                          | V <sub>OUTx</sub> = 0 V, nSLEEP = 1                                     |       |      | 1                           | μA   |
|                        |                                                                  | V <sub>VM</sub> = 24 V, SR = 25 V/µs, HS driver ON to LS driver OFF     |       | 1800 | 3400                        | ns   |
|                        | Output dead time (high to low / low to                           | $V_{VM}$ = 24 V, SR = 50 V/µs, HS driver ON to LS driver OFF            |       | 1100 | 1550                        | ns   |
| t <sub>DEAD</sub>      | high)                                                            | $V_{VM}$ = 24 V, SR = 125 V/µs, HS driver<br>ON to LS driver OFF        |       | 650  | 1000                        | ns   |
|                        |                                                                  | V <sub>VM</sub> = 24 V, SR = 200 V/µs, HS driver<br>ON to LS driver OFF |       | 500  | 750                         | ns   |
|                        | Propagation delay (high-side / low-side<br>ON/OFF)               | $V_{VM}$ = 24 V, INHx = 1 to OUTx transisition, SR = 25 V/µs            |       | 2000 | 4550                        | ns   |
| taa                    |                                                                  | $V_{VM}$ = 24 V, INHx = 1 to OUTx transisition, SR = 50V/µs             |       | 1200 | 2150                        | ns   |
| t <sub>PD</sub>        |                                                                  | $V_{VM}$ = 24 V, INHx = 1 to OUTx<br>transisition, SR = 125 V/µs        |       | 800  | 1350                        | ns   |
|                        |                                                                  | $V_{VM}$ = 24 V, INHx = 1 to OUTx transisition, SR = 200 V/µs           |       | 650  | 1050                        | ns   |
| t <sub>MIN_PULSE</sub> | Minimum output pulse width                                       | SR = 200 V/µs                                                           | 600   |      |                             | ns   |
| CURRENT                | SENSE AMPLIFIER                                                  |                                                                         |       |      |                             |      |
|                        |                                                                  | CSA_GAIN = 00                                                           |       | 0.15 |                             | V/A  |
| Gaal                   | Current sense gain (SPI Device)                                  | CSA_GAIN = 01                                                           |       | 0.3  |                             | V/A  |
| G <sub>CSA</sub>       |                                                                  | CSA_GAIN = 10                                                           |       | 0.6  |                             | V/A  |
|                        |                                                                  | CSA_GAIN = 11                                                           |       | 1.2  |                             | V/A  |
|                        |                                                                  | GAIN pin tied to AGND                                                   |       | 0.15 |                             | V/A  |
| 0                      |                                                                  | GAIN pin to Hi-Z                                                        |       | 0.3  |                             | V/A  |
| G <sub>CSA</sub>       | Current sense gain (HW Device)                                   | GAIN pin to 47 k $\Omega$ ± 5% to AVDD                                  |       | 0.6  |                             | V/A  |
|                        |                                                                  | GAIN pin tied to AVDD                                                   |       | 1.2  |                             | V/A  |
|                        |                                                                  | T <sub>A</sub> = 25°C, I <sub>PHASE</sub> < 4A                          | -9.5  |      | 9.5                         | %    |
| ~                      |                                                                  | $T_A = 25^{\circ}C, I_{PHASE} > 4A$                                     | -10.5 |      | 10.5                        | %    |
| G <sub>CSA_ERR</sub>   | Current sense gain error                                         | I <sub>PHASE</sub> < 4 A                                                | -10.5 |      | 10.5                        | %    |
|                        |                                                                  | I <sub>PHASE</sub> > 4 A                                                | -12.5 |      | 12.5                        | %    |
|                        | Current sense gain error matching                                | $T_A = 25^{\circ}C$                                                     | -4.5  |      | 4.5                         | %    |
| IMATCH                 | between phases A, B and C                                        |                                                                         | -7    |      | 7                           | %    |
| FS <sub>POS</sub>      | Full scale positive current measurement                          |                                                                         | 8     |      |                             | Α    |
| FS <sub>NEG</sub>      | Full scale negative current measurement                          |                                                                         |       |      | -8                          | Α    |
| V <sub>LINEAR</sub>    | SOX output voltage linear range                                  |                                                                         | 0.25  |      | V <sub>VREF</sub> –<br>0.25 | V    |
|                        |                                                                  | Phase current = 0 A, G <sub>CSA</sub> = 0.15 V/A                        | -50   |      | 50                          | mA   |
|                        |                                                                  | Phase current = 0 A, G <sub>CSA</sub> = 0.3 V/A                         | -50   |      | 50                          | mA   |
| IOFFSET                | Current sense offset low side current in                         | Phase current = 0 A, $G_{CSA}$ = 0.6 V/A                                | -50   |      | 50                          | mA   |
|                        | I                                                                |                                                                         |       |      |                             |      |

Copyright © 2022 Texas Instruments Incorporated



|                               | PARAMETER                                             | TEST CONDITIONS                                  | MIN    | TYP  | MAX            | UNIT  |
|-------------------------------|-------------------------------------------------------|--------------------------------------------------|--------|------|----------------|-------|
|                               |                                                       | Step on SOX = 1.2 V, G <sub>CSA</sub> = 0.15 V/A |        |      | 1              | μs    |
|                               |                                                       | Step on SOX = 1.2 V, G <sub>CSA</sub> = 0.3 V/A  |        |      | 1              | μs    |
| t <sub>SET</sub>              | Settling time to ±1%, 30 pF                           | Step on SOX = 1.2 V, G <sub>CSA</sub> = 0.6 V/A  |        |      | 1              | μs    |
|                               |                                                       | Step on SOX = 1.2 V, G <sub>CSA</sub> = 1.2 V/A  |        |      | 1              | μs    |
| V <sub>DRIFT</sub>            | Drift offset                                          | Phase current = 0 A                              | -160   |      | 160            | µA/°C |
| I <sub>VREF</sub>             | VREF input current                                    | VREF = 3.0 V                                     |        |      | 50             | μA    |
|                               |                                                       | AVDD to SOx, DC                                  | 55     |      | 80             | dB    |
| PSRR                          | Power Supply Rejection Ratio                          | AVDD to SOx, 10 kHz                              | 39     |      | 56             | dB    |
|                               |                                                       | AVDD to SOx, 500 kHz                             | 5      |      | 22             | dB    |
| PULSE-BY-                     | PULSE CURRENT LIMIT                                   | -                                                |        |      |                |       |
| V <sub>LIM</sub>              | Voltage on VLIM pin for cycle by cycle current limit  |                                                  | AVDD/2 |      | AVDD/2-<br>0.4 | V     |
| I <sub>LIMIT</sub>            | Current limit corresponding to VLIM pin voltage range |                                                  | 0      |      | 8              | А     |
| I <sub>LIM_AC</sub>           | Current limit accuracy                                |                                                  | -10    |      | 10             | %     |
| t <sub>BLANK</sub>            | Cycle by cycle current limit blank time               |                                                  |        | 5    |                | μs    |
| PROTECTIO                     | ON CIRCUITS                                           |                                                  |        |      |                |       |
| N/                            | Supply undervoltage lockout (UVLO)                    | VM rising                                        | 4.3    | 4.4  | 4.5            | V     |
| V <sub>UVLO</sub>             | Supply undervoltage lockout (UVLO)                    | VM falling                                       | 4.1    | 4.2  | 4.3            | V     |
| V <sub>UVLO_HYS</sub>         | Supply undervoltage lockout hysteresis                | Rising to falling threshold                      | 140    | 200  | 350            | mV    |
| t <sub>UVLO</sub>             | Supply undervoltage deglitch time                     |                                                  | 3      | 5    | 7              | μs    |
|                               | Supply overvoltage protection (OVP)<br>(SPI Device)   | Supply rising, OVP_EN = 1, OVP_SEL = 0           | 32.5   | 34   | 35             | V     |
| Max a                         |                                                       | Supply falling, OVP_EN = 1, OVP_SEL<br>= 0       | 31.8   | 33   | 34.3           | V     |
| V <sub>OVP</sub>              |                                                       | Supply rising, OVP_EN = 1, OVP_SEL = 1           | 20     | 22   | 23             | V     |
|                               |                                                       | Supply falling, OVP_EN = 1, OVP_SEL<br>= 1       | 19     | 21   | 22             | V     |
| Variation                     | Supply overvoltage protection (OVP)                   | Rising to falling threshold, OVP_SEL = 1         | 0.9    | 1    | 1.1            | V     |
| V <sub>OVP_HYS</sub>          | (SPI Device)                                          | Rising to falling threshold, OVP_SEL = 0         | 0.7    | 0.8  | 0.9            | V     |
| t <sub>OVP</sub>              | Supply overvoltage deglitch time                      |                                                  | 2.5    | 5    | 7              | μs    |
| Varuu                         | Charge pump undervoltage lockout                      | Supply rising                                    | 2.3    | 2.5  | 2.7            | V     |
| V <sub>CPUV</sub>             | (above VM)                                            | Supply falling                                   | 2.2    | 2.4  | 2.6            | V     |
| V <sub>CPUV_HYS</sub>         | Charge pump UVLO hysteresis                           | Rising to falling threshold                      | 75     | 100  | 140            | mV    |
| V                             | Analog regulator undervoltage lockout                 | Supply rising                                    | 2.7    | 2.85 | 3              | V     |
| V <sub>AVDD_UV</sub>          |                                                       | Supply falling                                   | 2.5    | 2.65 | 2.8            | V     |
| V <sub>AVDD</sub> _<br>UV_HYS | Analog regulator undervoltage lockout hysteresis      | Rising to falling threshold                      | 180    | 200  | 240            | mV    |
|                               | Overcurrent protection trip point (SPI                | OCP_LVL = 0b                                     | 10     | 16   | 20             | А     |
|                               | Device)                                               | OCP_LVL = 1b                                     | 15     | 24   | 28             | А     |
| I <sub>OCP</sub>              | Overcurrent protection trip point (HW                 | OCP pin tied to AGND                             | 10     | 16   | 21.5           | Α     |
|                               | Device)                                               | OCP pin tied to AVDD                             | 15     | 24   | 31             | А     |



|                                                                 | PARAMETER                                           | TEST CONDITIONS                   | MIN  | TYP  | MAX | UNIT |
|-----------------------------------------------------------------|-----------------------------------------------------|-----------------------------------|------|------|-----|------|
|                                                                 |                                                     | OCP_DEG = 00b                     | 0.06 | 0.3  | 0.7 | μs   |
|                                                                 | Overcurrent protection deglitch time                | OCP_DEG = 01b                     | 0.2  | 0.6  | 1.2 | μs   |
| t <sub>OCP</sub>                                                | (SPI Device)                                        | OCP_DEG = 10b                     | 0.6  | 1.25 | 1.8 | μs   |
| <b>1</b> 00P                                                    |                                                     | OCP_DEG = 11b                     | 1    | 1.6  | 2.5 | μs   |
|                                                                 | Overcurrent protection deglitch time<br>(HW Device) |                                   | 0.06 | 0.3  | 0.6 | μs   |
| t <sub>RETRY</sub> Overcurrent protection retry<br>(SPI Device) | Overcurrent protection retry time                   | OCP_RETRY = 0                     | 4    | 5    | 6   | ms   |
|                                                                 | (SPI Device)                                        | OCP_RETRY = 1                     | 425  | 500  | 575 | ms   |
| t <sub>RETRY</sub>                                              | Overcurrent protection retry time<br>(HW Device)    |                                   | 4    | 5    | 6   | ms   |
| T <sub>OTW</sub>                                                | Thermal warning temperature                         | Die temperature (T <sub>J</sub> ) | 160  | 170  | 180 | °C   |
| T <sub>OTW_HYS</sub>                                            | Thermal warning hysteresis                          | Die temperature (T <sub>J</sub> ) | 25   | 30   | 35  | °C   |
| T <sub>TSD</sub>                                                | Thermal shutdown temperature                        | Die temperature (T <sub>J</sub> ) | 175  | 185  | 195 | °C   |
| T <sub>TSD_HYS</sub>                                            | Thermal shutdown hysteresis                         | Die temperature (T <sub>J</sub> ) | 25   | 30   | 35  | °C   |
| T <sub>TSD_FET</sub>                                            | Thermal shutdown temperature (FET)                  | Die temperature (T <sub>J</sub> ) | 170  | 180  | 190 | °C   |
| T <sub>TSD_FET_HY</sub><br>s                                    | Thermal shutdown hysteresis (FET)                   | Die temperature (T <sub>J</sub> ) | 25   | 30   | 35  | °C   |

#### 40°C to +150°C V = 4.5 to 35 V (unless otherwise noted). Typical limits apply for T. - 25°C V - 24 1/

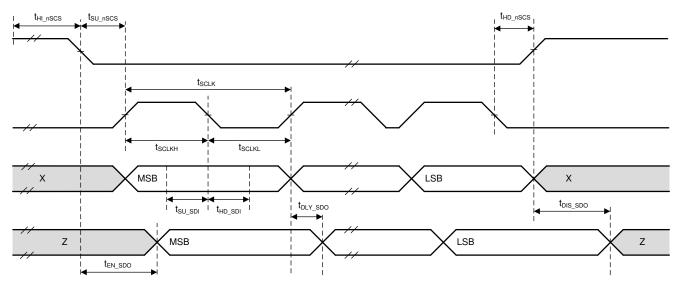
(1)  $R_{LBK}$  is resistance of inductor  $L_{BK}$ 

# 7.6 SPI Timing Requirements

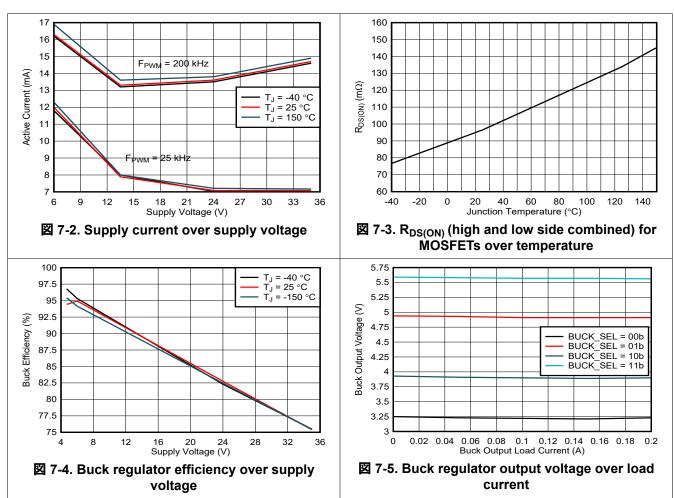
|                      |                            | MIN | NOM | MAX | UNIT |
|----------------------|----------------------------|-----|-----|-----|------|
| t <sub>READY</sub>   | SPI ready after power up   |     |     | 1   | ms   |
| t <sub>HI_nSCS</sub> | nSCS minimum high time     | 300 |     |     | ns   |
| t <sub>SU_nSCS</sub> | nSCS input setup time      | 25  |     |     | ns   |
| t <sub>HD_nSCS</sub> | nSCS input hold time       | 25  |     |     | ns   |
| t <sub>SCLK</sub>    | SCLK minimum period        | 100 |     |     | ns   |
| t <sub>SCLKH</sub>   | SCLK minimum high time     | 50  |     |     | ns   |
| t <sub>SCLKL</sub>   | SCLK minimum low time      | 50  |     |     | ns   |
| t <sub>SU_SDI</sub>  | SDI input data setup time  | 25  |     |     | ns   |
| t <sub>HD_SDI</sub>  | SDI input data hold time   | 25  |     |     | ns   |
| t <sub>DLY_SDO</sub> | SDO output data delay time |     |     | 25  | ns   |
| t <sub>EN_SDO</sub>  | SDO enable delay time      |     |     | 50  | ns   |
| t <sub>DIS_SDO</sub> | SDO disable delay time     |     |     | 50  | ns   |



# 7.7 SPI Slave Mode Timings







# 7.8 Typical Characteristics

15



# 8 Detailed Description

# 8.1 Overview

The DRV8316-Q1 device is an integrated95-m $\Omega$  (combined high-side and low-side MOSFET's on-state resistance) driver for 3-phase motor-drive applications. The device reduces system component count, cost, and complexity by integrating three half-bridge MOSFETs, gate drivers, charge pump, current sense amplifiers, linear regulator for the external load and buck regulator. A standard serial peripheral interface (SPI) provides a simple method for configuring the various device settings and reading fault diagnostic information through an external controller. Alternatively, a hardware interface (H/W) option allows for configuring the most commonly used settings through fixed external resistors.

The architecture uses an internal state machine to protect against short-circuit events, and protect against dv/dt parasitic turnon of the internal power MOSFET.

The DRV8316-Q1 device integrates three, bidirectional current-sense amplifiers for monitoring the current level through each of the half-bridges using a built-in current sense. The gain setting of the amplifier can be adjusted through the SPI or hardware interface.

In addition to the high level of device integration, the DRV8316-Q1 device provides a wide range of integrated protection features. These features include power-supply undervoltage lockout (UVLO), charge-pump undervoltage lockout (CPUV), overcurrent protection (OCP), AVDD undervoltage lockout (AVDD\_UV), buck regulator ULVO for DRV8316-Q1 and overtemperature shutdown (OTW and OTSD). Fault events are indicated by the nFAULT pin with detailed information available in the SPI registers on the SPI device version.

The DRV8316R-Q1 and DRV8316T-Q1 device are available in 0.5-mm pin pitch, VQFN surface-mount packages. The VQFN package size is 7 mm × 5 mm.



# 8.2 Functional Block Diagram

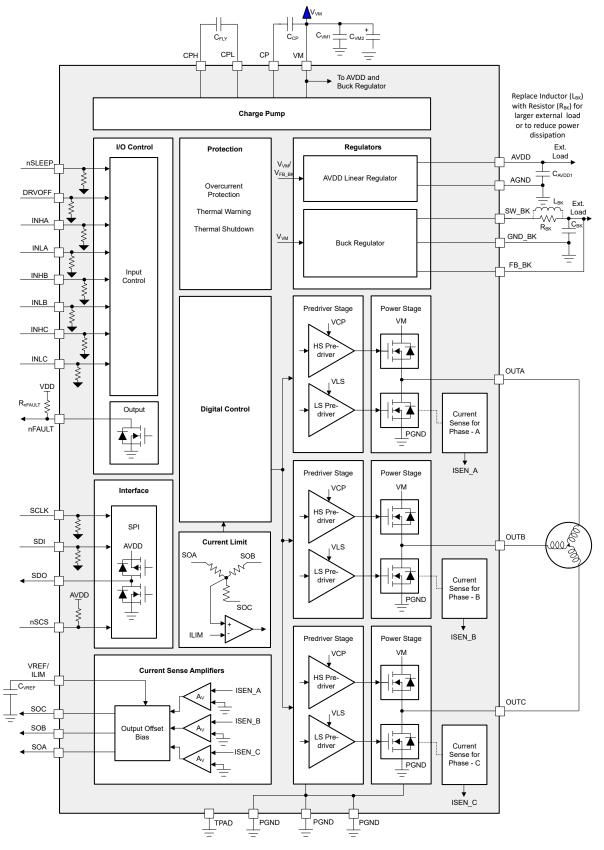
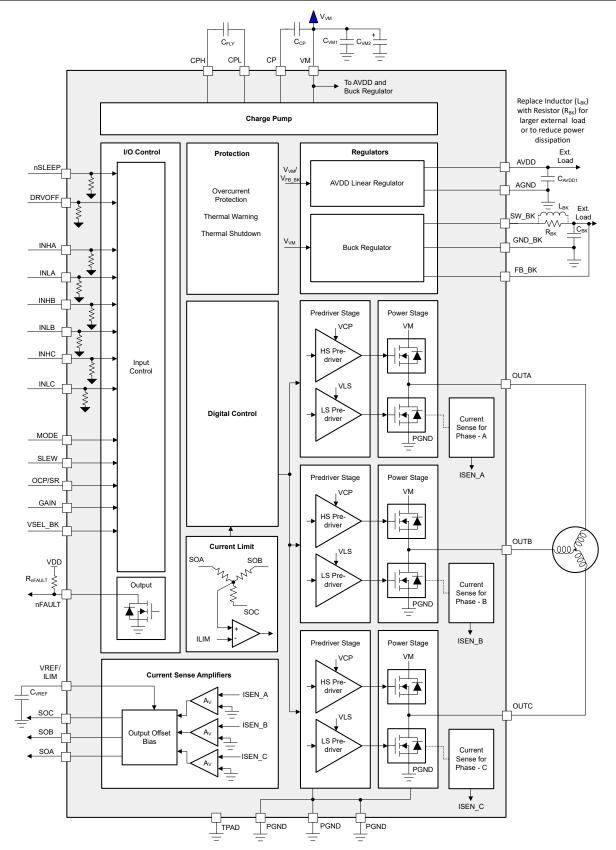


図 8-1. DRV8316R-Q1 Block Diagram









# 8.3 Feature Description

 $\pm$  8-1 lists the recommended values of the external components for the driver.

#### Note

TI recommends to connect pull up on nFAULT even if it is not used to avoid undesirable entry into internal test mode. If external supply is used to pull up nFAULT, ensure that it is pulled to >2.2V on power up or the device will enter internal test mode.

| COMPONENTS           | PIN 1     | PIN 2        | RECOMMENDED                                                                                                                                                                                              |
|----------------------|-----------|--------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| C <sub>VM1</sub>     | VM        | PGND         | X5R or X7R, 0.1-µF, TI recommends a capacitor<br>voltage rating at least twice the normal operating<br>voltage of the device                                                                             |
| C <sub>VM2</sub>     | VM        | PGND         | ≥ 10-µF, TI recommends a capacitor voltage rating at least twice the normal operating voltage of the device                                                                                              |
| C <sub>CP</sub>      | CP        | VM           | X5R or X7R, 16-V, 1-µF capacitor                                                                                                                                                                         |
| C <sub>FLY</sub>     | СРН       | CPL          | X5R or X7R, 47-nF, TI recommends a capacitor<br>voltage rating at least twice the normal operating<br>voltage of the pin                                                                                 |
| C <sub>AVDD</sub>    | AVDD      | AGND         | X5R or X7R, 1-μF, ≥ 6.3-V. In order for AVDD to<br>accurately regulate output voltage, capacitor should<br>have effective capacitance between 0.7-μF to 1.3-μF<br>at 3.3-V across operating temperature. |
| C <sub>BK</sub>      | SW_BK     | GND_BK       | X5R or X7R, 1-μF, ≥ 6.3-V. In order for AVDD to<br>accurately regulate output voltage, capacitor should<br>have effective capacitance between 0.7-μF to 1.3-μF<br>at 3.3-V across operating temperature. |
| L <sub>BK</sub>      | SW_BK     | FB_BK        | Output inductor                                                                                                                                                                                          |
| R <sub>nFAULT</sub>  | VCC       | nFAULT       | 5.1-kΩ, Pullup resistor                                                                                                                                                                                  |
| R <sub>MODE</sub>    | MODE      | AGND or AVDD | DRV8316T-Q1 hardware interface                                                                                                                                                                           |
| R <sub>SLEW</sub>    | SLEW      | AGND or AVDD | DRV8316T-Q1 hardware interface                                                                                                                                                                           |
| R <sub>OCP</sub>     | OCP       | AGND or AVDD | DRV8316T-Q1 hardware interface                                                                                                                                                                           |
| R <sub>GAIN</sub>    | GAIN      | AGND or AVDD | DRV8316T-Q1 hardware interface                                                                                                                                                                           |
| R <sub>VSEL_BK</sub> | VSEL_BK   | AGND or AVDD | DRV8316-Q1 hardware interface                                                                                                                                                                            |
| C <sub>VREF</sub>    | VREF/ILIM | AGND         | X5R or X7R, 0.1-µF, VREF-rated capacitor (Optional                                                                                                                                                       |

#### 表 8-1. DRV8316-Q1 External Components

Note

TI recommends to connect pull up on nFAULT even if it is not used to avoid undesirable entry into internal test mode.

# 8.3.1 Output Stage

The DRV8316-Q1 device consists of an integrated  $95-m\Omega$  (combined high-side and low-side FET's on-state resistance) NMOS FETs connected in a three-phase bridge configuration. A doubler charge pump provides the proper gate-bias voltage to the high-side NMOS FET's across a wide operating-voltage range in addition to providing 100% duty-cycle support. An internal linear regulator provides the gate-bias voltage for the low-side MOSFETs. The device has three VM motor power-supply pins which are to be connected together to the motor-supply voltage.

#### 8.3.2 Control Modes

The DRV8316-Q1 family of devices provides four different control modes to support various commutation and control methods.  $\frac{1}{5}$  8-2 shows the various modes of the DRV8316-Q1 device.



| MODE Type | MODE Pin<br>(Hardware<br>Variant)           | PWM_MODE Bits<br>(SPI Variant) | MODE                       |
|-----------|---------------------------------------------|--------------------------------|----------------------------|
| Mode 1    | Connected to<br>AGND                        | PWM_MODE =<br>00b              | 6x Mode                    |
| Mode 2    | Hi-Z                                        | PWM_MODE =<br>01b              | 6x Mode with Current Limit |
| Mode 3    | Connected to<br>AVDD with R <sub>MODE</sub> | PWM_MODE = 10b                 | 3x Mode                    |
| Mode 4    | Connected to<br>AVDD                        | PWM_MODE = 11b                 | 3x Mode with Current Limit |

# 表 8-2. PWM Control Modes

#### Note

Texas Instruments does not recommend changing the MODE pin or PWM\_MODE register during operation of the power MOSFETs. Set all INHx and INLx pins to logic low before changing the MODE pin or PWM\_MODE register.

#### 8.3.2.1 6x PWM Mode (MODE = 00b or MODE Pin Tied to AGND)

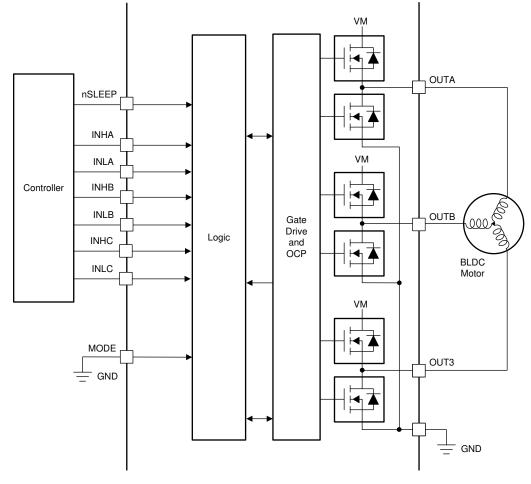
In 6x PWM mode, each half-bridge supports three output states: low, high, or high-impedance (Hi-Z). The corresponding INHx and INLx signals control the output state as listed in  $\frac{1}{5}$  8-3.

| INLx | INHx | PHASEx |  |  |  |  |
|------|------|--------|--|--|--|--|
| 0    | 0    | Hi-Z   |  |  |  |  |
| 0    | 1    | Н      |  |  |  |  |
| 1    | 0    | L      |  |  |  |  |
| 1    | 1    | Hi-Z   |  |  |  |  |

# 表 8-3. 6x PWM Mode Truth Table

☑ 8-3 shows the application diagram of DRV8316-Q1 configured in 6x PWM mode.





🖾 8-3. 6x PWM Mode



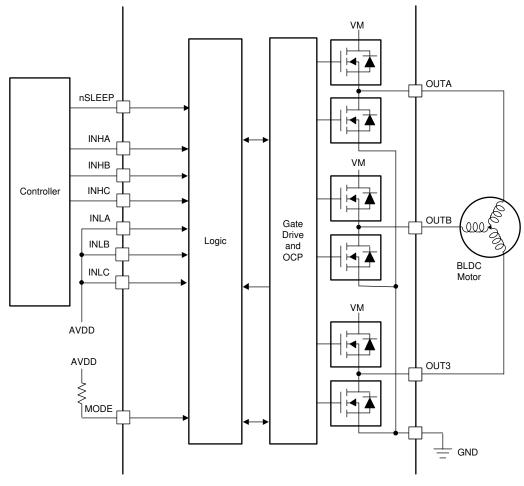
# 8.3.2.2 3x PWM Mode (MODE = 10b or MODE Pin is Connected to AGND with $R_{MODE}$ )

In 3x PWM mode, the INHx pin controls each half-bridge and supports two output states: low or high. The INLx pin is used to put the half bridge in the Hi-Z state. If the Hi-Z state is not required, tie all INLx pins to logic high. The corresponding INHx and INLx signals control the output state as listed in  $\gtrsim 8-4$ .

| INLx | INHx | PHASEx |  |  |  |
|------|------|--------|--|--|--|
| 0    | Х    | Hi-Z   |  |  |  |
| 1    | 0    | L      |  |  |  |
| 1    | 1    | Н      |  |  |  |

# 表 8-4. 3x PWM Mode Truth Table

⊠ 8-4 shows the application diagram of DRV8316-Q1 configured in 3x PWM mode.

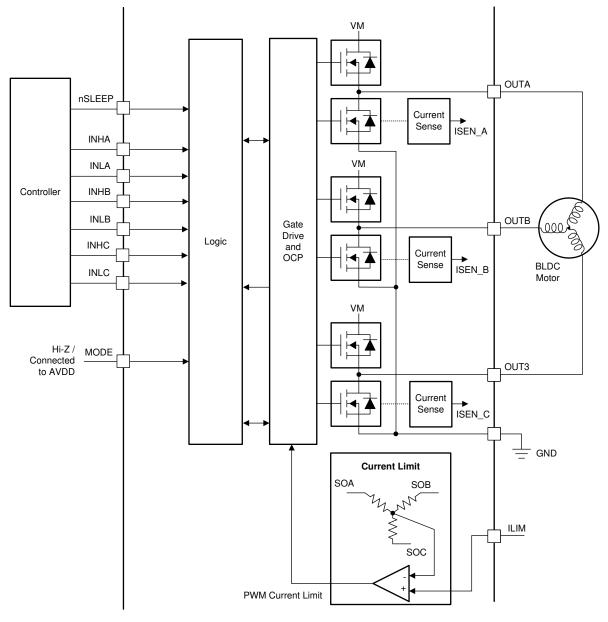


🖾 8-4. 3x PWM Mode



# 8.3.2.3 Current Limit Mode (MODE = 01b / 11b or MODE Pin is Hi-Z or Connected to AVDD)

⊠ 8-5 shows the application diagram of DRV8316-Q1 configured in current limit mode. A current limit comparator is used for the current limiting which input is generated with the three current sense amplifier's outputs.



🛛 8-5. Current Limit Mode



#### 8.3.3 Device Interface Modes

The DRV8316-Q1 family of devices supports two different interface modes (SPI and hardware) to let the end application design for either flexibility or simplicity. The two interface modes share the same four pins, allowing the different versions to be pin-to-pin compatible. This compatibility lets application designers evaluate with one interface version and potentially switch to another with minimal modifications to their design.

#### 8.3.3.1 Serial Peripheral Interface (SPI)

The SPI devices support a serial communication bus that lets an external controller send and receive data with the DRV8316-Q1. This support lets the external controller configure device settings and read detailed fault information. The interface is a four wire interface using the SCLK, SDI, SDO, and nSCS pins which are described as follows:

- The SCLK pin is an input that accepts a clock signal to determine when data is captured and propagated on the SDI and SDO pins.
- The SDI pin is the data input.
- The SDO pin is the data output. The SDO pin uses an open-drain structure and requires an external pullup resistor.
- The nSCS pin is the chip select input. A logic low signal on this pin enables SPI communication with the DRV8316-Q1.

For more information on the SPI, see the セクション 8.5 section.

#### 8.3.3.2 Hardware Interface

Hardware interface devices convert the four SPI pins into four resistor-configurable inputs which are GAIN, SLEW, MODE, and OCP.

This conversion lets the application designer configure the most common device settings by tying the pin logic high or logic low, or with a simple pullup or pulldown resistor. This removes the requirement for an SPI bus from the external controller. General fault information can still be obtained through the nFAULT pin.

- The GAIN pin configures the gain of the current sense amplifier.
- The SLEW pin configures the slew rate of the output voltage.
- The MODE pin configures the PWM control mode.
- The OCP/SR pin is used to configures the OCP level and active demagnetization modes.

For more information on the hardware interface, see the セクション 8.3.10 section.

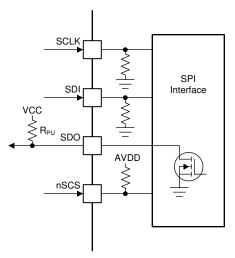


図 8-6. DRV8316R-Q1 SPI Interface

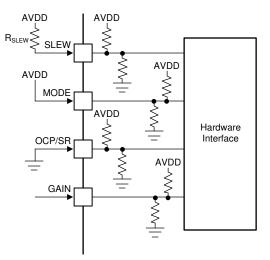


図 8-7. DRV8316T-Q1 Hardware Interface



#### 8.3.4 Step-Down Mixed-Mode Buck Regulator

The DRV8316R-Q1 and DRV8316T-Q1 has an integrated mixed-mode buck regulator in conjunction with AVDD to supply regulated 3.3 V or 5.0 V power for an external controller or system voltage rail. Additionally, the buck output can also be configured to 4.0 V or 5.7 V for supporting the extra headroom for external LDO for generating a 3.3 V or 5.0 V supplies. The output voltage of the buck is set by the VSEL\_BK pin in the DRV8316T-Q1 device (hardware variant) and BUCK\_SEL bits in the DRV8316R-Q1 device (SPI variant).

The buck regulator has a low quiescent current of ~1-2 mA during light loads to prolong battery life. The device improves performance during line and load transients by implementing a pulse-frequency current-mode control scheme which requires less output capacitance and simplifies frequency compensation design.

To disable the buck regulator, set the BUCK\_DIS bit in the DRV8316R-Q1 (SPI variant). The buck regulator cannot be disabled in the DRV8316T-Q1 (hardware variant).

Note

If the buck regulator is unused, the buck pins SW\_BK, GND\_BK, and FB\_BK cannot be left floating or connected to ground. The buck regulator components  $L_{BK}/R_{BK}$  and  $C_{BK}$  must be connected in hardware.

| A 0-5. Recommended settings for buck Regulator |                     |                                                      |                                                 |                          |                                    |
|------------------------------------------------|---------------------|------------------------------------------------------|-------------------------------------------------|--------------------------|------------------------------------|
| Buck Mode                                      | Buck output voltage | Max output current<br>from AVDD (I <sub>AVDD</sub> ) | Max output current from Buck (I <sub>BK</sub> ) | Buck current limit       | AVDD power<br>sequencing           |
| Inductor - 47 µH                               | 3.3 V or 4.0 V      | 30 mA                                                | 200 mA - I <sub>AVDD</sub>                      | 600 mA (BUCK_CL = 0b)    | Not supported<br>(BUCK_PS_DIS = 1) |
| Inductor - 47 µH                               | 5.0 V or 5.7 V      | 30 mA                                                | 200 mA - I <sub>AVDD</sub>                      | 600 mA (BUCK_CL = 0b)    | Supported<br>(BUCK_PS_DIS = 0)     |
| Inductor - 22 µH                               | 5.0 V or 5.7 V      | 30 mA                                                | 50 mA - I <sub>AVDD</sub>                       | 150 mA (BUCK_CL =<br>1b) | Not supported<br>(BUCK_PS_DIS = 1) |
| Inductor - 22 µH                               | 3.3 V or 4.0 V      | 30 mA                                                | 50 mA - I <sub>AVDD</sub>                       | 150 mA (BUCK_CL =<br>1b) | Supported<br>(BUCK_PS_DIS = 0)     |
| Resistor - 22 µH                               | 5.0 V or 5.7 V      | 30 mA                                                | 40 mA - I <sub>AVDD</sub>                       | 150 mA (BUCK_CL =<br>1b) | Not supported<br>(BUCK_PS_DIS = 1) |
| Resistor - 22 µH                               | 3.3 V or 4.0 V      | 30 mA                                                | 40 mA - I <sub>AVDD</sub>                       | 150 mA (BUCK_CL =<br>1b) | Supported<br>(BUCK_PS_DIS = 0)     |

#### 表 8-5. Recommended settings for Buck Regulator

#### 8.3.4.1 Buck in Inductor Mode

The buck regulator in DRV8316-Q1 device is primarily designed to support low inductance of  $47\mu$ H and  $22\mu$ H inductors. The  $47\mu$ H inductor allows the buck regulator to operate up to 200 mA load current support, whereas the  $22\mu$ H inductor limits the load current to 50 mA.

☑ 8-8 shows the connection of buck regulator in inductor mode.



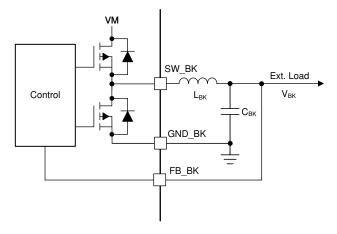
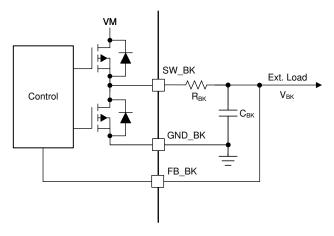


図 8-8. Buck (Inductor Mode)

# 8.3.4.2 Buck in Resistor mode

If the external load requirements is less than 40mA, the inductor can be replaced with a resistor. In resistor mode the power is dissipated across the external resistor and the efficiency is lower than buck in inductor mode.

⊠ 8-9 shows the connection of buck regulator in resistor mode.



🛛 8-9. Buck (Resistor Mode)



## 8.3.4.3 Buck Regulator with External LDO

The buck regulator also supports the voltage requirement to fed to external LDO to generate standard 3.3 V or 5.0 V output rail with higher accuracies. The buck output voltage should be configured to 4 V or 5.5 V to provide for a extra headroom to support the external LDO for generating 3.3 V or 5 V rail as shown in  $\boxtimes$  8-10.

This allows for a lower-voltage LDO design to save cost and better thermal management due to low drop-out voltage.

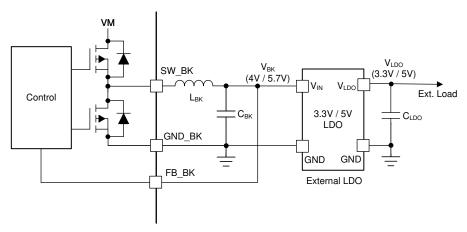


図 8-10. Buck Regulator with External LDO

#### 8.3.4.4 AVDD Power Sequencing on Buck Regulator

The AVDD LDO has an option of using the power supply from mixed mode buck regulator to reduce power dissipation internally. The power sequencing mode allows on-the-fly changeover of LDO power supply from DC mains (VM) to buck output (VBK) as shown in  $\boxtimes$  8-11. This sequencing can be configured through the BUCK\_PS\_DIS bit . Power sequencing is supported only when buck output voltage is set to 5.0 V or 5.7 V.



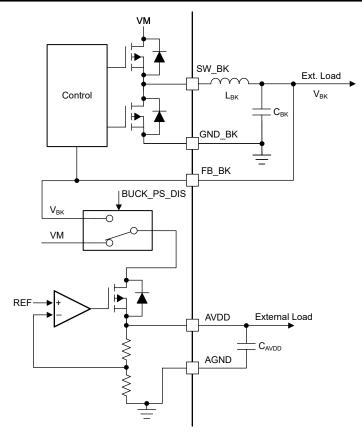


図 8-11. AVDD Power Sequencing on mixed mode Buck Regulator

# 8.3.4.5 Mixed mode Buck Operation and Control

The buck regulator implements a pulse frequency modulation (PFM) architecture with peak current mode control. The output voltage of the buck regulator is compared with the internal reference voltage ( $V_{BK\_REF}$ ) which is internally generated depending on the buck-output voltage setting (BUCK\_SEL) which constitutes an outer voltage control loop. Depending on the comparator output going high ( $V_{BK} < V_{BK\_REF}$ ) or low ( $V_{BK} > V_{BK\_REF}$ ), the high-side power FET of the buck turns on and turn off respectively. An independent current control loop monitors the current in high-side power FET ( $I_{BK}$ ) and turns off the high-side FET when the current becomes higher than the buck current limit ( $I_{BK\_CL}$ ). This implements a current limit control for the buck regulator.  $\boxtimes$  8-12 shows the architecture of the buck and various control/protection loops.



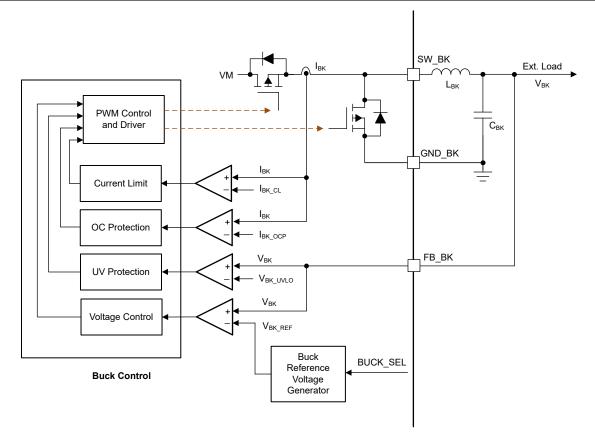


図 8-12. Buck Operation and Control Loops

# 8.3.4.6 Buck Undervoltage Protection

If at any time the input supply voltage on the FB\_BK pin falls lower than the  $V_{BK_UVLO}$  threshold, all of the both high-side and low-side MOSFETs of the buck regulator are disabled and the nFAULT pin is driven low. The FAULT, BK\_FLT and BUCK\_UV bits are also latched high in the registers on SPI devices. Normal operation starts again (buck operation and the nFAULT pin is released) when the VBK undervoltage condition clears. The BUCK\_UV bit stays set until cleared through the CLR\_FLT bit or an nSLEEP pin reset pulse (t<sub>RST</sub>).

# 8.3.4.7 Buck Overcurrent Protection

The overcurrent event is sensed by monitoring the current flowing through high-side MOSFET of the buck regulator. If the current across high-side MOSFET exceeds the  $I_{BK_OCP}$  threshold for longer than the  $t_{OCP_DEG}$  deglitch time, a buck OCP event is recognized and nFAULT pin is driven low. The FAULT, BK\_FLT and BK\_OCP bits are latched high in the SPI registers. Normal operation starts again automatically (buck operation and the nFAULT pin is released) after the  $t_{RETRY}$  time elapses. The FAULT, BK\_FLT and BK\_OCP bits stay latched until the  $t_{RETRY}$  period expires.

On hardware interface devices, the  $I_{BK\_OCP}$  threshold is set to 600-mA, whereas on SPI devices, the  $I_{BK\_OCP}$  threshold is set through the BUCK\_CL bit to either to 600-mA or 150-mA.



## 8.3.5 AVDD Linear Voltage Regulator

A 3.3-V, linear regulator is integrated into the DRV8316-Q1 family of devices and is available for use by external circuitry. The AVDD regulator is used for powering up the internal digital circuitry of the device and additionally, this regulator can also provide the supply voltage for a low-power MCU or other circuitry supporting low current (up to 30 mA). The output of the AVDD regulator should be bypassed near the AVDD pin with a X5R or X7R, 1- $\mu$ F, 6.3-V ceramic capacitor routed directly back to the adjacent AGND ground pin.

The AVDD nominal, no-load output voltage is 3.3V.

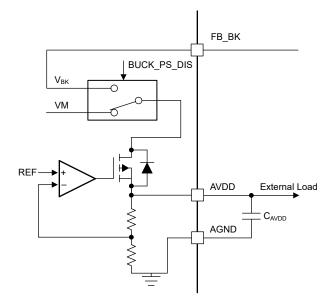


図 8-13. AVDD Linear Regulator Block Diagram

Use  $\neq$  1 to calculate the power dissipated in the device by the AVDD linear regulator with VM as supply (BUCK\_PD\_DIS = 1)

$$P = (V_{VM} - V_{AVDD}) \times I_{AVDD} \tag{1}$$

For example, at a V<sub>VM</sub> of 24 V, drawing 20 mA out of AVDD results in a power dissipation as shown in  $\pm$  2.

$$P = (24 V - 3.3 V) \times 20 mA = 414 mW$$

Use  $\neq 3$  to calculate the power dissipated in the device by the AVDD linear regulator with buck output as supply (BUCK\_PD\_DIS = 0)

$$P = (V_{FB_BK} - V_{AVDD}) \times I_{AVDD}$$
(3)

(2)



# 8.3.6 Charge Pump

Because the output stages use N-channel FETs, the device requires a gate-drive voltage higher than the VM power supply to enhance the high-side FETs fully. The DRV8316-Q1 integrates a charge-pump circuit that generates a voltage above the VM supply for this purpose.

The charge pump requires two external capacitors for operation. See the block diagram, pin descriptions and see section ( $\forall 2 2 \geq 8.3$ ) for details on these capacitors (value, connection, and so forth).

The charge pump shuts down when nSLEEP is low.

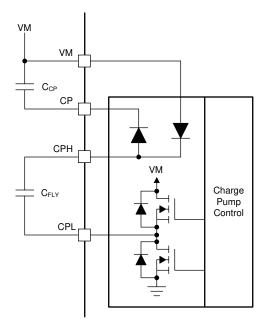
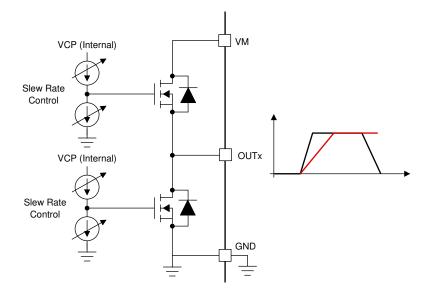


図 8-14. DRV8316-Q1 Charge Pump



#### 8.3.7 Slew Rate Control

An adjustable gate-drive current control to the MOSFETs of half-bridges is implemented to achieve the slew rate control. The MOSFET VDS slew rates are a critical factor for optimizing radiated emissions, energy and duration of diode recovery spikes, and switching voltage transients related to parasitics. These slew rates are predominantly determined by the rate of gate charge to internal MOSFETs as shown in 🛛 8-15.



#### 図 8-15. Slew Rate Circuit Implementation

The slew rate of each half-bridge can be adjusted by the SLEW pin in hardware device variant or by using the SLEW bits in SPI device variant. Each half-bridge can be selected to either of a slew rate setting of 25-V/ $\mu$ s, 50-V/ $\mu$ s, 125-V/ $\mu$ s or 200-V/ $\mu$ s. The slew rate is calculated by the rise time and fall time of the voltage on OUTx pin as shown in  $\boxtimes$  8-16.

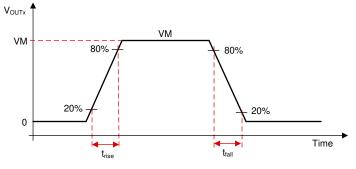
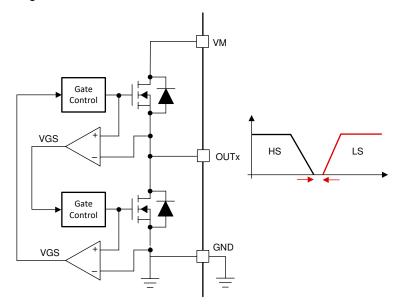


図 8-16. Slew Rate Timings

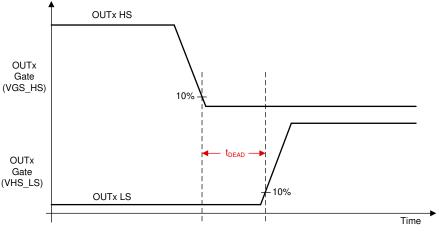


#### 8.3.8 Cross Conduction (Dead Time)

The device is fully protected for any cross conduction of MOSFETs. In half-bridge configuration, the operation of high-side and low-side MOSFETs are ensured to avoid any shoot-through currents by inserting a dead time  $(t_{dead})$ . This is implemented by sensing the gate-source voltage (VGS) of the high-side and low-side MOSFETs and ensuring that VGS of high-side MOSFET has reached below turn-off levels before switching on the low-side MOSFET of same half-bridge as shown in  $\boxtimes$  8-17 and  $\boxtimes$  8-18.



**図** 8-17. Cross Conduction Protection



🛛 8-18. Dead Time



## 8.3.9 Propagation Delay

The propagation delay time  $(t_{pd})$  is measured as the time between an input logic edge to change in gate driver voltage. This time has three parts consisting of the digital input deglitcher delay, analog driver, and comparator delay.

The input deglitcher prevents high-frequency noise on the input pins from affecting the output state of the gate drivers. To support multiple control modes, a small digital delay is added as the input command propagates through the device.

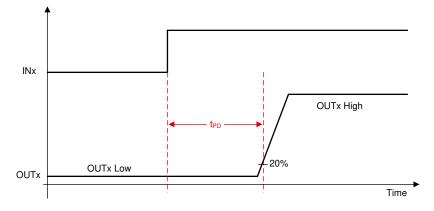


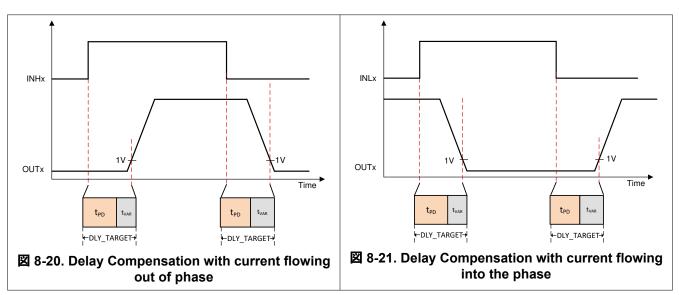
図 8-19. Propagation Delay Timing

# 8.3.9.1 Driver Delay Compensation

DRV8316-Q1 monitors the prorogation delay internally and adds a variable delay on top of it to provide fixed delay as shown in  $\boxtimes$  8-20 and  $\boxtimes$  8-21. Delay compensation feature reduces uncertainty caused in timing of current measurement and also reduces duty cycle distortion caused due to propagation delay.

The fixed delay is summation of propagation delay  $(t_{PD})$  caused to internal driver delay and variable delay  $(t_{VAR})$  added to compensate for uncertainty. The fixed delay can be configured through DLY\_TARGET register. Refer  $\gtrsim 8-6$  for recommendation on configuration for DLY\_TARGET for different slew rate settings.

Delay compensation is only available in SPI variant DRV8316R-Q1 and can be enabled by configuring DLYCMP\_EN and DLY\_TARGET. It is disabled in hardware variant DRV8316T-Q1



| 表 8-6. Delay larget Recommendation |                           |  |  |  |
|------------------------------------|---------------------------|--|--|--|
| SLEW RATE                          | DLY_TARGET                |  |  |  |
| 200 V/µs                           | DLY_TARGET = 0x5 (1.2 μs) |  |  |  |
| 125 V/µs                           | DLY_TARGET = 0x8 (1.8 μs) |  |  |  |
| 50 V/µs                            | DLY_TARGET = 0xB (2.4 µs) |  |  |  |
| 25 V/µs                            | DLY_TARGET = 0xF (3.2 µs) |  |  |  |

# 表 8-6. Delay Target Recommendation

## 8.3.10 Pin Diagrams

This section presents the I/O structure of all digital input and output pins.

#### 8.3.10.1 Logic Level Input Pin (Internal Pulldown)

⊠ 8-22 shows the input structure for the logic level pins, DRVOFF, INHx, INLx, nSLEEP, SCLK and SDI. The input can be with a voltage or external resistor. It is recommended to put these pins low in device sleep mode to reduce leakage current through internal pull-down resistors.

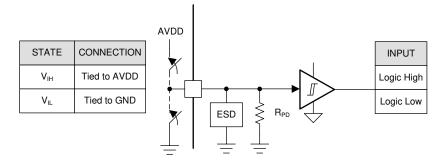
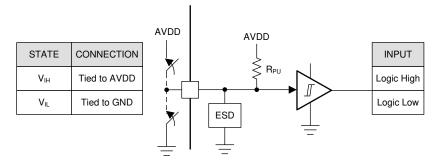


図 8-22. Logic-Level Input Pin Structure

# 8.3.10.2 Logic Level Input Pin (Internal Pullup)

⊠ 8-23 shows the input structure for the logic level pin, nSCS. The input can be driven with a voltage or external resistor.

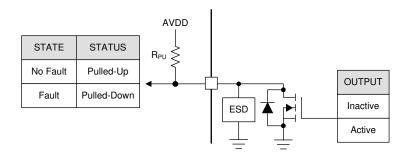


🛛 8-23. Logic nSCC

# 8.3.10.3 Open Drain Pin

⊠ 8-24 shows the structure of the open-drain output pin, nFAULT. The open-drain output requires an external pullup resistor to function properly.

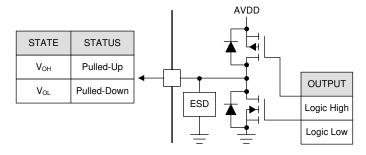






# 8.3.10.4 Push Pull Pin

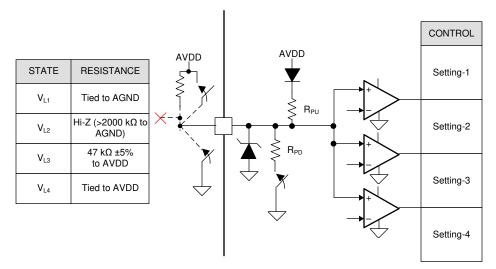
⊠ 8-25 shows the structure of push-pull pin, SDO.





# 8.3.10.5 Four Level Input Pin

⊠ 8-26 shows the structure of the four level input pins, GAIN, MODE, SLEW, OCP/SR and VSEL\_BK on hardware interface devices. The input can be set with an external resistor.







#### 8.3.11 Current Sense Amplifiers

The DRV8316-Q1 integrates three, high-performance low-side current sense amplifiers for current measurements using built-in current sensing. Low-side current measurements are commonly used to implement overcurrent protection, external torque control, or brushless-DC commutation with an external controller. All three amplifiers can be used to sense the current in each of the half-bridge legs (low-side FETs). The current sense amplifiers include features such as programmable gain and external reference is provided on a voltage reference pin (VREF).

### 8.3.11.1 Current Sense Amplifier Operation

The SOx pin on the DRV8316-Q1 outputs an analog voltage proportional to current flowing in the low side FETs multiplied by the gain setting ( $G_{CSA}$ ). The gain setting is adjustable between four different levels which can be set by the GAIN pin (in hardware device variant) or the GAIN bits (in SPI device variant).

⊠ 8-27 shows the internal architecture of the current sense amplifiers. The current sense is implemented with the sense FET on each low-side FET of the DRV8316-Q1 device. This current information is fed to the interal I/V converter, which generates the CSA output voltage on the SOX pin based on the voltage on VREF pin and the Gain setting. The CSA output voltage can be calculated as :

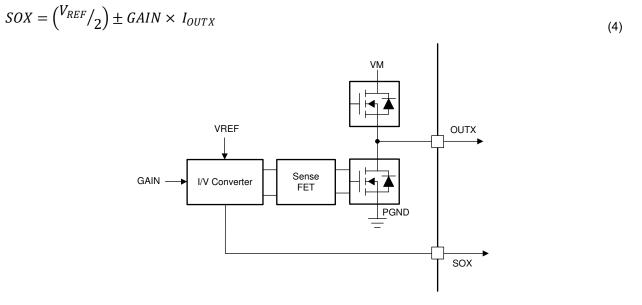
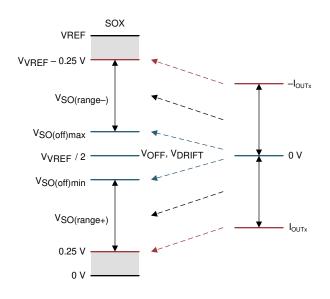


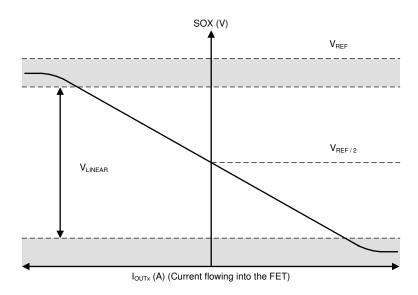
図 8-27. Integrated Current Sense Amplifier



 $\boxtimes$  8-28 and  $\boxtimes$  8-29 show the detail of the amplifier operational range. In bi-directional operation, the amplifier output for 0-V input is set at VREF / 2. Any change in the differential input results in a corresponding change in the output times the CSA\_GAIN factor. The amplifier has a defined linear region in which it can maintain operation.



# 🛛 8-28. Bidirectional Current Sense Output



## **8-29.** Bidirectional Current Sense Regions



#### 8.3.12 Current Sense Amplifier Offset Correction

CSA output has an offset induced due to ground differences between the sense FET and output FET. When running trapezoidal control or another single-shunt based control (sensored sine, for example) this CSA offset has no impact to operation. When running sensorless sinusoidal or FOC control where two or three current sense are required, some current distortion and noise may occur unless the user implements the corrective action below.

**Corrective Action**: Implement the below equations in firmware to correct for any current induced offset:

1. When all three current sense amplifiers are used:

|    |    | $i_a = 0.995832^* i_{a\_sensed} - 0.028199^* i_{b\_sensed} - 0.014988^* i_{c\_sensed}$          | (5)  |
|----|----|-------------------------------------------------------------------------------------------------|------|
|    |    | $i_b = 0.037737^* i_{a_{sensed}} + 1.007723^* i_{b\_sensed} - 0.033757^* i_{c\_sensed}$         | (6)  |
|    |    | $i_c = 0.009226*i_{a_{sensed}} + 0.029805*i_{b_{sensed}} + 1.003268*i_{c_{sensed}}$             | (7)  |
| 2. |    | nen only two of the three current sense amplifiers are used:<br>Current sensed in phases A & B: |      |
|    |    | $i_a = 1.013075^* i_{a\_sensed} - 0.01236^* i_{b\_sensed}$                                      | (8)  |
|    |    | $i_a = 1.013075^* i_{a\_sensed} - 0.01236^* i_{b\_sensed}$                                      | (9)  |
|    |    | $i_c = -(i_a + i_b)$                                                                            | (10) |
|    | b. | Current sensed in phases B & C:                                                                 |      |
|    |    | $i_b = 0.971197^* i_{b\_sensed} - 0.0683^* i_{c\_sensed}$                                       | (11) |
|    |    | $i_c = 0.020876^* i_{b_{sensed}} + 0.994823^* i_{c\_sensed}$                                    | (12) |
|    |    | $i_a = -(i_b + i_c)$                                                                            | (13) |
|    | c. | Current sensed in phases C & A:                                                                 |      |
|    |    | $i_a = 1.025489^* i_{a_{sensed}} + 0.011936^* i_{c_{sensed}}$                                   | (14) |
|    |    | $i_c = 0.022043^* i_{a_{sensed}} + 0.996548^* i_{c_sensed}$                                     | (15) |
|    |    | $i_b = -(i_a + i_c)$                                                                            | (16) |

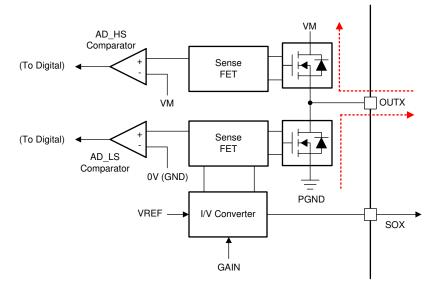


#### 8.3.13 Active Demagnetization

DRV8316-Q1 family of devices has smart rectification features (active demagnetization) which reduces power losses in device by reducing diode conduction losses. When this feature is enabled device automatically turns ON FET whenever it detects diode conduction. This feature can be configured with the OCP/SR pins in hardware variants. In SPI device variants this can be configured through EN\_ASR and EN\_AAR bits. The smart rectification is classified into two categories of automatic synchronous rectification (ASR) mode and automatic asynchronous rectification (AAR) mode which are described in sections below.

Note In SPI device variants both bits, EN\_ASR and EN\_AAR needs to set to 1 to enable active demagnetization.

The DRV8316-Q1 device includes a high-side (AD\_HS) and low-side (AD\_LS) comparator which detects the negative flow of current in the device on each half-bridge. The AD\_HS comparator compares the sense-FET output with the supply voltage (VM) threshold, whereas the AD\_LS compatator compares with the ground (0-V) threshold. Depending upon the flow of current from OUTx to VM or PGND to OUTx, the AD\_HS or the AD\_LS comparator trips. This comparator provides a reference point for the operation of active demagnetization feature.



#### **図** 8-30. Active Demagnetization Operation

#### $\pm$ 8-7 shows the configuration of ASR and AAR mode in the DRV8316-Q1 device.

| MODE Type | OCP/SR Pin (Hardware<br>Variant)             | SR Bits (SPI Variant)  | OCP Setting | ASR and AAR Mode     |
|-----------|----------------------------------------------|------------------------|-------------|----------------------|
| Mode 1    | Connected to AGND                            | EN_ASR = 0, EN_AAR = 0 | 16 A        | ASR and AAR Disabled |
| Mode 2    | Connected to AGND with<br>R <sub>MODE1</sub> | EN_ASR = 0, EN_AAR = 0 | 24 A        | ASR and AAR Disabled |
| Mode 3    | Hi-Z                                         | EN_ASR = 1, EN_AAR = 1 | 16 A        | ASR and AAR Enabled  |
| Mode 4    | Connected to AVDD                            | EN_ASR = 1, EN_AAR = 1 | 24 A        | ASR and AAR Enabled  |



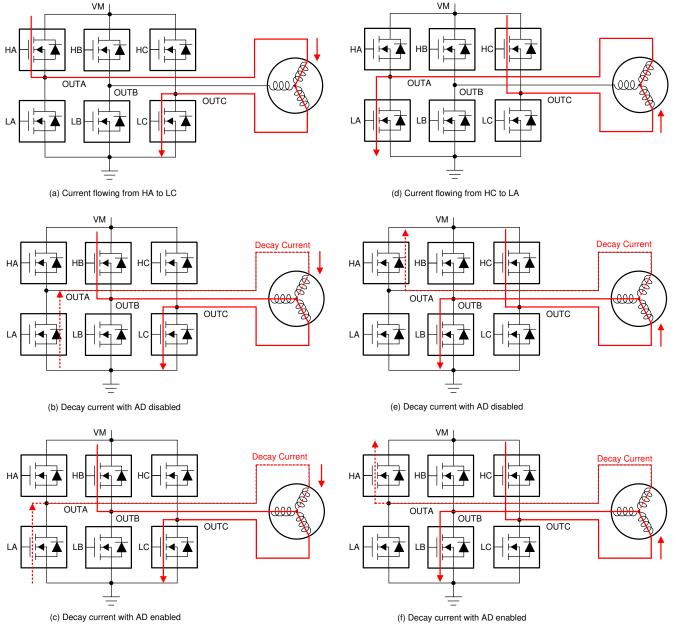
## 8.3.13.1 Automatic Synchronous Rectification Mode (ASR Mode)

The automatic synchronous rectification (ASR) mode is divided into two categories of ASR during commutation and ASR during PWM mode.

#### 8.3.13.1.1 Automatic Synchronous Rectification in Commutation

 $\boxtimes$  8-31 shows the operation of active demagnetization during the BLDC motor commutation. As shown in  $\boxtimes$  8-31 (a), the current is flowing from HA to LC in one commutation state. During the commutation changeover as shown in  $\boxtimes$  8-31 (b), the HC switch is turned on, whereas the commutation current (due to motor inductance) in OUTA flows through the body diode of LA. This incorporates a higher diode loss depending on the commutation current. This commutation loss is reduced by turning on the LA for the commutation time as shown in  $\boxtimes$  8-31 (c).

Similarly the operation of high-side FET is realized in  $\boxtimes$  8-31 (d), (e) and (f).

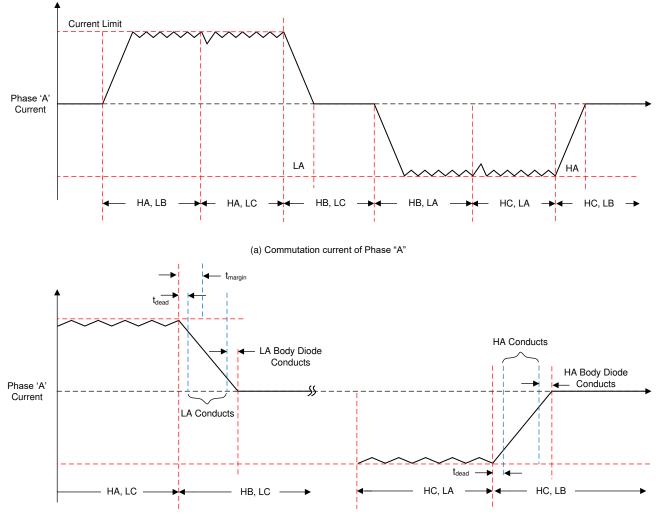






⊠ 8-32 (a) shows the BLDC motor phase current waveforms for automatic synchronous rectification mode in BLDC motor operating with trapezoidal commutation. This figure shows the operation of various switches in a single commutation cycle.

 $\boxtimes$  8-32 (b) shows the zoomed waveform of commutation cycle with details on the ASR mode start with margin time (t<sub>margin</sub>) and ASR mode early stop due to active demag. comparator threshold and delays.



(b) Zoomed waveform of Active Demagnetization

図 8-32. Current Waveforms for ASR in BLDC Motor Commutation



#### 8.3.13.1.2 Automatic Synchronous Rectification in PWM Mode

⊠ 8-33 shows the operation of ASR in PWM mode. As shown in this figure, a PWM is applied only on the highside FET, whereas the low-side FET is always off. During the PWM off time, current decays from the low-side FET which results in higher power losses. Therefore, this mode supports turning on the low-side FET during the low-side diode conduction.

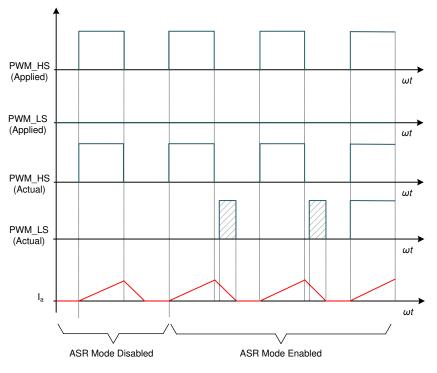
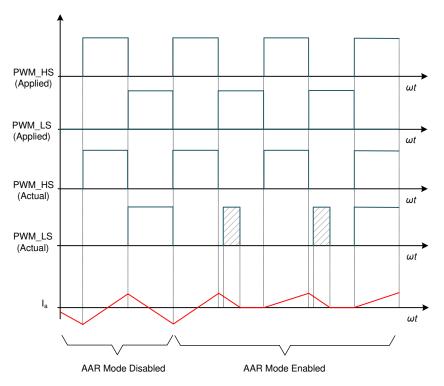


図 8-33. ASR in PWM Mode



### 8.3.13.2 Automatic Asynchronous Rectification Mode (AAR Mode)

⊠ 8-34 shows the operation of AAR in PWM mode. As shown in this figure, a PWM is applied in a synchronous rectification to the high-side and low-side FETs. During the low-side FET conduction, for lower inductance motors, the current can decay to zero and becomes negative since low side FET is in on-state. This creates a negative torque on the BLDC motor operation. When AAR mode is enabled, the current during the decay is monitored and the low-side FET is turned off as soon as the current reaches near to zero. This saves the negative current building in the BLDC motor which results in better noise performance and better thermal management.



🛛 8-34. AAR in PWM Mode



## 8.3.14 Cycle-by-Cycle Current Limit

The current-limit circuit activates if the current flowing through the low-side MOSFET exceeds the  $I_{LIMIT}$  current. This feature restricts motor current to less than the  $I_{LIMIT}$ .

The current-limit circuitry utilizes the current sense amplifier output of the three phases compared with the voltage at ILIM pin.  $\boxtimes$  8-35 shows the implementation of current limit circuitry. As shown in this figure, the output of current sense amplifiers is combined with star connected resistive network. This measured voltage V<sub>MEAS</sub> is compared with the external reference voltage e V<sub>ILIM</sub> pin to realize the current limit implementation. The relation between current sensed on OUTX pin and V<sub>MEAS</sub> threshold is given as:

$$V_{MEAS} = {\binom{V_{AVDD}}{2}} - \left( (I_{OUTA} + I_{OUTB} + I_{OUTC}) \times GAIN/3 \right)$$
(17)

where

- AVDD is 3.3-V LDO output
- OUTX is current flowing into the low-side MOSFET
- GAIN is the CSA\_GAIN setting

The  $I_{\text{LIMIT}}$  threshold can be adjusted by configuring ILIM pin between AVDD/2 to (AVDD/2 - 0.4) V. AVDD/2 is minimum value and when it is applied on ILIM pin cycle by cycle current limit is disabled, whereas maximum threshold of 8A can be configured by applying (AVDD/2 - 0.4) V on ILIM pin.

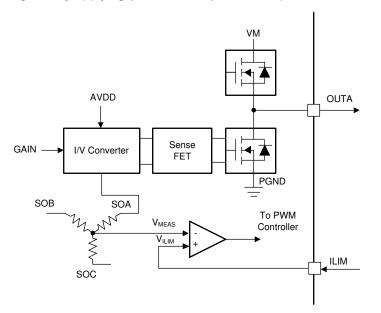
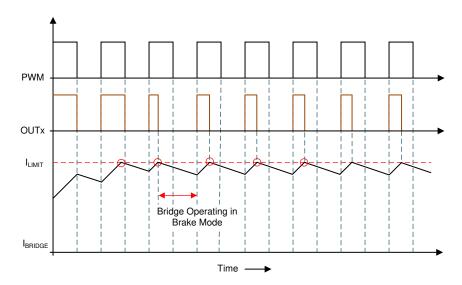


図 8-35. Current Limit Implementation

When then the current limit activates, the high-side FET is disabled until the beginning of the next PWM cycle as shown in  $\boxtimes$  8-36. The low-side FETs can operate in brake mode or high-Z mode by configuring the ILIM\_RECIR bit in the SPI device variant.

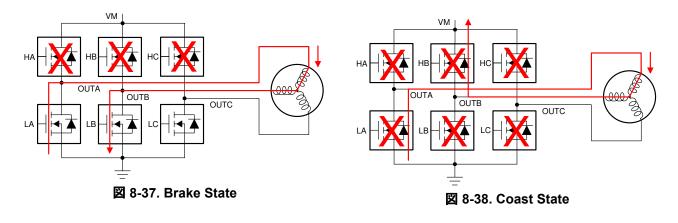




☑ 8-36. Cycle-by-Cycle Current-Limit Operation

⊠ 8-37 shows the operation of driver in brake mode, where the current recirculates through low-side FETs while the high-side FETs are disabled.

⊠ 8-38 shows the operation of driver in hi-Z mode, where the current recirculates through the body diodes of the low-side FETs while the high-side FETs are disabled.



#### Note

The current-limit circuit is ignored immediately after the PWM signal goes active for a short blanking time to prevent false trips of the current-limit circuit.

## Note

During the brake operation, a high-current can flow through the low-side FETs which can eventually trigger the over current protection circuit. This allows the body-diode of the high-side FET to conduct and pump brake energy to the VM supply rail.

## 8.3.14.1 Cycle by Cycle Current Limit with 100% Duty Cycle Input

In case of 100% duty cycle applied on PWM input, there is no edge available to turn high-side FET back on. To overcome this problem, DRV8316-Q1 has built in internal PWM clock which is used to turn high-side FET back on once it is disabled after exceeding I<sub>LIMIT</sub> threshold. In SPI variant DRV8316R-Q1, this internal PWM clock can



be configured to either 20 kHz or 40 kHz through PWM\_100\_DUTY\_SEL. In H/W variant DRV8316T-Q1 PWM internal clock is set to 20 kHz. ⊠ 8-39 shows operation with 100 % duty cycle.

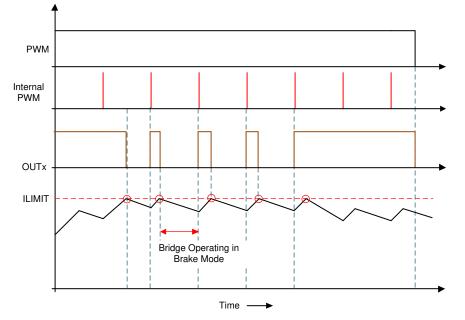


図 8-39. Cycle-by-Cycle Current-Limit Operation with 100% PWM Duty Cycle



# 8.3.15 Protections

The DRV8316-Q1 family of devices is protected against VM undervoltage, charge pump undervoltage, and overcurrent events.  $\frac{1}{2}$  8-8 summarizes various faults details.

| FAULT                                        | CONDITION                                | CONFIGURATION    | REPORT | H-BRIDGE | LOGIC    | RECOVERY                                                                                                  |  |  |
|----------------------------------------------|------------------------------------------|------------------|--------|----------|----------|-----------------------------------------------------------------------------------------------------------|--|--|
| VM undervoltage<br>(NPOR)                    | V <sub>VM</sub> < V <sub>UVLO</sub>      | -                | _      | Hi-Z     | Disabled | Automatic:<br>V <sub>VM</sub> > V <sub>UVLO_R</sub><br>CLR_FLT, nSLEEP Reset Pulse (NPOR<br>bit)          |  |  |
| AVDD undervoltage<br>(NPOR)                  | V <sub>AVDD</sub> < V <sub>AVDD_UV</sub> | _                | nFAULT | Hi-Z     | Disabled | Automatic:<br>V <sub>AVDD</sub> > V <sub>AVDD</sub> _UV_R<br>CLR_FLT, nSLEEP Reset Pulse (NPOR<br>bit)    |  |  |
| Buck undervoltage<br>(BUCK_UV)               | V <sub>FB_BK</sub> < V <sub>BK_UV</sub>  | _                | nFAULT | Active   | Active   | Automatic:<br>V <sub>FB_BK</sub> > V <sub>BUCK_UV_R</sub><br>CLR_FLT, nSLEEP Reset Pulse<br>(BUCK_UV bit) |  |  |
| Charge pump<br>undervoltage<br>(VCP_UV)      | V <sub>CP</sub> < V <sub>CPUV</sub>      | _                | nFAULT | Hi-Z     | Active   | Automatic:<br>V <sub>VCP</sub> > V <sub>CPUV</sub><br>CLR_FLT, nSLEEP Reset Pulse<br>(VCP_UV bit)         |  |  |
| 0                                            |                                          | OVP_EN = 0b      | None   | Active   | Active   | No action (OVP Disabled)                                                                                  |  |  |
| OverVoltage<br>Protection<br>(OVP)           | V <sub>VM</sub> > V <sub>OVP</sub>       | OVP_EN = 1b      | FAULT  | Hi-Z     | Active   | $\begin{tabular}{lllllllllllllllllllllllllllllllllll$                                                     |  |  |
|                                              |                                          | OCP_MODE = 00b   | nFAULT | Hi-Z     | Active   | Latched:<br>CLR_FLT, nSLEEP Reset Pulse (OCP<br>bits)                                                     |  |  |
| Overcurrent<br>Protection                    | I <sub>PHASE</sub> > I <sub>OCP</sub>    | OCP_MODE = 01b   | nFAULT | Hi-Z     | Active   | Retry:<br><sup>t</sup> RETRY                                                                              |  |  |
| (OCP)                                        |                                          | OCP_MODE = 10b   | nFAULT | Active   | Active   | Automatic:<br>CLR_FLT, nSLEEP Reset Pulse (OCP<br>bits)                                                   |  |  |
|                                              |                                          | OCP_MODE = 11b   | None   | Active   | Active   | No action                                                                                                 |  |  |
| Buck Overcurrent<br>Protection<br>(BUCK_OCP) | I <sub>BK</sub> > I <sub>BK_OC</sub>     | _                | nFAULT | Active   | Active   | Retry:<br><sup>t</sup> RETRY                                                                              |  |  |
| SPI Error<br>(SPI_FLT)                       | SCLK fault and ADDR<br>fault             | SPI_FLT_REP = 0b | nFAULT | Active   | Active   | Automatic:<br>CLR_FLT, nSLEEP Reset Pulse<br>(SPI_FLT bit)                                                |  |  |
|                                              |                                          | SPI_FLT_REP = 1b | None   | Active   | Active   | No action                                                                                                 |  |  |
| OTP Error<br>(OTP_ERR)                       | OTP reading is erroneous                 | _                | nFAULT | Hi-Z     | Active   | Latched:<br>Power Cycle, nSLEEP Reset Pulse                                                               |  |  |
|                                              |                                          | OTW_REP = 0b     | None   | Active   | Active   | No action                                                                                                 |  |  |
| Thermal warning<br>(OTW)                     | T <sub>J</sub> > T <sub>OTW</sub>        | OTW_REP = 1b     | nFAULT | Active   | Active   | Automatic:<br>T <sub>J</sub> < T <sub>OTW</sub> – T <sub>HYS</sub><br>CLR_FLT, nSLEEP Pulse (OTW bit)     |  |  |
| Thermal shutdown<br>(OTSD)                   | T <sub>J</sub> > T <sub>TSD</sub>        | _                | nFAULT | Hi-Z     | Active   | Automatic:<br>T <sub>J</sub> < T <sub>TSD</sub> – T <sub>TSD_HYS</sub><br>CLR_FLT, nSLEEP Pulse (OTS bit) |  |  |
| Thermal shutdown<br>(OTSD_FET)               | T <sub>J</sub> > T <sub>TSD_FET</sub>    | _                | nFAULT | Hi-Z     | Active   | Automatic:<br>TJ < T <sub>TSD_FET</sub> – T <sub>TSD_FET_HYS</sub><br>CLR_FLT, nSLEEP Pulse (OTS bit)     |  |  |

|  | 表 8-8. Fault | Action and | Response | (SPI Devices) |  |
|--|--------------|------------|----------|---------------|--|
|--|--------------|------------|----------|---------------|--|



## 8.3.15.1 VM Supply Undervoltage Lockout (NPOR)

If at any time the input supply voltage on the VM pin falls lower than the  $V_{UVLO}$  threshold (VM UVLO falling threshold), all of the integrated FETs, driver charge-pump and digital logic controller are disabled as shown in 8-40. Normal operation resumes (driver operation) when the VM undervoltage condition is removed. The NPOR bit is reset and latched low in the IC status (IC\_STAT) register once the device presumes VM. The NPOR bit remains in reset condition until cleared through the CLR\_FLT bit or an nSLEEP pin reset pulse (t<sub>RST</sub>).

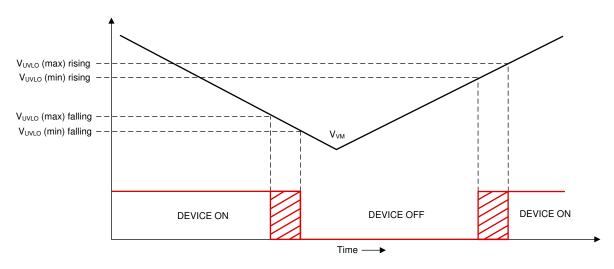


図 8-40. VM Supply Undervoltage Lockout

## 8.3.15.2 AVDD Undervoltage Lockout (AVDD\_UV)

If at any time the voltage on AVDD pin falls lower than the  $V_{AVDD_UV}$  threshold, all of the integrated FETs, driver charge-pump and digital logic controller are disabled. Normal operation resumes (driver operation) when the AVDD undervoltage condition is removed. The NPOR bit is reset and latched low in the IC status (IC\_STAT) register once the device presumes VM. The NPOR bit remains in reset condition until cleared through the CLR\_FLT bit or an nSLEEP pin reset pulse (t<sub>RST</sub>).

## 8.3.15.3 BUCK Undervoltage Lockout (BUCK\_UV)

If at any time the voltage on VFB\_BK pin falls lower than the  $V_{BK_UV}$  threshold, the integrated FETs of the buck regulator are disabled while the driver FETs, charge pump, and digital logic control continue to operate normally. The nFAULT pin is driven low in the event of a buck undervoltage fault, and the BK\_FLT bit in IC\_STAT register is set in SPI devices. The FAULT and BUCK\_UV bits are also latched high in the registers on SPI devices. Normal operation starts again (buck regulator operation and the nFAULT pin is released) when the BUCK undervoltage condition clears. The BK\_FLT and BUCK\_UV bits stay set until cleared through the CLR\_FLT bit or an nSLEEP pin reset pulse (t<sub>RST</sub>).

## 8.3.15.4 VCP Charge Pump Undervoltage Lockout (CPUV)

If at any time the voltage on the VCP pin (charge pump) falls lower than the  $V_{CPUV}$  threshold voltage of the charge pump, all of the integrated FETs are disabled and the nFAULT pin is driven low. The FAULT and VCP\_UV bits are also latched high in the registers on SPI devices. Normal operation starts again (driver operation and the nFAULT pin is released) when the VCP undervoltage condition clears. The CPUV bit stays set until cleared through the CLR\_FLT bit or an nSLEEP pin reset pulse (t<sub>RST</sub>). The CPUV protection is always enabled in both hardware and SPI device variants.

## 8.3.15.5 Overvoltage Protections (OV)

If at any time input supply voltage on the VM pins rises higher lower than the  $V_{OVP}$  threshold voltage, all of the integrated FETs are disabled and the nFAULT pin is driven low. The FAULT and OVP bits are also latched high in the registers on SPI devices. Normal operation starts again (driver operation and the nFAULT pin is released) when the OVP condition clears. The OVP bit stays set until cleared through the CLR\_FLT bit or an nSLEEP pin



reset pulse (t<sub>RST</sub>). Setting the OVP\_EN bit high on the SPI devices enables this protection feature. On hardware interface devices, the OVP protection is always enabled and set to a 34-V threshold.

The OVP threshold is also programmable on the SPI device variant. The OVP threshold can be set to 20-V or 32-V based on the OVP\_SEL bit.

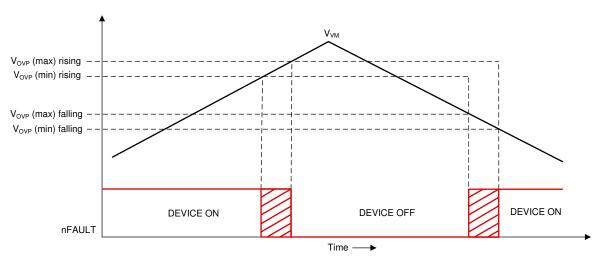


図 8-41. Over Voltage Protection

# 8.3.15.6 Overcurrent Protection (OCP)

A MOSFET overcurrent event is sensed by monitoring the current flowing through FETs. If the current across a FET exceeds the  $I_{OCP}$  threshold for longer than the  $t_{OCP}$  deglitch time, an OCP event is recognized and action is done according to the OCP\_MODE bit. On hardware interface devices, the  $I_{OCP}$  threshold is set via OCP/SR pin, the  $t_{OCP\_DEG}$  is fixed at 0.6-µs, and the OCP\_MODE bit is configured for latched shutdown. On SPI devices, the  $I_{OCP}$  threshold is set through the OCP\_LVL SPI register, the  $t_{OCP\_DEG}$  is set through the OCP\_DEG SPI register, and the OCP\_MODE bit can operate in four different modes: OCP latched shutdown, OCP automatic retry, OCP report only, and OCP disabled.

## 8.3.15.6.1 OCP Latched Shutdown (OCP\_MODE = 00b)

After a OCP event in this mode, all MOSFETs are disabled and the nFAULT pin is driven low. The FAULT, OCP, and corresponding FET's OCP bits are latched high in the SPI registers. Normal operation starts again (driver operation and the nFAULT pin is released) when the OCP condition clears and a clear faults command is issued either through the CLR\_FLT bit or an nSLEEP reset pulse (t<sub>RST</sub>).



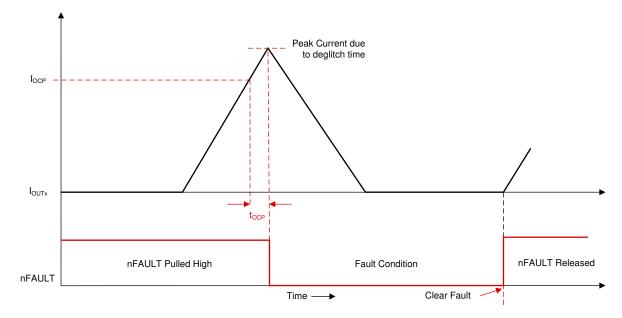
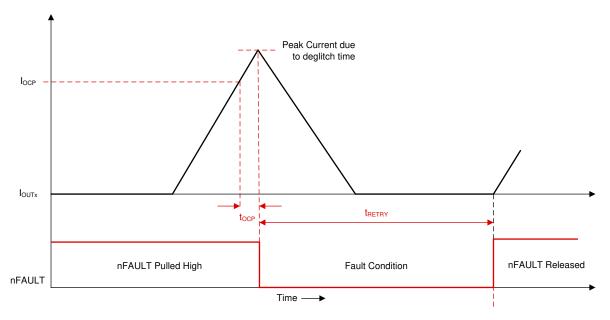
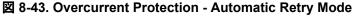


図 8-42. Overcurrent Protection - Latched Shutdown Mode

### 8.3.15.6.2 OCP Automatic Retry (OCP\_MODE = 01b)

After a OCP event in this mode, all the FETs are disabled and the nFAULT pin is driven low. The FAULT, OCP, and corresponding FET's OCP bits are latched high in the SPI registers. Normal operation starts again automatically (driver operation and the nFAULT pin is released) after the  $t_{RETRY}$  time elapses. After the  $t_{RETRY}$  time elapses, the FAULT, OCP, and corresponding FET's OCP bits stay latched until a clear faults command is issued either through the CLR\_FLT bit or an nSLEEP reset pulse ( $t_{RST}$ ).





## 8.3.15.6.3 OCP Report Only (OCP\_MODE = 10b)

No protective action occurs after a OCP event in this mode. The overcurrent event is reported by driving the nFAULT pin low and latching the FAULT, OCP, and corresponding FET's OCP bits high in the SPI registers. The DRV8316-Q1 continues to operate as usual. The external controller manages the overcurrent condition by acting



appropriately. The reporting clears (nFAULT pin is released) when the OCP condition clears and a clear faults command is issued either through the CLR\_FLT bit or an nSLEEP reset pulse (t<sub>RST</sub>).

#### 8.3.15.6.4 OCP Disabled (OCP\_MODE = 11b)

No action occurs after a OCP event in this mode.

## 8.3.15.7 Buck Overcurrent Protection

A buck overcurrent event is sensed by monitoring the current flowing through buck regulator's FETs. If the current across the buck regulator FET exceeds the  $I_{BK_OCP}$  threshold for longer than the  $t_{BK_OCP}$  deglitch time, an OCP event is recognized. The buck OCP mode is configured in automatic retry setting. In this setting, after a buck OCP event is detected, all the buck regulator's FETs are disabled and the nFAULT pin is driven low. The FAULT, BK\_FLT, and BUCK\_OCP bits are latched high in the SPI registers. Normal operation starts again automatically (driver operation and the nFAULT pin is released) after the  $t_{BK_RETRY}$  time elapses. The FAULT, BK\_FLT, and BUCK\_OCP bits stay latched until the  $t_{RETRY}$  period expires.

## 8.3.15.8 Thermal Warning (OTW)

If the die temperature exceeds the trip point of the thermal warning ( $T_{OTW}$ ), the OT bit in the IC status (IC\_STAT) register and OTW bit in the status register is set. The reporting of OTW on the nFAULT pin can be enabled by setting the over-temperature warning reporting (OTW\_REP) bit in the configuration control register. The device performs no additional action and continues to function. In this case, the nFAULT pin releases when the die temperature decreases below the hysteresis point of the thermal warning ( $T_{OTW_HYS}$ ). The OTW bit remains set until cleared through the CLR\_FLT bit or an nSLEEP reset pulse ( $t_{RST}$ ) and the die temperature is lower than thermal warning trip ( $T_{OTW}$ ).

#### Note

Over temperature warning is not reported on nFAULT pin by default.

## 8.3.15.9 Thermal Shutdown (OTS)

DRV8316-Q1 has 2 die temperature sensor for thermal shutdown, one of them near FETs and other one in other part of die.

#### 8.3.15.9.1 OTS FET

If the die temperature near FET exceeds the trip point of the thermal shutdown limit ( $T_{TSD_FET}$ ), all the FETs are disabled, the charge pump is shut down, and the nFAULT pin is driven low. In addition, the FAULT and OT bit in the IC status (IC\_STAT) register and OTS bit in the status register is set. Normal operation starts again (driver operation and the nFAULT pin is released) when the overtemperature condition clears. The OTS bit stays latched high indicating that a thermal event occurred until a clear fault command is issued either through the CLR\_FLT bit or an nSLEEP reset pulse ( $t_{RST}$ ). This protection feature cannot be disabled.

#### 8.3.15.9.2 OTS (Non FET)

If the die temperature in the device exceeds the trip point of the thermal shutdown limit ( $T_{TSD}$ ), all the FETs are disabled, the buck regulator disabled, the charge pump is shut down, and the nFAULT pin is driven low. In addition, the FAULT and OT bit in the IC status (IC\_STAT) register and OTS bit in the status register is set. Normal operation starts again (driver operation and the nFAULT pin is released) when the overtemperature condition clears. The OTS bit stays latched high indicating that a thermal event occurred until a clear fault command is issued either through the CLR\_FLT bit or an nSLEEP reset pulse ( $t_{RST}$ ). This protection feature cannot be disabled.



#### DRV8316-Q1 JAJSN64 – JANUARY 2022

# 8.4 Device Functional Modes

# 8.4.1 Functional Modes

## 8.4.1.1 Sleep Mode

The nSLEEP pin manages the state of the DRV8316-Q1 family of devices. When the nSLEEP pin is low, the device goes to a low-power sleep mode. In sleep mode, all FETs are disabled, sense amplifiers are disabled, buck regulator (if present) is disabled, the charge pump is disabled, the AVDD regulator is disabled, and the SPI bus is disabled. The  $t_{SLEEP}$  time must elapse after a falling edge on the nSLEEP pin before the device goes to sleep mode. The device comes out of sleep mode automatically if the nSLEEP pin is pulled high. The  $t_{WAKE}$  time must elapse before the device is ready for inputs.

In sleep mode and when  $V_{VM} < V_{UVLO}$ , all MOSFETs are disabled.

#### Note

During power up and power down of the device through the nSLEEP pin, the nFAULT pin is held low as the internal regulators are enabled or disabled. After the regulators have enabled or disabled, the nFAULT pin is automatically released. The duration that the nFAULT pin is low does not exceed the  $t_{SLEEP}$  or  $t_{WAKE}$  time.

## 8.4.1.2 Operating Mode

When the nSLEEP pin is high and the  $V_{VM}$  voltage is greater than the  $V_{UVLO}$  voltage, the device goes to operating mode. The  $t_{WAKE}$  time must elapse before the device is ready for inputs. In this mode the charge pump, AVDD regulator, buck regulator, and SPI bus are active.

## 8.4.1.3 Fault Reset (CLR\_FLT or nSLEEP Reset Pulse)

In the case of device latched faults, the DRV8316-Q1 family of devices goes to a partial shutdown state to help protect the power MOSFETs and system.

When the fault condition clears, the device can go to the operating state again by either setting the CLR\_FLT SPI bit on SPI devices or issuing a reset pulse to the nSLEEP pin on either interface variant. The nSLEEP reset pulse ( $t_{RST}$ ) consists of a high-to-low-to-high transition on the nSLEEP pin. The low period of the sequence should fall with the  $t_{RST}$  time window or else the device will start the complete shutdown sequence. The reset pulse has no effect on any of the regulators, device settings, or other functional blocks.

## 8.4.2 DRVOFF functionality

DRV8316-Q1 has capability to disable predriver and MOSFETs bypassing the digital through DRVOFF pin. When DRVOFF pin is pulled high, all six MOSFETs are disabled. If nSLEEP is high when the DRVOFF pin is high, the charge pump, AVDD regulator, buck regulator, and SPI bus are active and any driver-related faults such as OCP will be inactive. DRVOFF pin independently disables MOSFETs which will stop motor commutation irrespective of status of INHx and INLx input pins.

Note

DRVOFF pin independently disables MOSFET, it may trigger fault condition resulting in nFAULT getting pulled low.



# 8.5 SPI Communication

## 8.5.1 Programming

On DRV8316-Q1 SPI devices, an SPI bus is used to set device configurations, operating parameters, and read out diagnostic information. The SPI operates in slave mode and connects to a master controller. The SPI input data (SDI) word consists of a 16-bit word, with a 6-bit address and 8 bits of data. The SPI output consists of 16 bit word, with a 8 bits of status information (STAT register) and 8-bit register data.

A valid frame must meet the following conditions:

- The SCLK pin should be low when the nSCS pin transitions from high to low and from low to high.
- The nSCS pin should be pulled high for at least 400 ns between words.
- When the nSCS pin is pulled high, any signals at the SCLK and SDI pins are ignored and the SDO pin is placed in the Hi-Z state.
- Data is captured on the falling edge of the SCLK pin and data is propagated on the rising edge of the SCLK pin.
- The most significant bit (MSB) is shifted in and out first.
- A full 16 SCLK cycles must occur for transaction to be valid.
- If the data word sent to the SDI pin is less than or more than 16 bits, a frame error occurs and the data word is ignored.
- For a write command, the existing data in the register being written to is shifted out on the SDO pin following the 8-bit status data.

The SPI registers are reset to the default settings on power up and when the device is enters sleep mode

## 8.5.1.1 SPI Format

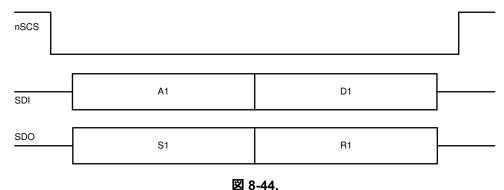
The SDI input data word is 16 bits long and consists of the following format:

- 1 read or write bit, W (bit B15)
- 6 address bits, A (bits B14 through B9)
- Parity bit, P (bit B8)
- 8 data bits, D (bits B7 through B0)

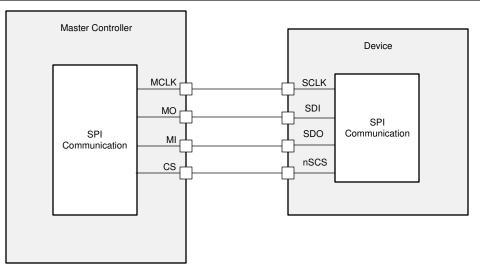
The SDO output data word is 16 bits long and the first 8 bits are status bits. The data word is the content of the register being accessed.

For a write command (W0 = 0), the response word on the SDO pin is the data currently in the register being written to.

For a read command (W0 = 1), the response word is the data currently in the register being read.



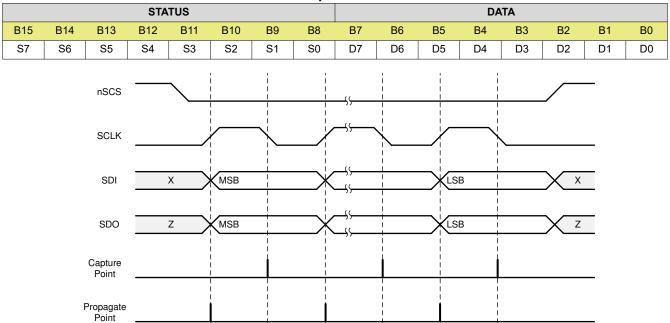






#### 表 8-9. SDI Input Data Word Format

| R/W |     | ADDRESS |     |     |     |    | Parity |    |    |    | DA | TA |    |    |    |
|-----|-----|---------|-----|-----|-----|----|--------|----|----|----|----|----|----|----|----|
| B15 | B14 | B13     | B12 | B11 | B10 | B9 | B8     | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 |
| W0  | A5  | A4      | A3  | A2  | A1  | A0 | Р      | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |



## 表 8-10. SDO Output Data Word Format





# 8.6 Register Map

## 8.6.1 STATUS Registers

STATUS Registers lists the memory-mapped registers for the STATUS registers. All register offset addresses not listed in STATUS Registers should be considered as reserved locations and the register contents should not be modified.

|        | 表 8-11. STATUS Registers             |                    |               |  |  |  |  |  |  |  |
|--------|--------------------------------------|--------------------|---------------|--|--|--|--|--|--|--|
| Offset | Offset Acronym Register Name Section |                    |               |  |  |  |  |  |  |  |
| 0h     | IC_Status_Register                   | IC Status Register | セクション 8.6.1.1 |  |  |  |  |  |  |  |
| 1h     | Status_Register_1                    | Status Register 1  | セクション 8.6.1.2 |  |  |  |  |  |  |  |
| 2h     | Status_Register_2                    | Status Register 2  | セクション 8.6.1.3 |  |  |  |  |  |  |  |

Complex bit access types are encoded to fit into small table cells. STATUS Access Type Codes shows the codes that are used for access types in this section.

| Access Type     | Code                   | Description                            |  |  |  |  |
|-----------------|------------------------|----------------------------------------|--|--|--|--|
| Read Type       |                        |                                        |  |  |  |  |
| R               | R                      | Read                                   |  |  |  |  |
| R-0             | R<br>-0                | Read<br>Returns 0s                     |  |  |  |  |
| Reset or Defaul | Reset or Default Value |                                        |  |  |  |  |
| -n              |                        | Value after reset or the default value |  |  |  |  |

## 表 8-12. STATUS Access Type Codes



# 8.6.1.1 IC\_Status\_Register Register (Offset = 0h) [Reset = 00h]

IC\_Status\_Register is shown in IC\_Status\_Register Register and described in IC\_Status\_Register Field Descriptions.

#### Return to the STATUS Registers.

| 図 8-47. IC_Status_Register Register |        |         |      |      |      |      |       |  |  |  |
|-------------------------------------|--------|---------|------|------|------|------|-------|--|--|--|
| 7                                   | 6      | 5       | 4    | 3    | 2    | 1    | 0     |  |  |  |
|                                     | BK_FLT | SPI_FLT | OCP  | NPOR | OVP  | OT   | FAULT |  |  |  |
|                                     | R-0h   | R-0h    | R-0h | R-0h | R-0h | R-0h | R-0h  |  |  |  |

| Bit | Field   | Туре | Reset | Description                                                                                                                                       |
|-----|---------|------|-------|---------------------------------------------------------------------------------------------------------------------------------------------------|
| 6   | BK_FLT  | R    | Oh    | Buck Fault Bit<br>0h = No buck regulator fault condition is detected<br>1h = Buck regulator fault condition is detected                           |
| 5   | SPI_FLT | R    | Oh    | SPI Fault Bit<br>0h = No SPI fault condition is detected<br>1h = SPI Fault condition is detected                                                  |
| 4   | OCP     | R    | Oh    | Over Current Protection Status Bit<br>0h = No overcurrent condition is detected<br>1h = Overcurrent condition is detected                         |
| 3   | NPOR    | R    | Oh    | Supply Power On Reset Bit<br>0h = Power on reset condition is detected on VM<br>1h = No power-on-reset condition is detected on VM                |
| 2   | OVP     | R    | Oh    | Supply Overvoltage Protection Status Bit<br>0h = No overvoltage condition is detected on VM<br>1h = Overvoltage condition is detected on VM       |
| 1   | ОТ      | R    | Oh    | Overtemperature Fault Status Bit<br>0h = No overtemperature warning / shutdown is detected<br>1h = Overtemperature warning / shutdown is detected |
| 0   | FAULT   | R    | Oh    | Device Fault Bit<br>0h = No fault condition is detected<br>1h = Fault condition is detected                                                       |

## 表 8-13. IC\_Status\_Register Register Field Descriptions

## 8.6.1.2 Status\_Register\_1 Register (Offset = 1h) [Reset = 00h]

Status\_Register\_1 is shown in Status\_Register\_1 Register and described in Status\_Register\_1 Register Field Descriptions.

#### Return to the STATUS Registers.

| 図 8-48. Status_Register_1 Register |      |        |        |        |        |        |        |  |  |
|------------------------------------|------|--------|--------|--------|--------|--------|--------|--|--|
| 7                                  | 6    | 5      | 4      | 3      | 2      | 1      | 0      |  |  |
| OTW                                | OTS  | OCP_HC | OCL_LC | OCP_HB | OCP_LB | OCP_HA | OCP_LA |  |  |
| R-0h                               | R-0h | R-0h   | R-0h   | R-0h   | R-0h   | R-0h   | R-0h   |  |  |

| Bit | Field  | Туре | Reset | Description                                                                                                                                                         |  |  |  |  |
|-----|--------|------|-------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------|--|--|--|--|
| 7   | OTW    | R    | 0h    | Overtemperature Warning Status Bit<br>0h = No overtemperature warning is detected<br>1h = Overtemperature warning is detected                                       |  |  |  |  |
| 6   | OTS    | R    | Oh    | Overtemperature Shutdown Status Bit<br>0h = No overtemperature shutdown is detected<br>1h = Overtemperature shutdown is detected                                    |  |  |  |  |
| 5   | OCP_HC | R    | Oh    | Overcurrent Status on High-side switch of OUTC<br>0h = No overcurrent detected on high-side switch of OUTC<br>1h = Overcurrent detected on high-side switch of OUTC |  |  |  |  |
| 4   | OCL_LC | R    | Oh    | Overcurrent Status on Low-side switch of OUTC<br>0h = No overcurrent detected on low-side switch of OUTC<br>1h = Overcurrent detected on low-side switch of OUTC    |  |  |  |  |
| 3   | OCP_HB | R    | Oh    | Overcurrent Status on High-side switch of OUTB<br>0h = No overcurrent detected on high-side switch of OUTB<br>1h = Overcurrent detected on high-side switch of OUTB |  |  |  |  |
| 2   | OCP_LB | R    | Oh    | Overcurrent Status on Low-side switch of OUTB<br>0h = No overcurrent detected on low-side switch of OUTB<br>1h = Overcurrent detected on low-side switch of OUTB    |  |  |  |  |
| 1   | OCP_HA | R    | Oh    | Overcurrent Status on High-side switch of OUTA<br>0h = No overcurrent detected on high-side switch of OUTA<br>1h = Overcurrent detected on high-side switch of OUTA |  |  |  |  |
| 0   | OCP_LA | R    | Oh    | Overcurrent Status on Low-side switch of OUTA<br>0h = No overcurrent detected on low-side switch of OUTA<br>1h = Overcurrent detected on low-side switch of OUTA    |  |  |  |  |

### 表 8-14. Status Register 1 Register Field Descriptions



## 8.6.1.3 Status\_Register\_2 Register (Offset = 2h) [Reset = 00h]

Status\_Register\_2 is shown in Status\_Register\_2 Register and described in Status\_Register\_2 Register Field Descriptions.

#### Return to the STATUS Registers.

| 図 8-49. Status_Register_2 Register |         |          |         |        |            |              |                  |
|------------------------------------|---------|----------|---------|--------|------------|--------------|------------------|
| 7                                  | 6       | 5        | 4       | 3      | 2          | 1            | 0                |
| RESERVED                           | OTP_ERR | BUCK_OCP | BUCK_UV | VCP_UV | SPI_PARITY | SPI_SCLK_FLT | SPI_ADDR_FL<br>T |
| R-0-0h                             | R-0h    | R-0h     | R-0h    | R-0h   | R-0-0h     | R-0h         | R-0h             |

# 表 8-15. Status Register 2 Register Field Descriptions

| Bit | Field        | Туре | Reset | Description                                                                                                                                  |  |  |  |
|-----|--------------|------|-------|----------------------------------------------------------------------------------------------------------------------------------------------|--|--|--|
| 7   | RESERVED     | R-0  | 0h    | Reserved                                                                                                                                     |  |  |  |
| 6   | OTP_ERR      | R    | Oh    | One Time Programmabilty Error<br>0h = No OTP error is detected<br>1h = OTP Error is detected                                                 |  |  |  |
| 5   | BUCK_OCP     | R    | Oh    | Buck Regulator Overcurrent Staus Bit<br>0h = No buck regulator overcurrent is detected<br>1h = Buck regulator overcurrent is detected        |  |  |  |
| 4   | BUCK_UV      | R    | Oh    | Buck Regulator Undervoltage Staus Bit<br>0h = No buck regulator undervoltage is detected<br>1h = Buck regulator undervoltage is detected     |  |  |  |
| 3   | VCP_UV       | R    | Oh    | Charge Pump Undervoltage Status Bit<br>0h = No charge pump undervoltage is detected<br>1h = Charge pump undervoltage is detected             |  |  |  |
| 2   | SPI_PARITY   | R-0  | Oh    | SPI Parity Error Bit<br>0h = No SPI parity error is detected<br>1h = SPI parity error is detected                                            |  |  |  |
| 1   | SPI_SCLK_FLT | R    | Oh    | SPI Clock Framing Error Bit<br>0h = No SPI clock framing error is detected<br>1h = SPI clock framing error is detected                       |  |  |  |
| 0   | SPI_ADDR_FLT | R    | Oh    | SPI Address Error Bit<br>0h = No SPI address fault is detected (due to accessing non-user<br>register)<br>1h = SPI address fault is detected |  |  |  |



## 8.6.2 CONTROL Registers

CONTROL Registers lists the memory-mapped registers for the CONTROL registers. All register offset addresses not listed in CONTROL Registers should be considered as reserved locations and the register contents should not be modified.

| 表 8-16. CONTROL Registers |                     |                     |               |  |  |
|---------------------------|---------------------|---------------------|---------------|--|--|
| Offset                    | Acronym             | Register Name       | Section       |  |  |
| 3h                        | Control_Register_1  | Control Register 1  | セクション 8.6.2.1 |  |  |
| 4h                        | Control_Register_2  | Control Register 2  | セクション 8.6.2.2 |  |  |
| 5h                        | Control_Register_3  | Control Register 3  | セクション 8.6.2.3 |  |  |
| 6h                        | Control_Register_4  | Control Register 4  | セクション 8.6.2.4 |  |  |
| 7h                        | Control_Register_5  | Control Register 5  | セクション 8.6.2.5 |  |  |
| 8h                        | Control_Register_6  | Control Register 6  | セクション 8.6.2.6 |  |  |
| Ch                        | Control_Register_10 | Control Register 10 | セクション 8.6.2.7 |  |  |

# Complex bit access types are encoded to fit into small table cells. CONTROL Access Type Codes shows the codes that are used for access types in this section.

|                | 2 0-11. OONTROE Access Type Oodes |                                               |  |  |  |  |
|----------------|-----------------------------------|-----------------------------------------------|--|--|--|--|
| Access Type    | Code                              | Description                                   |  |  |  |  |
| Read Type      |                                   |                                               |  |  |  |  |
| R              | R                                 | Read                                          |  |  |  |  |
| R-0            | R<br>-0                           | Read<br>Returns 0s                            |  |  |  |  |
| Write Type     |                                   |                                               |  |  |  |  |
| W              | W                                 | Write                                         |  |  |  |  |
| W1C            | W<br>1C                           | Write<br>1 to clear                           |  |  |  |  |
| WAPU           | W<br>APU                          | Write<br>Atomic write with password<br>unlock |  |  |  |  |
| Reset or Defau | It Value                          |                                               |  |  |  |  |
| -n             |                                   | Value after reset or the default value        |  |  |  |  |



## 8.6.2.1 Control\_Register\_1 Register (Offset = 3h) [Reset = 00h]

Control\_Register\_1 is shown in Control\_Register\_1 Register and described in Control\_Register\_1 Register Field Descriptions.

#### Return to the CONTROL Registers.

| 図 8-50. Control_Register_1 Register |   |   |   |   |   |           |   |
|-------------------------------------|---|---|---|---|---|-----------|---|
| 7                                   | 6 | 5 | 4 | 3 | 2 | 1         | 0 |
| RESERVED                            |   |   |   |   |   | REG_LOCK  |   |
| R-0-0h                              |   |   |   |   |   | R/WAPU-0h |   |

| Bit | Field    | Туре   | Reset | Description                                                                                                                                                                                                                                                                                                                                                                                                                                |
|-----|----------|--------|-------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7-3 | RESERVED | R-0    | 0h    | Reserved                                                                                                                                                                                                                                                                                                                                                                                                                                   |
| 2-0 | REG_LOCK | R/WAPU | 0h    | Register Lock Bits<br>Oh = No effect unless locked or unlocked<br>1h = No effect unless locked or unlocked<br>2h = No effect unless locked or unlocked<br>3h = Write 011b to this register to unlock all registers<br>4h = No effect unless locked or unlocked<br>5h = No effect unless locked or unlocked<br>6h = Write 110b to lock the settings by ignoring further register writes<br>except to these bits and address 0x03h bits 2-0. |
|     |          |        |       |                                                                                                                                                                                                                                                                                                                                                                                                                                            |

# 表 8-18. Control\_Register\_1 Register Field Descriptions

# 8.6.2.2 Control\_Register\_2 Register (Offset = 4h) [Reset = 60h]

Control\_Register\_2 is shown in Control\_Register\_2 Register and described in Control\_Register\_2 Register Field Descriptions.

#### Return to the CONTROL Registers.

| 図 8-51. Control_Register_2 Register |       |          |     |      |       |      |         |
|-------------------------------------|-------|----------|-----|------|-------|------|---------|
| 7                                   | 6     | 5        | 4   | 3    | 2     | 1    | 0       |
| RES                                 | ERVED | SDO_MODE | SLE | W    | PWM_I | NODE | CLR_FLT |
| R/                                  | W-1h  | R/W-1h   | R/W | '-0h | R/W   | -0h  | W1C-0h  |

| Bit | Field    | Туре | Reset | Description                                                                                                                                         |
|-----|----------|------|-------|-----------------------------------------------------------------------------------------------------------------------------------------------------|
| 7-6 | RESERVED | R/W  | 1h    | Reserved                                                                                                                                            |
| 5   | SDO_MODE | R/W  | 1h    | SDO Mode Setting<br>0h = SDO IO in Open Drain Mode<br>1h = SDO IO in Push Pull Mode                                                                 |
| 4-3 | SLEW     | R/W  | 0h    | Slew Rate Settings<br>0h = Slew rate is 25 V/μs<br>1h = Slew rate is 50 V/μs<br>2h = Slew rate is 125 V/μs<br>3h = Slew rate is 200 V/μs            |
| 2-1 | PWM_MODE | R/W  | 0h    | Device Mode Selection<br>0h = 6x mode<br>1h = 6x mode with current limit<br>2h = 3x mode<br>3h = 3x mode with current limit                         |
| 0   | CLR_FLT  | W1C  | 0h    | Clear Fault<br>Oh = No clear fault command is issued<br>1h = To clear the latched fault bits. This bit automatically resets after<br>being written. |

## 表 8-19. Control\_Register\_2 Register Field Descriptions



## 8.6.2.3 Control\_Register\_3 Register (Offset = 5h) [Reset = 46h]

Control\_Register\_3 is shown in Control\_Register\_3 Register and described in Control\_Register\_3 Register Field Descriptions.

#### Return to the CONTROL Registers.

| 図 8-52. Control_Register_3 Register |          |          |                      |         |        |          |         |
|-------------------------------------|----------|----------|----------------------|---------|--------|----------|---------|
| 7                                   | 6        | 5        | 4                    | 3       | 2      | 1        | 0       |
| RESERVED                            | RESERVED | RESERVED | PWM_100_DU<br>TY_SEL | OVP_SEL | OVP_EN | RESERVED | OTW_REP |
| R-0-0h                              | R/W-1h   | R/W-0h   | R/W-0h               | R/W-0h  | R/W-1h | R/W-1h   | R/W-0h  |

| Bit | Field            | Туре | Reset | Description                                                                                                                                            |
|-----|------------------|------|-------|--------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7   | RESERVED         | R-0  | 0h    | Reserved                                                                                                                                               |
| 6   | RESERVED         | R/W  | 1h    | Reserved                                                                                                                                               |
| 5   | RESERVED         | R/W  | 0h    | Reserved                                                                                                                                               |
| 4   | PWM_100_DUTY_SEL | R/W  | Oh    | Freqency of PWM at 100% Duty Cycle<br>0h = 20KHz<br>1h = 40KHz                                                                                         |
| 3   | OVP_SEL          | R/W  | Oh    | Overvoltage Level Setting<br>0h = VM overvoltage level is 34-V<br>1h = VM overvoltage level is 22-V                                                    |
| 2   | OVP_EN           | R/W  | 1h    | Overvoltage Enable Bit<br>0h = Overvoltage protection is disabled<br>1h = Overvoltage protection is enabled                                            |
| 1   | RESERVED         | R/W  | 1h    | Reserved                                                                                                                                               |
| 0   | OTW_REP          | R/W  | Oh    | Overtemperature Warning Reporting Bit<br>0h = Over temperature reporting on nFAULT is disabled<br>1h = Over temperature reporting on nFAULT is enabled |

#### 表 8-20. Control Register 3 Register Field Descriptions

# 8.6.2.4 Control\_Register\_4 Register (Offset = 6h) [Reset = 10h]

Control\_Register\_4 is shown in Control\_Register\_4 Register and described in Control\_Register\_4 Register Field Descriptions.

#### Return to the CONTROL Registers.

| 図 8-53. Control | _Register_4 Register |
|-----------------|----------------------|
|-----------------|----------------------|

| 7       | 6       | 5       | 4 | 3         | 2       | 1        | 0    |
|---------|---------|---------|---|-----------|---------|----------|------|
| DRV_OFF | OCP_CBC | OCP_DEG |   | OCP_RETRY | OCP_LVL | OCP_MODE |      |
| R/W-0h  | R/W-0h  | R/W-1h  |   | R/W-0h    | R/W-0h  | R/W      | /-0h |

| Bit | Field     | Туре | Reset | Description                                                                                                                                                                                                                              |
|-----|-----------|------|-------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7   | DRV_OFF   | R/W  | Oh    | Driver OFF Bit<br>0h = No Action<br>1h = Enter Low Power Standby Mode                                                                                                                                                                    |
| 6   | OCP_CBC   | R/W  | Oh    | OCP PWM Cycle Operation Bit<br>0h = OCP clearing in PWM input cycle change is disabled<br>1h = OCP clearing in PWM input cycle change is enabled                                                                                         |
| 5-4 | OCP_DEG   | R/W  | 1h    | OCP Deglitch Time Settings<br>0h = OCP deglitch time is 0.2 µs<br>1h = OCP deglitch time is 0.6 µs<br>2h = OCP deglitch time is 1.25 µs<br>3h = OCP deglitch time is 1.6 µs                                                              |
| 3   | OCP_RETRY | R/W  | Oh    | OCP Retry Time Settings<br>0h = OCP retry time is 5 ms<br>1h = OCP retry time is 500 ms                                                                                                                                                  |
| 2   | OCP_LVL   | R/W  | Oh    | Overcurrent Level Setting<br>0h = OCP level is 16 A<br>1h = OCP level is 24 A                                                                                                                                                            |
| 1-0 | OCP_MODE  | R/W  | Oh    | OCP Fault Options<br>0h = Overcurrent causes a latched fault<br>1h = Overcurrent causes an automatic retrying fault<br>2h = Overcurrent is report only but no action is taken<br>3h = Overcurrent is not reported and no action is taken |

## 表 8-21. Control\_Register\_4 Register Field Descriptions



## 8.6.2.5 Control\_Register\_5 Register (Offset = 7h) [Reset = 00h]

Control\_Register\_5 is shown in Control\_Register\_5 Register and described in Control\_Register\_5 Register Field Descriptions.

#### Return to the CONTROL Registers.

| 図 8-54. Control_Register_5 Register |            |          |          |        |        |          |   |  |  |
|-------------------------------------|------------|----------|----------|--------|--------|----------|---|--|--|
| 7                                   | 6          | 5        | 4        | 3      | 2      | 1        | 0 |  |  |
| RESERVED                            | ILIM_RECIR | RESERVED | RESERVED | EN_AAR | EN_ASR | CSA_GAIN |   |  |  |
| R/W-0h                              | R/W-0h     | R/W-0h   | R/W-0h   | R/W-0h | R/W-0h | R/W-0h   |   |  |  |

| Bit | Field      | Туре | Reset | Description                                                                                                                                              |
|-----|------------|------|-------|----------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7   | RESERVED   | R/W  | 0h    | Reserved                                                                                                                                                 |
| 6   | ILIM_RECIR | R/W  | Oh    | Current Limit Recirculation Settings<br>0h = Current recirculation through FETs (Brake Mode)<br>1h = Current recirculation through diodes (Coast Mode)   |
| 5   | RESERVED   | R/W  | 0h    | Reserved                                                                                                                                                 |
| 4   | RESERVED   | R/W  | 0h    | Reserved                                                                                                                                                 |
| 3   | EN_AAR     | R/W  | Oh    | Active Asynshronous Rectification Enable Bit<br>0h = AAR mode is disabled<br>1h = AAR mode is enabled                                                    |
| 2   | EN_ASR     | R/W  | Oh    | Active Synchronous Rectification Enable Bit<br>0h = ASR mode is disabled<br>1h = ASR mode is enabled                                                     |
| 1-0 | CSA_GAIN   | R/W  | Oh    | Current Sense Amplifier's Gain Settings<br>0h = CSA gain is 0.15 V/A<br>1h = CSA gain is 0.3 V/A<br>2h = CSA gain is 0.6 V/A<br>3h = CSA gain is 1.2 V/A |

#### 表 8-22. Control\_Register\_5 Register Field Descriptions

# 8.6.2.6 Control\_Register\_6 Register (Offset = 8h) [Reset = 00h]

Control\_Register\_6 is shown in Control\_Register\_6 Register and described in Control\_Register\_6 Register Field Descriptions.

#### Return to the CONTROL Registers.

| 図 8-55. Control_Register_6 Register |      |          |             |         |       |     |          |  |  |
|-------------------------------------|------|----------|-------------|---------|-------|-----|----------|--|--|
| 7                                   | 6    | 5        | 4           | 3       | 2     | 1   | 0        |  |  |
| RESE                                | RVED | RESERVED | BUCK_PS_DIS | BUCK_CL | BUCK_ | SEL | BUCK_DIS |  |  |
| R-0                                 | )-0h | R/W-0h   | R/W-0h      | R/W-0h  | R/W-  | 0h  | R/W-0h   |  |  |

| Bit | Field       | Туре | Reset | Description                                                                                                                                    |
|-----|-------------|------|-------|------------------------------------------------------------------------------------------------------------------------------------------------|
|     |             |      |       |                                                                                                                                                |
| 7-6 | RESERVED    | R-0  | 0h    | Reserved                                                                                                                                       |
| 5   | RESERVED    | R/W  | 0h    | Reserved                                                                                                                                       |
| 4   | BUCK_PS_DIS | R/W  | 0h    | Buck Power Sequencing Disable Bit<br>0h = Buck power sequencing is enabled                                                                     |
|     |             |      |       | 1h = Buck power sequencing is disabled                                                                                                         |
| 3   | BUCK_CL     | R/W  | 0h    | Buck Current Limit Setting<br>0h = Buck regulator current limit is set to 600 mA<br>1h = Buck regulator current limit is set to 150 mA         |
| 2-1 | BUCK_SEL    | R/W  | 0h    | Buck Voltage Selection<br>0h = Buck voltage is 3.3 V<br>1h = Buck voltage is 5.0 V<br>2h = Buck voltage is 4.0 V<br>3h = Buck voltage is 5.7 V |
| 0   | BUCK_DIS    | R/W  | 0h    | Buck Disable Bit<br>0h = Buck regulator is enabled<br>1h = Buck regulator is disabled                                                          |

#### 表 8-23. Control\_Register\_6 Register Field Descriptions



## 8.6.2.7 Control\_Register\_10 Register (Offset = Ch) [Reset = 00h]

Control\_Register\_10 is shown in Control\_Register\_10 Register and described in Control\_Register\_10 Register Field Descriptions.

#### Return to the CONTROL Registers.

| 図 8-56. Control_Register_10 Register |          |   |                      |   |     |      |   |  |  |
|--------------------------------------|----------|---|----------------------|---|-----|------|---|--|--|
| 7                                    | 6        | 5 | 4                    | 3 | 2   | 1    | 0 |  |  |
|                                      | RESERVED |   | DLYCMP_EN DLY_TARGET |   |     |      |   |  |  |
|                                      | R-0-0h   |   |                      |   | R/W | /-0h |   |  |  |

| Bit | Field      | Туре | Reset | Description                                                                                                                                                                                                                                                                        |
|-----|------------|------|-------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 7-5 | RESERVED   | R-0  | 0h    | Reserved                                                                                                                                                                                                                                                                           |
| 4   | DLYCMP_EN  | R/W  | Oh    | Driver Delay Compensation enable<br>0h = Disable<br>1h = Enable                                                                                                                                                                                                                    |
| 3-0 | DLY_TARGET | R/W  | Oh    | Delay Target for Driver Delay Compensation<br>0h = 0 us<br>1h = 0.4 us<br>2h = 0.6 us<br>3h = 0.8 us<br>4h = 1 us<br>5h = 1.2 us<br>6h = 1.4 us<br>7h = 1.6 us<br>8h = 1.8 us<br>9h = 2 us<br>Ah = 2.2 us<br>Bh = 2.4 us<br>Ch = 2.6 us<br>Dh = 2.8 us<br>Eh = 3 us<br>Fh = 3.2 us |

## 表 8-24. Control\_Register\_10 Register Field Descriptions



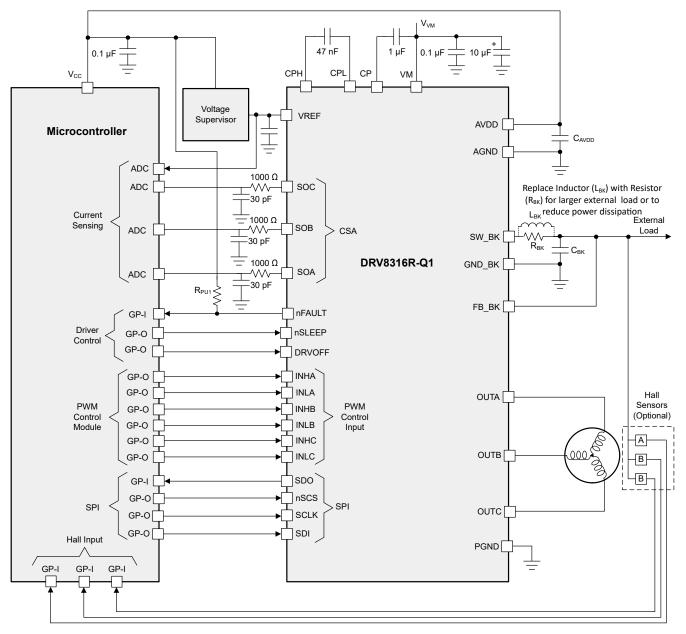
# **9** Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

## 9.1 Application Information

The DRV8316-Q1 can be used to drive Brushless-DC motors. The following design procedure can be used to configure the DRV8316-Q1.





# 9.2 Typical Applications

### 9.2.1 Three-Phase Brushless-DC Motor Control

In this application, the DRV8316-Q1 is used to drive a Brushless-DC motor.

#### 9.2.1.1 Detailed Design Procedure

 $\pm$  9-1 lists the example input parameters for the system design.

| DESIGN PARAMETERS             | REFERENCE         | EXAMPLE VALUE   |  |  |  |  |  |
|-------------------------------|-------------------|-----------------|--|--|--|--|--|
| Supply voltage                | V <sub>VM</sub>   | 24 V            |  |  |  |  |  |
| Motor RMS current             | I <sub>RMS</sub>  | 3 A             |  |  |  |  |  |
| Motor peak current            | I <sub>PEAK</sub> | 8 A             |  |  |  |  |  |
| PWM Frequency                 | f <sub>PWM</sub>  | 50 kHz          |  |  |  |  |  |
| Slew Rate Setting             | SR                | 200 V/µs        |  |  |  |  |  |
| Buck regulator output voltage | V <sub>BK</sub>   | 3.3 V           |  |  |  |  |  |
| ADC reference voltage         | V <sub>VREF</sub> | 3.0 V           |  |  |  |  |  |
| System ambient temperature    | T <sub>A</sub>    | –20°C to +105°C |  |  |  |  |  |
|                               |                   |                 |  |  |  |  |  |

表 9-1. Design Parameters

#### 9.2.1.1.1 Motor Voltage

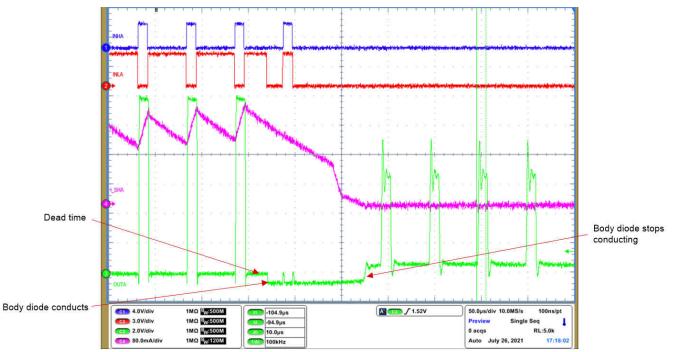
Brushless-DC motors are typically rated for a certain voltage (for example 12 V). Operating a motor at a higher voltage corresponds to a lower drive current to obtain the same motor power. Operating at lower voltages generally allows for more accurate control of phase currents. The DRV8316-Q1 functions down to a supply of 4.5V. A higher operating voltage also corresponds to a higher obtainable rpm. The DRV8316-Q1 allows for a range of possible operating voltages because of a maximum VM rating of 40 V.

#### 9.2.1.1.2 Using Active Demagnetization

Active demagnetization reduces power losses in the device by turning on the MOSFETs automatically when the body diode starts conducting to reduce diode conduction losses. It is used in trapezoidal commutation when switching commutation states (turning a high-side MOSFET off and another high-side MOSFET on while keeping a low-side MOSFET on). Active demagnetization is enabled when EN\_ASR and EN\_AAR bits are set in the SPI variant or OCP/SR pin is set to Mode 3 or Mode 4 in the H/W variant.

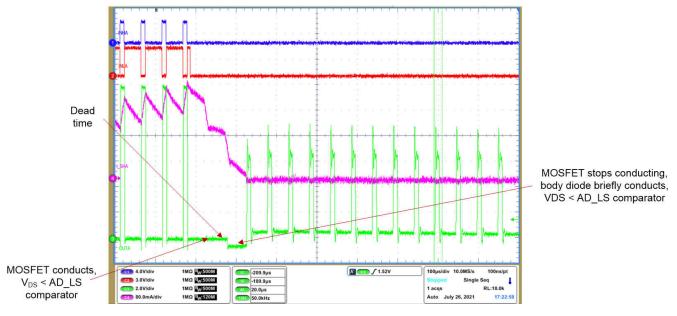
When switching commutation states with active demagnetization disabled, dead time is inserted and the low-side MOSFET's body diode conducts while turning another high-side MOSFET on to continue sourcing current through the motor. This conduction period causes higher power losses due to the forward-bias voltage of the diode and slower dissipation of current.  $\boxtimes$  9-2 shows the body diode conducting when switching commutation states.







When active demagnetization is enabled, the AD\_HS and AD\_LS comparators detect when the sense FET voltage is higher or lower than the programmed threshold. After the dead time period, if the threshold is exceeded for a fixed amount of time, the body diode is conducting and the logic core turns the low-side FET on to provide a conduction path with smaller power losses. Once the  $V_{DS}$  voltage is below the comparator threshold, the MOSFET turns off and current briefly conducts through the body diode until the current completely decays to zero. This is shown in  $\boxtimes$  9-3.





#### 9.2.1.1.3 Driver Propagation Delay and Dead Time

Driver propagation delay ( $t_{PD}$ ) and dead time ( $t_{dead}$ ) is specified with a typical and maximum value, but not with a minimum value. This is due to the direction of current at the OUTx pin when synchronous inputs are switching.



Driver propagation delay and dead time can be shorter than typical values due to slower internal turn-ons of the high-side or low-side internal MOSFETs to avoid internal dV/dt coupling.

For more information and examples of how propagation delay and dead time differs for input PWM and output configurations, please visit the Delay and Dead Time in Integrated MOSFET Drivers application note.

The dead time from the microcontroller's PWM outputs can be used as an extra precaution in addition to the DRV8316-Q1 internal shoot-through protection. This creates a condition where internal logic prioritizes the MCU dead time or driver dead time based on their durations.

If the MCU dead time is less than the driver dead time, the driver will compensate and make the true output dead time the value specified by the DRV8316-Q1. If the MCU inserted dead time is larger than the driver dead time, then the DRV8316-Q1 will adjust accordingly to the MCU dead time as shown in the table below.

A summary of the device delay times with respect to synchronous inputs INHx and INLx, OUTx current direction, and inserted MCU dead time are shown in  $\pm$  9-2.

| difection    |         |                          |                      |                                |                                                  |                                              |  |  |  |
|--------------|---------|--------------------------|----------------------|--------------------------------|--------------------------------------------------|----------------------------------------------|--|--|--|
| OUTx current | INHx    | INLx                     | Propagation          | Dead Time (t <sub>dead</sub> ) | Inserted MCU dead time (t <sub>dead(MCU)</sub> ) |                                              |  |  |  |
| direction    | Dela    | Delay (t <sub>PD</sub> ) |                      | $t_{dead(MCU)} < t_{dead}$     | t <sub>dead(MCU)</sub> > t <sub>dead</sub>       |                                              |  |  |  |
| Out of OUTx  | Rising  | Falling                  | Typical              | Typical                        | Output dead time<br>= t <sub>dead</sub>          | Output dead time<br>= t <sub>dead(MCU)</sub> |  |  |  |
|              | Falling | Rising                   | Smaller than typical | Smaller than typical           | Output dead time<br>< t <sub>dead</sub>          | Output dead time<br>< t <sub>dead(MCU)</sub> |  |  |  |
| Into OUTx    | Rising  | Falling                  | Smaller than typical | Smaller than typical           | Output dead time<br>< t <sub>dead</sub>          | Output dead time<br>< t <sub>dead(MCU)</sub> |  |  |  |
|              | Falling | Rising                   | Typical              | Typical                        | Output dead time<br>= t <sub>dead</sub>          | Output dead time<br>= t <sub>dead(MCU)</sub> |  |  |  |

# 表 9-2. Summary of delay times in integrated FET devices depending on inputs and output current direction

## 9.2.1.1.4 Using Delay Compensation

Differences in delays of dead time and propagation delay can cause mismatch in the output timings of PWMs, which can lead to duty cycle distortion. In order to accommodate differences in propagation delay between various input conditions, the DRV8316R-Q1 integrates a Delay Compensation feature.

Delay Compensation is used to match delay times for currents going into and out of phase by adding a variable delay time ( $t_{var}$ ) to match a preset target delay time. This delay time is configurable in SPI devices, and it is recommended in the datasheets to choose a target delay time that is equal to the propagation delay time plus the driver dead time ( $t_{pd} + t_{dead}$ ).

For an example of Delay Compensation implementation, please visit the Delay and Dead Time in Integrated MOSFET Drivers application note.

#### 9.2.1.1.5 Using the Buck Regulator

In the DRV8316-Q1, the buck regulator components must be populated whether the buck is used or unused.

If unused, Resistor Mode should be configured by placing a small value resistor of 22-ohm for  $R_{BK}$  and a 6.3-V rated, 22-uF capacitor for  $C_{BK}$  to minimize board space and reduce component cost. To disable the buck regulator, set the BUCK\_DIS in the SPI variant. The buck cannot be disabled in the Hardware variant.

If the buck regulator is used, either the Inductor or Resistor Mode can be selected. Inductor Mode allows a 22uH or 47-uH inductor be used for  $L_{BK}$ .  $C_{BK}$  is recommended to be 22-uF. Ensure an appropriate inductor is chosen to allow for maximum peak saturation current at a 20% inductance drop since the buck can supply up to 600-mA external current.

Resistor Mode allows for power to be dissipated in an external resistor if the load requirement is less than 40-mA. Ensure the resistor is rated for the power dissipation required at worst case VM voltage dropout. See  $\neq$  18,

式 19, and 式 20 to calculate the resistor power rating required for a 24-V rated system, 3.3V buck output voltage, and 20-mA load current.

| $P_{R_{BK}} > (V_M - V_{BK}) \times I_{BK}$ | (18) |
|---------------------------------------------|------|
| $P_{R_{BK}} > (24V - 3.3V) \times 20mA$     | (19) |
| $P_{R\_BK} > 0.434W$                        | (20) |

#### 9.2.1.1.6 Current Sensing and Output Filtering

The SOx pins are typically sampled by an analog-to-digital converter in the MCU to calculate the phase current. Phase current calculations are used for closed-loop feedback such as Field-oriented control.

An example calculation for phase current is shown in  $\pm$  21,  $\pm$  22, and  $\pm$  23 for a system using VREF = 3.0V, GAIN = 0.15 V/A, and a SOx voltage of 1.2V.

$$SOx = \left(\frac{VREF}{2}\right) \pm GAIN \times I_{OUTx}$$
(21)

$$1.2V = \left(\frac{3.0V}{2}\right) \pm 0.15 \, V/A \times I_{OUTx} \tag{22}$$

$$I_{OUTx} = -2.0 A$$
 (23)

Sometimes high frequency noise can appear at the SOx signals based on voltage ripple at VREF, added inductance at the SOx traces, or routing of SOx traces near high frequency components. It is recommended to add a low-pass RC filter close to the MCU with cutoff frequency at least 10 times the PWM switching frequency for trapezoidal commutation and 100 times the PWM switching frequency for sinusoidal commutation to filter high frequency noise. A recommended RC filter is 1000-ohms, 30-pF to add minimal parallel capacitance to the ADC and current mirroring circuitry. The cutoff frequency for the low-pass RC filter is in  $\pm 24$ .

$$f_c = \frac{1}{2\pi RC} \tag{24}$$

Note

There is a small dynamic offset and gain error that appears at the SOB output when sinking larger currents into OUTB in applications such as 3-shunt Field-oriented control. Check Current Sense Amplifier Offset Correction for equations to manually implement in software to compensate for dynamic gain and offset errors at larger currents.

#### 9.2.1.1.7 Power Dissipation and Junction Temperature Losses

To calculate the junction temperature of the DRV8316-Q1 from power losses, use  $\neq 25$ . Note that the thermal resistance  $\theta_{JA}$  depends on PCB configurations such as the ambient temperature, numbers of PCB layers, copper thickness on top and bottom layers, and the PCB area.

$$T_{f}[^{\circ}C] = P_{loss}[W] \times \theta_{JA}\left[\frac{^{\circ}C}{W}\right] + T_{A}\left[^{\circ}C\right]$$
(25)



#### 9.2.1.2 Application Curves

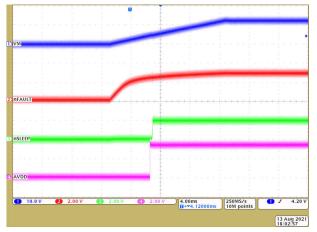


図 9-4. Device powerup with VM



**2** 9-6. Driver PWM operation with feedback

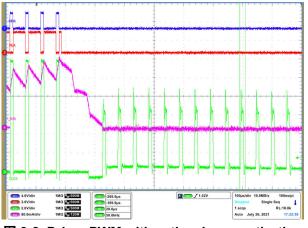


図 9-8. Driver PWM with active demagnetization (ASR and AAR)

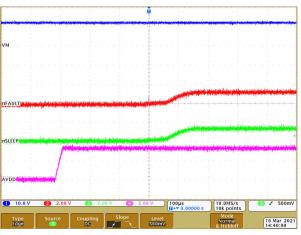
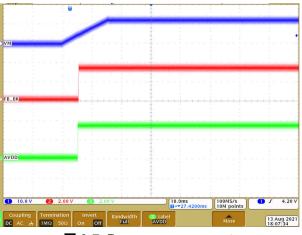


図 9-5. Device powerup with nSLEEP



2 9-7. Power management



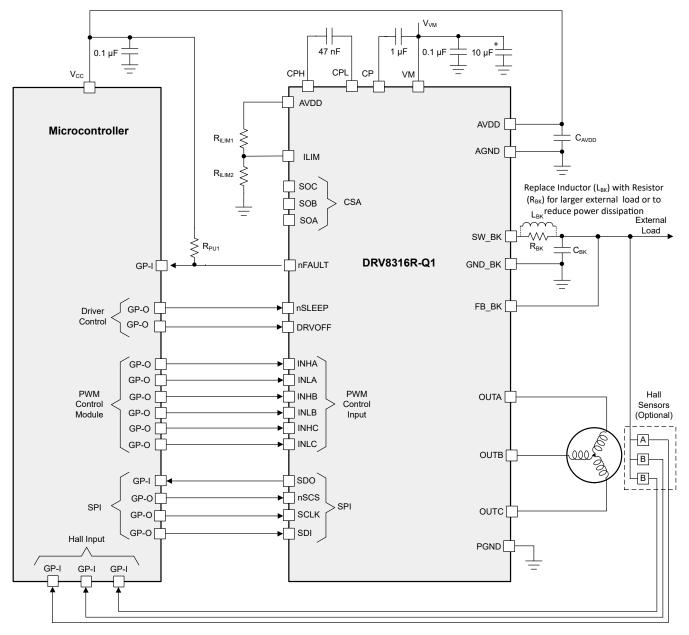
図 9-9. Driver delay compensation (1.8 µs)



#### 9.2.2 Three-Phase Brushless-DC Motor Control With Current Limit

In this application, the DRV8316-Q1 is used to drive a brushless-DC motor with current limit up to 100% duty cycle. The following design procedure can be used to configure the DRV8316-Q1in current limit mode.

#### 9.2.2.1 Block Diagram





#### 9.2.2.2 Detailed Design Procedure

 $\pm$  9-3 lists the example input parameters for the system design.

| 表 9-3. Des | ign Param | eters |
|------------|-----------|-------|
|------------|-----------|-------|

| DESIGN PARAMETERS  | REFERENCE         | EXAMPLE VALUE |
|--------------------|-------------------|---------------|
| Supply voltage     | V <sub>VM</sub>   | 24 V          |
| Motor peak current | I <sub>PEAK</sub> | 2 A           |



| 表 9-3. Design Parameters (continued) |                  |               |  |  |  |  |
|--------------------------------------|------------------|---------------|--|--|--|--|
| DESIGN PARAMETERS                    | REFERENCE        | EXAMPLE VALUE |  |  |  |  |
| PWM Frequency                        | f <sub>PWM</sub> | 50 kHz        |  |  |  |  |
| Slew Rate Setting                    | SR               | 200 V/µs      |  |  |  |  |
| Buck regulator output voltage        | V <sub>BK</sub>  | 3.3 V         |  |  |  |  |

#### 9.2.2.2.1 Motor Voltage

Brushless-DC motors are typically rated for a certain voltage (for example 12 V and 24 V). Operating a motor at a higher voltage corresponds to a lower drive current to obtain the same motor power. A higher operating voltage also corresponds to a higher obtainable rpm. DRV8316-Q1 device allows for the use of higher operating voltage because of a maximum VM rating of 40 V.

Operating at lower voltages generally allows for more accurate control of phase currents. The DRV8316-Q1 functions down to a supply of 4.5V.

#### 9.2.2.2.2 ILIM Implementation

The ILIM pin on the DRV8316-Q1 device is used to set a cycle-by-cycle current limit proportional to the voltage on the ILIM pin. The analog voltage ILIM can be set using a digital-to-analog converter from an external microcontroller or a resistor divider. Applying AVDD/2 on the ILIM pin disables the cycle-by-cycle current limit, and applying (AVDD/2 - 0.4) V on ILIM pin sets the current limit at the maximum threshold of 8-A.

式 26, 式 27, and 式 28 shows how to set the ILIM voltage with respect to AVDD = 3.3V to set cycle-by-cycle current limit to 2-A.

$$1.55V = 3.3 \left(\frac{10 \,\mathrm{k\Omega}}{R_{ILIM1} + 10 \,\mathrm{k\Omega}}\right) \tag{26}$$

$$ILIM[V] = \frac{\left(1.25 - \frac{3.3}{2}\right)[V]}{8A} \times 2A + 1.65V$$
(27)

$$ILIM[V] = 1.55V$$
 (28)

Use  $\neq$  29 to calculate values for an AVDD-sourced resistor divider with resistors RILIM1 and RILIM2 to set ILIM equal to the 2-A calculated current limit.

$$ILIM[V] = AVDD\left(\frac{R_{ILIM2}}{R_{ILIM1} + R_{ILIM2}}\right)$$
(29)

To reduce current load on AVDD,  $R_{ILIM2}$  is configured to be 10 k $\Omega$  as shown in  $\pm$  30 and  $\pm$  31.

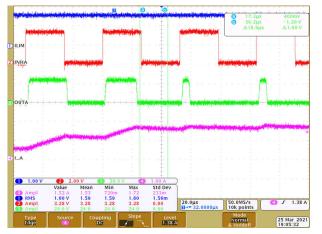
$$1.55V = 3.3 \left(\frac{10 \,\mathrm{k\Omega}}{R_{ILIM1} + 10 \,\mathrm{k\Omega}}\right) \tag{30}$$

$$R_{ILIM1} = 11.29 \text{ k}\Omega \tag{31}$$

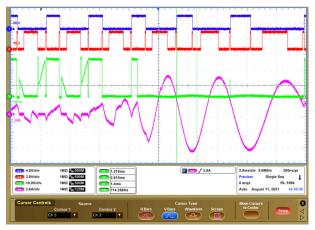
Cycle-by-cycle limit can also occur with 100% PWM duty cycle inputs using an internal PWM pulse to monitor the current with ILIM. Setting the PWM\_100\_DUTY\_SEL configures the frequency of the internal PWM pulse to 20kHz or 40kHz.



#### 9.2.2.3 Application Curves



**図** 9-11. Driver PWM with Current Limit



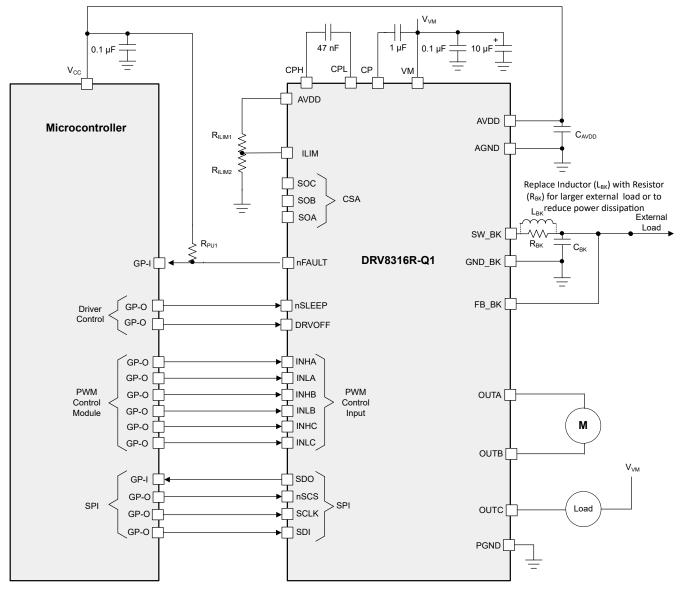
☑ 9-12. Device 100% Operation with Current Chopping (Latched shutdown mode)



#### 9.2.3 Brushed-DC and Solenoid Load

In this application, the DRV8316-Q1 can be configured to drive a Brushed-DC motor and a solenoid load.

#### 9.2.3.1 Block Diagram





#### 9.2.3.2 Design Requirements

表 9-4 gives design input parameters for system design.

| 表 9-4. Design Parameters   |                        |               |  |  |  |  |
|----------------------------|------------------------|---------------|--|--|--|--|
| DESIGN PARAMETER           | REFERENCE              | EXAMPLE VALUE |  |  |  |  |
| Brushed motor rms current  | I <sub>RMS, BDC</sub>  | 1.0 A         |  |  |  |  |
| Brushed motor peak current | I <sub>PEAK, BDC</sub> | 2.0 A         |  |  |  |  |
| Solenoid rms current       | I <sub>RMS, SOL</sub>  | 0.5 A         |  |  |  |  |
| Solenoid peak current      | I <sub>PEAK, SOL</sub> | 1.0 A         |  |  |  |  |

| 表 9-4. Design Parameter | Parameters | esign | 9-4. | 表 |
|-------------------------|------------|-------|------|---|
|-------------------------|------------|-------|------|---|



#### 9.2.3.2.1 Detailed Design Procedure

| Function                    | IN1 | EN1 | IN2 | EN2 | OUT1 | OUT2 |  |  |
|-----------------------------|-----|-----|-----|-----|------|------|--|--|
| Forward                     | 1   | 1   | 0   | 1   | Н    | L    |  |  |
| Reverse                     | 0   | 1   | 1   | 1   | L    | Н    |  |  |
| Brake (low-side slow decay) | 0   | 1   | 0   | 1   | L    | L    |  |  |
| High-side slow decay        | 1   | 1   | 1   | 1   | Н    | Н    |  |  |
| Coast                       | Х   | 0   | Х   | 0   | Z    | Z    |  |  |

#### 表 9-5. Brushed-DC Control

#### 表 9-6. Solenoid Control (High-Side Load)

| Function    | IN3 | EN3 | OUT3 |  |
|-------------|-----|-----|------|--|
| Coast / Off | X   | 0   | Z    |  |
| On          | 0   | 1   | L    |  |
| Brake       | 1   | 1   | Н    |  |

6x PWM mode or 3x PWM mode (with or without current limit) can be used to drive three solenoid loads depending on the application.

A Brushed-DC motor can be connected to two OUTx phases to create an integrated full H-bridge configuration to drive the motor. In 6x PWM mode or 3x PWM mode, current feedback can be monitored through the SOx pins of the H-bridge when current is dissipated through that phase's low-side FET during motor control. In 6x PWM with Current Limit or 3x PWM with Current Limit mode, cycle-by-cycle current can be implemented by setting the ILIM analog voltage to the proportional threshold.

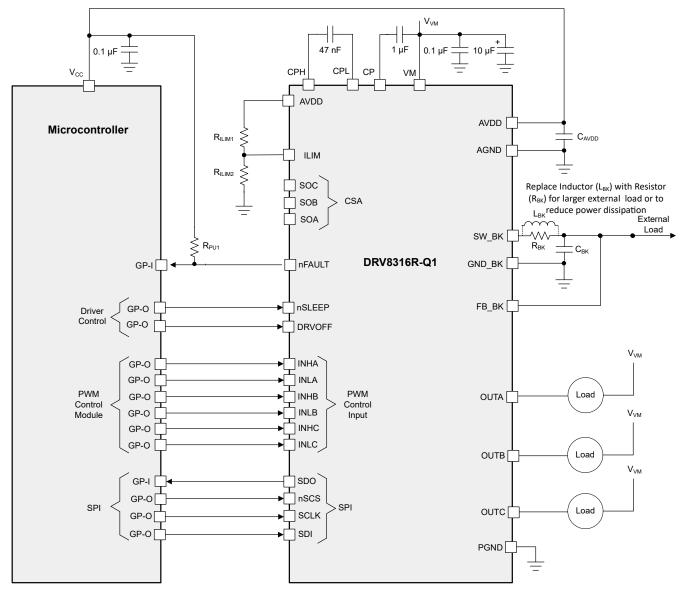
Solenoid loads can be connected from OUTx to VM or GND to use the DRV8316-Q1 as a push-pull driver in 6x PWM or 3x PWM mode. When the load is connected from OUTx to GND, current is sourced from the high-side MOSFET and therefore current feedback or cycle-by-cycle current limit is not available. When the load is connected from OUTx to VM, current feedback or cycle-by-cycle current limit can be used depending on the mode configuration.

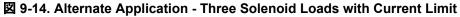


#### 9.2.4 Three Solenoid Loads

The DRV8316-Q1 can be used to drive three solenoid loads. The following design procedure can be used to configure the DRV8316-Q1 for three solenoid loads.

#### 9.2.4.1 Block Diagram





#### 9.2.4.2 Design Requirements

表 9-7 gives design input parameters for system design.

表 9-7. Design Parameters

| P4 - · · · · · · · · · · · · · · · |                        |               |  |  |  |  |  |
|------------------------------------|------------------------|---------------|--|--|--|--|--|
| DESIGN PARAMETER                   | REFERENCE              | EXAMPLE VALUE |  |  |  |  |  |
| Solenoid rms current               | I <sub>RMS, SOL</sub>  | 1.0 A         |  |  |  |  |  |
| Solenoid peak current              | I <sub>PEAK, SOL</sub> | 1.5 A         |  |  |  |  |  |



#### 9.2.4.2.1 Detailed Design Procedure

#### 表 9-8. Solenoid Control (high-side load)

| Function    | IN2 | EN2 | OUT2 |
|-------------|-----|-----|------|
| Coast / Off | Х   | 0   | Z    |
| On          | 0   | 1   | L    |
| Brake       | 1   | 1   | Н    |

#### 表 9-9. Solenoid Control (low-side load)

| Function    | Function IN1 EN1 |   | OUT1 |
|-------------|------------------|---|------|
| Coast / Off | Х                | 0 | Z    |
| On          | 1                | 1 | Н    |
| Brake       | 0                | 1 | L    |

6x PWM mode or 3x PWM mode (with or without current limit) can be used to drive three solenoid loads depending on the application.

Solenoid loads can be connected from OUTx to VM or GND to use the DRV8316-Q1 as a push-pull driver in 6x PWM or 3x PWM mode. When the load is connected from OUTx to GND, current is sourced from the high-side MOSFET and therefore current feedback or cycle-by-cycle current limit is not available. When the load is connected from OUTx to VM, current feedback or cycle-by-cycle current limit can be used depending on the mode configuration.



### 10 Power Supply Recommendations

#### **10.1 Bulk Capacitance**

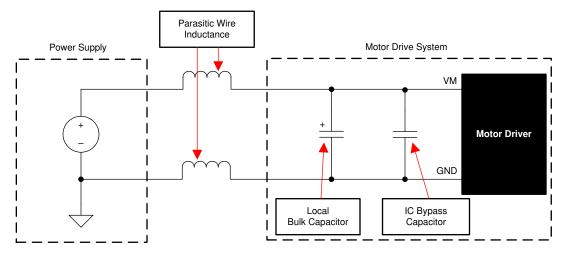
Having an appropriate local bulk capacitance is an important factor in motor drive system design. It is generally beneficial to have more bulk capacitance, while the disadvantages are increased cost and physical size.

The amount of local capacitance needed depends on a variety of factors, including:

- · The highest current required by the motor system
- The capacitance and current capability of the power supply
- · The amount of parasitic inductance between the power supply and motor system
- The acceptable voltage ripple
- The type of motor used (brushed dc, brushless DC, stepper)
- The motor braking method

The inductance between the power supply and the motor drive system limits the rate current can change from the power supply. If the local bulk capacitance is too small, the system responds to excessive current demands or dumps from the motor with a change in voltage. When adequate bulk capacitance is used, the motor voltage remains stable and high current can be quickly supplied.

The data sheet generally provides a recommended value, but system-level testing is required to determine the appropriate sized bulk capacitor.



**2** 10-1. Example Setup of Motor Drive System With External Power Supply

The voltage rating for bulk capacitors should be higher than the operating voltage, to provide margin for cases when the motor transfers energy to the supply.



### 11 Layout

#### **11.1 Layout Guidelines**

The bulk capacitor should be placed to minimize the distance of the high-current path through the motor driver device. The connecting metal trace widths should be as wide as possible, and numerous vias should be used when connecting PCB layers. These practices minimize inductance and allow the bulk capacitor to deliver high current.

Small-value capacitors such as the charge pump, AVDD, and VREF capacitors should be ceramic and placed closely to device pins.

The high-current device outputs should use wide metal traces.

To reduce noise coupling and EMI interference from large transient currents into small-current signal paths, grounding should be partitioned between PGND and AGND. TI recommends connecting all non-power stage circuitry (including the thermal pad) to AGND to reduce parasitic effects and improve power dissipation from the device. Optionally, GND\_BK can be split. Ensure grounds are connected through net-ties or wide resistors to reduce voltage offsets and maintain gate driver performance.

The device thermal pad should be soldered to the PCB top-layer ground plane. Multiple vias should be used to connect to a large bottom-layer ground plane. The use of large metal planes and multiple vias helps dissipate the  $l2 \times RDS(on)$  heat that is generated in the device.

To improve thermal performance, maximize the ground area that is connected to the thermal pad ground across all possible layers of the PCB. Using thick copper pours can lower the junction-to-air thermal resistance and improve thermal dissipation from the die surface.

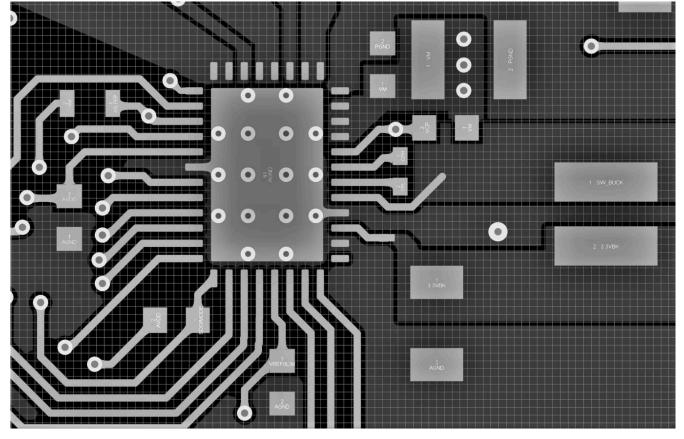
Separate the SW\_BUCK and FB\_BUCK traces with ground separation to reduce buck switching from coupling as noise into the buck outer feedback loop. Widen the FB\_BUCK trace as much as possible to allow for faster load switching.

Recommended Layout Example for VQFN Package shows a layout example for the DRV8316-Q1.



### 11.2 Layout Example

## Recommended Layout Example for VQFN Package





#### **11.3 Thermal Considerations**

The DRV8316-Q1 has thermal shutdown (TSD) as previously described. A die temperature in excess of 150°C (minimally) disables the device until the temperature drops to a safe level.

Any tendency of the device to enter thermal shutdown is an indication of excessive power dissipation, insufficient heatsinking, or too high an ambient temperature.

#### 11.3.1 Power Dissipation

The power dissipated in the output FET resistance, or R<sub>DS(on)</sub> dominates power dissipation in the DRV8316-Q1.

At start-up and fault conditions, this current is much higher than normal running current; remember to take these peak currents and their duration into consideration.

The total device dissipation is the power dissipated in each of the three half-H-bridges added together.

The maximum amount of power that the device can dissipate depends on ambient temperature and heatsinking.

Note that  $R_{DS(on)}$  increases with temperature, so as the device heats, the power dissipation increases. Take this into consideration when sizing the heatsink.

A summary of equations for calculating each loss is shown below for trapezoidal controland field-oriented control.

| A TI-T. DRV0310-QT FOWER LOSSES for Trapezoidal and Tield-Onented Control |                                                                                                                                                                                                                                                                                 |                                                                                                        |  |  |  |
|---------------------------------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------------------------|--|--|--|
| Loss type                                                                 | Trapezoidal Field-oriented control                                                                                                                                                                                                                                              |                                                                                                        |  |  |  |
| Standby power                                                             | P <sub>standby</sub> = V                                                                                                                                                                                                                                                        | /M x I <sub>VM_TA</sub>                                                                                |  |  |  |
| LDO (from VM)                                                             | $P_{LDO} = (VM-V_{AVDD}) \times I_{AVDD}$ , if BUCK_PS_DIS = 1b<br>$P_{LDO} = (V_{BK}-V_{AVDD}) \times I_{AVDD}$ , if BUCK_PS_DIS = 0b                                                                                                                                          |                                                                                                        |  |  |  |
| FET conduction                                                            | $P_{\text{CON}} = 2 \text{ x } (I_{\text{RMS}(\text{trap})})^2 \text{ x } R_{\text{ds,on}(\text{TA})} \qquad P_{\text{CON}} = 3 \text{ x } (I_{\text{RMS}(\text{FOC})})^2 \text{ x } R_{\text{ds}}$                                                                             |                                                                                                        |  |  |  |
| FET switching                                                             | $P_{SW} = I_{PK(trap)} \times V_{PK(trap)} \times t_{rise/fall} \times f_{PWM}$                                                                                                                                                                                                 | $P_{SW} = 3 \text{ x } I_{PK(FOC)} \text{ x } V_{PK(FOC)} \text{ x } t_{rise/fall} \text{ x } f_{PWM}$ |  |  |  |
| Diode                                                                     | P <sub>diode</sub> = I <sub>PK(trap)</sub> x V <sub>diode</sub> x t <sub>dead</sub> x f <sub>PWM</sub> P <sub>diode</sub> = 3 x I <sub>PK(FOC)</sub> x V <sub>diode</sub> x t <sub>dead</sub> x f                                                                               |                                                                                                        |  |  |  |
| Demagnetization                                                           | Without Active Demag: 3 x I <sub>PK(trap</sub> ) x V <sub>diode</sub> x<br>t <sub>commutation</sub> x f <sub>motor_elec</sub><br>With Active Demag: 3 x (I <sub>RMS(trap</sub> )) <sup>2</sup> x<br>R <sub>ds,on(TA)</sub> x t <sub>commutation</sub> x f <sub>motor_elec</sub> | Not Applicable                                                                                         |  |  |  |
| Buck                                                                      | P <sub>BK</sub> = 0.11 x V <sub>BK</sub> x I <sub>BK</sub> (η <sub>BK</sub> = 90%)                                                                                                                                                                                              |                                                                                                        |  |  |  |

#### 表 11-1. DRV8316-Q1 Power Losses for Trapezoidal and Field-oriented Control



### **12 Device and Documentation Support**

### 12.1 サポート・リソース

TI E2E<sup>™</sup> サポート・フォーラムは、エンジニアが検証済みの回答と設計に関するヒントをエキスパートから迅速かつ直接 得ることができる場所です。既存の回答を検索したり、独自の質問をしたりすることで、設計で必要な支援を迅速に得るこ とができます。

リンクされているコンテンツは、該当する貢献者により、現状のまま提供されるものです。これらは TI の仕様を構成するものではなく、必ずしも TI の見解を反映したものではありません。TI の使用条件を参照してください。

#### 12.2 Trademarks

#### TI E2E<sup>™</sup> is a trademark of Texas Instruments.

すべての商標は、それぞれの所有者に帰属します。

#### **12.3 Electrostatic Discharge Caution**



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

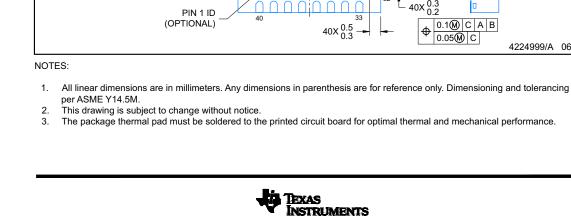
ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 12.4 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

#### 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the mostcurrent data available for the designated device. This data is subject to change without notice and without revision of this document. For browser-based versions of this data sheet, see the left-hand navigation pane.



RGF0040E

## PACKAGE OUTLINE

### VQFN - 1 mm max height

PLASTIC QUAD FLAT PACK- NO LEAD

Α 5.1 4.9 B PIN 1 INDEX AREA 7.1 6.9 1 MAX С - SEATING PLANE ○ 0.08 C 3.7±0.1 0.05 0.00 3.5 SYMM (0.1) TYP 36X 0.5 12 C C C  $\subset$ SYMM ℄\_ C 41 5.5 5.7±0.1  $\subset$  $\subset$ C C 32 40X 0.3  $\cap \cap \cap$ 0.1 (M) C A B 0.05M C 4224999/A 06/2019

DRV8316-Q1 JAJSN64 – JANUARY 2022

www.ti.com

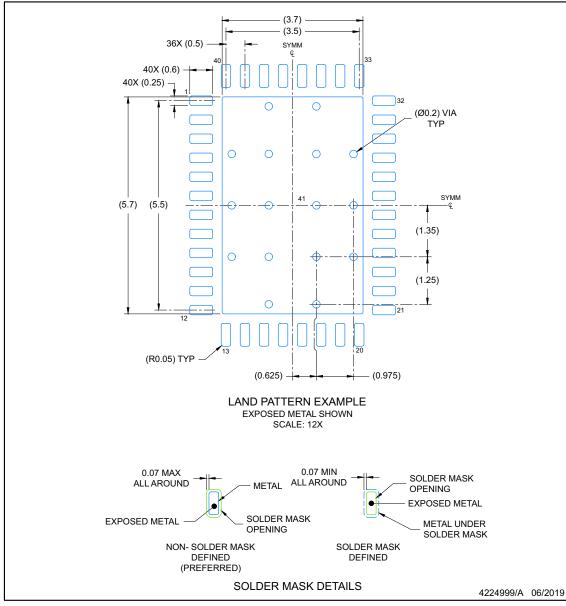


**RGF0040E** 

## EXAMPLE BOARD LAYOUT

#### VQFN - 1 mm max height

PLASTIC QUAD FLAT PACK- NO LEAD



NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

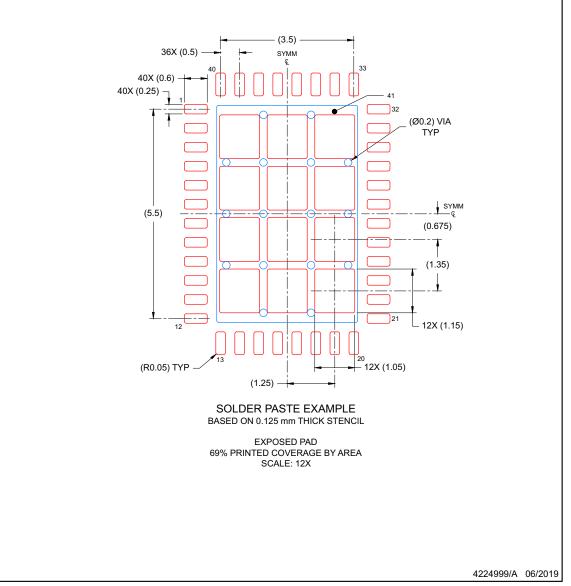
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



## **EXAMPLE STENCIL DESIGN**

### VQFN - 1 mm max height

PLASTIC QUAD FLAT PACK- NO LEAD



NOTES: (continued)

Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate 6. design recommendations.





## **RGF0040E**



#### PACKAGING INFORMATION

| Orderable part number | Status<br>(1) | Material type (2) | Package   Pins  | Package qty   Carrier | <b>RoHS</b><br>(3) | Lead finish/<br>Ball material | MSL rating/<br>Peak reflow | Op temp (°C) | Part marking (6) |
|-----------------------|---------------|-------------------|-----------------|-----------------------|--------------------|-------------------------------|----------------------------|--------------|------------------|
|                       |               |                   |                 |                       |                    | (4)                           | (5)                        |              |                  |
| DRV8316RQRGFRQ1       | Active        | Production        | VQFN (RGF)   40 | 3000   LARGE T&R      | Yes                | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | 8316RQ           |
| DRV8316RQRGFRQ1.A     | Active        | Production        | VQFN (RGF)   40 | 3000   LARGE T&R      | Yes                | NIPDAU                        | Level-2-260C-1 YEAR        | -40 to 125   | 8316RQ           |

<sup>(1)</sup> **Status:** For more details on status, see our product life cycle.

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF DRV8316-Q1 :

Catalog : DRV8316



NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product

## **RGF 40**

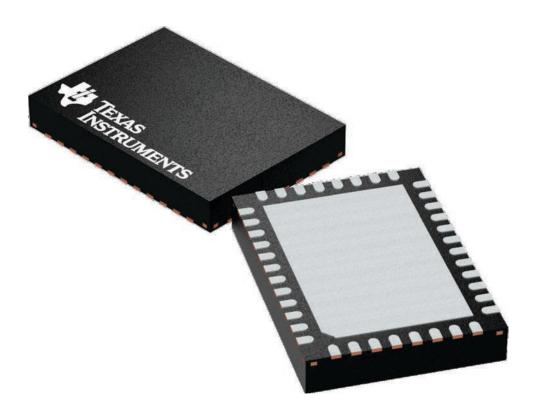
## 5 x 7, 0.5 mm pitch

## **GENERIC PACKAGE VIEW**

### VQFN - 1 mm max height

PLASTIC QUAD FLAT PACK- NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



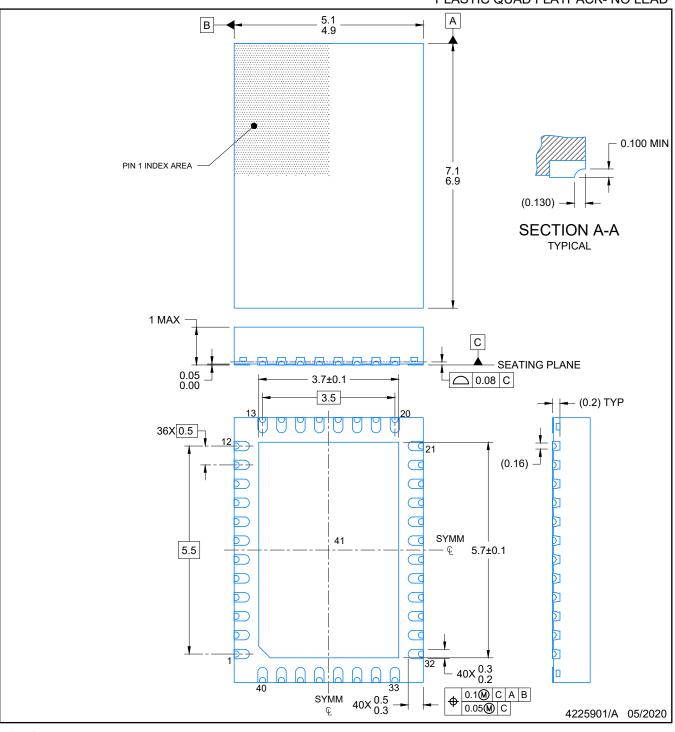


## **RGF0040F**

# PACKAGE OUTLINE

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK- NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.

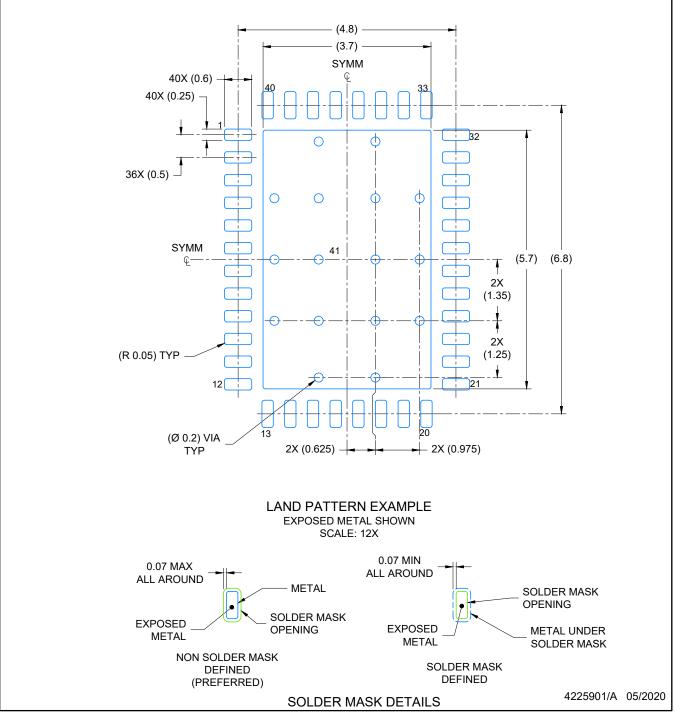


## **RGF0040F**

## **EXAMPLE BOARD LAYOUT**

### VQFN - 1 mm max height

PLASTIC QUAD FLATPACK- NO LEAD



NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

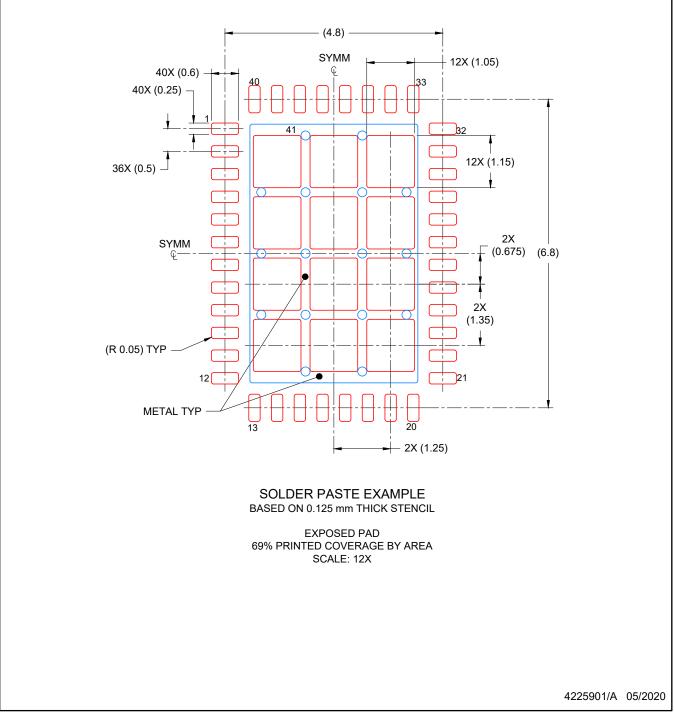


## **RGF0040F**

## **EXAMPLE STENCIL DESIGN**

## VQFN - 1 mm max height

PLASTIC QUAD FLATPACK- NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



#### 重要なお知らせと免責事項

テキサス・インスツルメンツは、技術データと信頼性データ (データシートを含みます)、設計リソース (リファレンス デザインを含みま す)、アプリケーションや設計に関する各種アドバイス、Web ツール、安全性情報、その他のリソースを、欠陥が存在する可能性のある 「現状のまま」提供しており、商品性および特定目的に対する適合性の黙示保証、第三者の知的財産権の非侵害保証を含むいかなる保証 も、明示的または黙示的にかかわらず拒否します。

これらのリソースは、 テキサス・インスツルメンツ製品を使用する設計の経験を積んだ開発者への提供を意図したものです。(1) お客様 のアプリケーションに適した テキサス・インスツルメンツ製品の選定、(2) お客様のアプリケーションの設計、検証、試験、(3) お客様の アプリケーションに該当する各種規格や、その他のあらゆる安全性、セキュリティ、規制、または他の要件への確実な適合に関する責任 を、お客様のみが単独で負うものとします。

上記の各種リソースは、予告なく変更される可能性があります。これらのリソースは、リソースで説明されている テキサス・インスツル メンツ製品を使用するアプリケーションの開発の目的でのみ、 テキサス・インスツルメンツはその使用をお客様に許諾します。これらの リソースに関して、他の目的で複製することや掲載することは禁止されています。 テキサス・インスツルメンツや第三者の知的財産権の ライセンスが付与されている訳ではありません。お客様は、これらのリソースを自身で使用した結果発生するあらゆる申し立て、損害、 費用、損失、責任について、 テキサス・インスツルメンツおよびその代理人を完全に補償するものとし、 テキサス・インスツルメンツは 一切の責任を拒否します。

テキサス・インスツルメンツの製品は、 <del>テキサス・インスツルメンツの販売条件</del>、または ti.com やかかる テキサス・インスツルメンツ 製品の関連資料などのいずれかを通じて提供する適用可能な条項の下で提供されています。 テキサス・インスツルメンツがこれらのリソ ースを提供することは、適用される テキサス・インスツルメンツの保証または他の保証の放棄の拡大や変更を意味するものではありませ ん。

お客様がいかなる追加条項または代替条項を提案した場合でも、 テキサス・インスツルメンツはそれらに異議を唱え、拒否します。

郵送先住所:Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2025, Texas Instruments Incorporated